INCH-POUND MIL-M-38510/315D <u>27 October 2003</u> SUPERSEDING MIL-M-38510/315C 17 JANUARY 1984

#### MILITARY SPECIFICATION

#### MICROCIRCUITS, DIGITAL, LOW-POWER SCHOTTKY TTL, COUNTERS, MONOLITHIC SILICON

Inactive for new design after 18 April 1997.

This specification is approved for use by all Departments and Agencies of the Department of Defense.

The requirements for acquiring the product herein shall consist of this specification sheet and MIL-PRF 38535

1. SCOPE

1.1 <u>Scope.</u> This specification covers the detail requirements for monolithic silicon, low power Schottky TTL, binary and decade counters. Two product assurance classes and a choice of case outlines/lead finish are provided for each type and are reflected in the complete part number. For this product, the requirements of MIL-M-38510 have been superseded by MIL-PRF-38535, (see 6.3).

1.2 Part or Identifying Number (PIN). The PIN should be in accordance with MIL-PRF-38535, and as specified herein.

1.2.1 <u>Device types.</u> The device types should be as follows:

Device type	Circuit
01	Decade counter
02	4-bit binary counter
03	Synchronous 4-bit decade counter (asynchronous clear)
04	Synchronous 4-bit binary counter (asynchronous clear)
05	Synchronous 4-bit up/down decade counter
06	Synchronous 4-bit up/down binary counter
07	Synchronous 4-bit up/down decade counter (with clear)
08	Synchronous 4-bit up/down binary counter (with clear)
09	Synchronous 4-bit up/down binary counter (with mode control)
10	Divide-by-twelve counter
11	Synchronous 4-bit decade counter (with synchronous clear)
12	Synchronous 4-bit binary counter (with synchronous clear)
13	Synchronous 4-bit decade counter (with mode control)

1.2.2 Device class. The device class should be the product assurance level as defined in MIL-PRF-38535.

Comments, suggestions, or questions on this document should be addressed to: Commander, Defense Supply Center Columbus, ATTN: DSCC-VAS, 3990 East Broad St., Columbus, OH 43216-5000, or emailed to bipolar@dscc.dla.mil. Since contact information can change, you may want to verify the currency of this address information using the ASSIST Online database at www.dodssp.daps.mil.

Outline letter	Descriptive designator	<u>Terminals</u>	Package style
А	GDFP5-F14 or CDFP6-F14	14	Flat pack
B	GDFP4-F14	14	•
С	<u>GDIP1-T14 or CDIP2-T14</u>	14	Flat pack Dual-in-line
D	GDFP1-F14 or CDFP2-F14	14	
E	GDIP1-T16 or CDIP2-T16	14	Flat pack Dual-in-line
F	<u>GDFP2-F16 or CDFP3-F16</u>	16	
-	<u>CQCC1-N20</u>	-	Flat pack
2	<u>CQCC1-N20</u>	20	Square leadless chip carrier
1.3 Absolute maximu	<u>ım ratings.</u>		
	nge		
Input voltage rang	je	•	1.2 V dc at -18 mA to 5.5 V dc
Storage temperat	ure range	·	·65° to +150°C
Maximum power	dissipation, $(P_D) \ \underline{1}/$ :		
Device type 0	5, 06, 07, 08	····· · · · · · · · · · · · · · · · ·	187 mW
Device type 0	1, 02, 10		83 mW
Device type 0	3, 04, 11, 12	····· · · · · · · · · · · · · · · · ·	176 mW
Device type 0	9, 13	····· · · · · · · · · · · · · · · · ·	193 mW
Lead temperature	e (soldering, 10 seconds)		300°C
	in the case $(\theta_{JC})$ :		
Cases A, B, C, I		(3	See MIL-STD-1835)
	ture (T <sub>J</sub> ) <u>3</u> /		
1.4 Recommended c	perating conditions. 2/		
Maximum low leve	el output current (I <sub>oL</sub> )	2	4 0 mA
Supply voltage (V			4.5 V dc minimum to 5.5 V dc maximum
	el input voltage (V <sub>IH</sub> )		
	el input voltage ( $V_{IL}$ )		
Normalized fanou			
Types 01 02	05, 06, 07, 08, 10		10 maximum
Types 03 04	09, 11, 12, 13		
			10 maximum
Width of input cou			
Types 01, 02,			
	set		15 ns minimum
-			
Width of reset pul			
Types 01 02	10		25 ns minimum
Count enable time			
	_ ble		40 ns minimum

1.2.3 <u>Case outlines.</u> The case outlines should be as designated in MIL-STD-1835 and as follows:

 $<sup>\</sup>underline{1}$  Must withstand the added P<sub>D</sub> due to short-circuit test (e.g., I<sub>OS</sub>).

<sup>&</sup>lt;u>2</u>/ A change of states on the  $U/\overline{D}$  input for device types 09 and 13 is not recommended when the clock input is low. This may result in an erroneous count.

<sup>3/</sup> Maximum junction temperature shall not be exceeded except for allowable short duration burn-in screening conditions in accordance with MIL-PRF-38535.

Input clock frequency, f <sub>clock</sub> Types 01, 02, 10	
Input A	0 to 29 MHz
Types 03, 04, 11, 12	0 to 22 MHz
Types 09, 13	0 to 18 MHz
Types 07, 08	0 to 20 MHz
Types 05, 06	0 to 25 MHz
Width of clock pulse, t <sub>w</sub> (clock)	
Types 03, 06, 09, 11, 12, 13	25 ns minimum
Types 04	30 ns minimum
Types 05	20 ns minimum
Width of clear pulse, tw (clear)	
Types 03, 04, 05, 06, 07, 08, 11, 12	20 ns minimum
Setup time, t <sub>(setup)</sub>	
Types 03, 11, 12	
Enable P	
Load	
Clear (types 11 and 12 only)	20 ns minimum
Туре 04	
Enable P	
Load	35 ns minimum
Data inputs	
Types 03, 09, 11, 12, 13	
Туре 04	
Types 07, 08	30 ns minimum
Туре 05	
Data, L inputs	15 ns minimum
U/D input	30 ns minimum
EP, ET inputs	
Type 06	
Data, L inputs	25 ns minimum
$U/\overline{D}$ input	30 ns minimum
EP, ET, inputs	
Hold time at any input, t <sub>(hold)</sub>	
Types 09, 13	0 ns minimum
Types 07, 08	10 ns minimum
Types 05, 06	
Data, EP, ET inputs	5 ns minimum
L, U/D inputs	0 ns minimum
Types 03, 04, 11, 12	
Types 03, 04, 11, 12 t <sub>w</sub> (clear)	
Case operating temperature range (T <sub>c</sub> )	
	00 0 10 1 120 0

#### 2. APPLICABLE DOCUMENTS

2.1 <u>General</u>. The documents listed in this section are specified in sections 3, 4, or 5 of this specification. This section does not include documents cited in other sections of this specification or recommended for additional information or as examples. While every effort has been made to ensure the completeness of this list, document users are cautioned that they must meet all specified requirements of documents cited in sections 3, 4, or 5 of this specification, whether or not they are listed.

#### 2.2 Government documents.

2.2.1 <u>Specifications and Standards</u>. The following specifications and standards form a part of this specification to the extent specified herein. Unless otherwise specified, the issues of these documents are those cited in the solicitation or contract.

#### DEPARTMENT OF DEFENSE SPECIFICATIONS

MIL-PRF-38535 - Integrated Circuits (Microcircuits) Manufacturing, General Specification for.

#### DEPARTMENT OF DEFENSE STANDARDS

MIL-STD-883	-	Test Method Standard for Microelectronics.
MIL-STD-1835	-	Interface Standard Electronic Component Case Outlines

(Copies of these documents are available online at http://assist.daps.dla.mil;quicksearch/ or www.dodssp.daps.mil or from the Standardization Document Order Desk, 700 Robbins Avenue, Building 4D, Philadelphia, PA 19111-5094.)

2.3 <u>Order of precedence</u>. In the event of a conflict between the text of this specification and the references cited herein, the text of this document takes precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

#### 3. REQUIREMENTS

3.1 Qualification. Microcircuits furnished under this specification shall be products that are manufactured by a manufacturer authorized by the qualifying activity for listing on the applicable qualified manufacturers list before contract award (see 4.3 and 6.4).

3.2 <u>Item requirements</u>. The individual item requirements shall be in accordance with MIL-PRF-38535 and as specified herein or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not affect the form, fit, or function as described herein.

3.3 <u>Design, construction, and physical dimensions</u>. The design, construction, and physical dimensions shall be as specified in MIL-PRF-38535 and herein.

3.3.1 <u>Terminal connections and logic diagrams</u>. The terminal connections and logic diagrams shall be as specified on figures 1 and 2.

3.3.2 Truth tables. The truth tables and logic equations shall be as specified on figure 3.

3.3.4 <u>Schematic circuits</u>. The schematic circuits shall be \_maintained by the manufacturer and made available to the qualifying activity and the preparing activity (DSCC-VAS) upon request.

3.3.5 <u>Case outlines.</u> The case outlines shall be as specified in 1.2.3.

3.4 Lead material and finish. The lead material and finish shall be in accordance with MIL-PRF-38535 (see 6.6).

3.5 <u>Electrical performance characteristics</u>. The electrical performance characteristics are as specified in table I, and apply over the full recommended case operating temperature range, unless otherwise specified.

3.6 <u>Electrical test requirements.</u> The electrical test requirements for each device class shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table III.

3.7 Marking. Marking shall be in accordance with MIL-PRF-38535.

3.8 <u>Microcircuit group assignment.</u> The devices covered by this specification shall be in microcircuit group number 12 (see MIL-PRF-38535, appendix A).

4. VERIFICATION

4.1 <u>Sampling and inspection</u>. Sampling and inspection procedures shall be in accordance with MIL-PRF-38535 or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not effect the form, fit, or function as described herein.

4.2 <u>Screening</u>. Screening shall be in accordance with MIL-PRF-38535 and shall be conducted on all devices prior to qualification and quality conformance inspection. The following additional criteria shall apply:

- a. The burn-in test duration, test condition, and test temperature, or approved alternatives shall be as specified in the device manufacturer's QM plan in accordance with MIL-PRF-38535. The burn-in test circuit shall be maintained under document control by the device manufacturer's Technology Review Board (TRB) in accordance with MIL-PRF-38535 and shall be made available to the acquiring or preparing activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in test method 1015 of MIL-STD-883.
- b. Interim and final electrical test parameters shall be as specified in table II, except interim electrical parameters test prior to burn-in is optional at the discretion of the manufacturer.
- c. Additional screening for space level product shall be as specified in MIL-PRF-38535, appendix B.

Test	Symbol	Conditions	Device	Lim	nits	Unit
		$-55^{\circ}C \le T_{C} \le +125^{\circ}C$ unless otherwise specified	types	Min	Max	
Low-level output voltage	V <sub>OL</sub>	$\begin{array}{l} V_{CC} = 4.5 \ V, \ V_{IH} = 2.0 \ V \\ V_{IL} \ = 0.7 \ V, \ I_{OL} \ = 4 \ mA \ \underline{1}/ \end{array}$	All	-	0.4	V
High-level output voltage	V <sub>OH</sub>	$\begin{array}{l} V_{CC} = 4.5 \ V, \ V_{IH} = 2.0 \ V \\ V_{IL} \ = 0.7 \ V, \ I_{OH} \ = -400m \ \mu A \end{array}$	All	2.5	-	V
Input clamp voltage	V <sub>IC</sub>	$T_{C} = 25^{\circ}C, V_{CC} = 4.5 V$ $I_{IN} = -18 \text{ mA}$	All	-	-1.5	V
Low-level input current at reset inputs	I <sub>IL1</sub>	$V_{CC} = 5.5 \text{ V}, \text{ V}_{IN} = 0.4 \text{ V}$	01, 02, 10	-30	-400	μA
Low-level input current at input A	I <sub>IL2</sub>		01, 02, 10	-0.5	-2.4	mA
Low-level input current	I <sub>IL3</sub>		01, 10	-0.4	-3.2	mA
at input B			02	-0.4	-1.6	mΑ
Low-level input current at data, clear, EnP	I <sub>IL4</sub>		03, 04	-30	-400	μΑ
Low-level input current at data, EnP	I <sub>IL4</sub>		01, 12	-30	-400	μA
Low-level input current at clear	I <sub>IL4</sub>		01, 12	-30	-760	μΑ
Low-level input current at load	I <sub>IL5</sub>		03, 04, 11, 12	-30	-800	μΑ
Low-level input current at EnT	I <sub>IL5</sub>		03, 04, 11, 12	-30	-860	μΑ
Low-level input current at clock	I <sub>IL6</sub>		03, 04, 11, 12	0	630	mA
Low-level input current	I <sub>IL7</sub>	-	09	15	-1.08	mA
at EnG			13	36	-1.08	
Low-level input current at data, clock, down/up	I <sub>IL8</sub>		09, 13	-120	-400	μA
Low-level input current at load	I <sub>IL8</sub>		09, 13	-100	-400	μA
Low-level input current at data	I <sub>IL9</sub>		07, 08	-100	-400	μΑ
Low-level input current at load	I <sub>IL10</sub>		07, 08	-100	-400	μΑ
Low-level input current at	I <sub>IL11</sub>	-	07, 08	-120	-400	μΑ
Low-level input current at data	I <sub>IL12</sub>		05, 06	-3.0	-400	μΑ
Low-level input current at clock, down/up	I <sub>IL13</sub>		05, 06	-135	-370	μΑ
Low-level input current at EP	I <sub>IL14</sub>		05, 06	-150	-385	μΑ
Low-level input current at ET	I <sub>IL15</sub>		05, 06	-280	-760	μA

See footnotes at end of table.

Test	Symbol	Conditions	Device	Lin	nits	Unit
		-55°C <u>&lt;</u> T <sub>C</sub> <u>&lt;</u> +125°C unless otherwise specified	types	Min	Max	
High-level input current at reset inputs	I <sub>IH1</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 2.7 \text{ V}$	01, 02 10	-	20	μA
High-level input current at reset inputs	I <sub>IH2</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 5.5 \text{ V}$	01, 02 10	-	100	μA
High-level input current at input A	I <sub>IH3</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 2.7 \text{ V}$	01, 02 10	-	80	μA
High-level input current at input A	I <sub>IH4</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 5.5 \text{ V}$	01, 02, 10	-	400	μA
High-level input current at input B	I <sub>IH5</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 2.7 \text{ V}$	01	-	160 80	μA
High-level input current at input B	I <sub>IH6</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 5.5 \text{ V}$	01 02, 10	-	800 400	μA
High-level input current at load, clock, EnT	I <sub>IH9</sub>	$V_{CC} = 5.5 \text{ V}, \ V_{IN} = 2.7 \text{ V}$	03, 04, 11, 12	-	40	μA
High-level input current at load, clock, EnT	I <sub>IH10</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 5.5 \text{ V}$	03, 04, 11, 12	-	200	μA
High-level input current at data, EnP	I <sub>IH11</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 2.7 \text{ V}$	03, 04, 11, 12	-	20	μA
High-level input current at data, EnP	I <sub>IH12</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 5.5 \text{ V}$	03, 04, 11, 12	-	100	μA
High-level input current at clear	I <sub>IH13</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 2.7 \text{ V}$	03, 04, 11, 12	-	20 40	μA
High-level input current at clear	I <sub>IH14</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 5.5 \text{ V}$	03, 04	-	100 200	μA
High-level input current at EnG	I <sub>IH15</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 2.7 \text{ V}$	09, 13	-	60	μA
High-level input current at EnG	I <sub>IH16</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 5.5 \text{ V}$	09, 13	-	300	μA
High-level input current at data, load, clear, count up, count down, clock, down/up	I <sub>IH17</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 2.7 \text{ V}$	05, 06 07, 08 09, 13	-	20	μΑ
High-level input current at data, load, clear, count up, count down, clock, down/up	I <sub>IH18</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 5.5 \text{ V}$	05, 06 07, 08 09, 13	-	100	μA
High-level input current at ET	I <sub>IH19</sub>	$V_{CC} = 5.5 \text{ V}, V_{IN} = 2.7 \text{ V}$	05, 06	-	40	μA

# TABLE I. Electrical performance characteristics.

See footnotes at end of table.

Test	Symbol	Conditions	Device	Lin	nits	Unit
		-55°C ≤ T <sub>C</sub> ≤ +125°C unless otherwise specified	types	Min	Max	
High-level input current at ET	I <sub>IH20</sub>	$V_{CC} = 5.5 \text{ V}, \text{ V}_{IN} = 5.5 \text{ V}$	05, 06	-	200	μA
Short circuit output current	I <sub>OS</sub>	V <sub>CC</sub> = 5.5 V <u>2</u> /	All	-15	-130	mA
Supply current	I <sub>CC</sub>	V <sub>CC</sub> = 5.5 V	01,02,10		15	mA
			05,06,07,08		34	
High lovel supply surrent			09, 13		35	
High-level supply current	I <sub>CCH</sub>	V <sub>CC</sub> = 5.5 V, <u>3</u> /	03, 04, 11, 12	-	31	mA
High-level supply current	I <sub>ССН</sub>	V <sub>CC</sub> = 5.5 V, <u>3</u> /	03, 04 11, 12	-	31	mA
Low-level supply current	I <sub>CCL</sub>	V <sub>CC</sub> = 5.5 V, <u>4</u> /	03, 04 11, 12	-	32	mA
Maximum input A, clock, or count up frequency	F <sub>MAX</sub>	$V_{CC} = 5.0 \text{ V}, C_L = 50 \text{ pF}, \pm 10\%$	05, 06	25	-	MHz
oount up noquonoy		$R_L = 2 k\Omega$	01, 02, 10	29		
			03, 04, 07, 08, 11, 12	22		
			09, 13	18	-	
Propagation delay time, high to low, A to $Q_C$	t <sub>PHL1</sub>		01,02,10	3	81	ns
Propagation delay time, low to high, A to $Q_C$	t <sub>PLH1</sub>	-	01, 10	3	74	ns
			02	3	74	
Propagation delay time, high to low, B to $Q_D$	t <sub>PHL2</sub>		01, 10	3	56	ns
			02	3	78	
Propagation delay time, low to high, B to $Q_D$	t <sub>PLH2</sub>	]	01, 10	3	52	ns
		1	02	3	78	
Propagation delay time, low to high, clock to carry	t <sub>PLH4</sub>		03, 04, 11, 12	3	56	ns
Propagation delay time, high to low, clock to carry	t <sub>PHL4</sub>		03, 04, 11, 12	3	56	ns

# TABLE I. <u>Electrical performance characteristics</u> - Continued.

See footnotes at end of table.

TABLE I.	Electrical performance characteristics - Continued

Test	Symbol	Conditions	Device	Lim	its	Unit
		$-55^{\circ}C \leq T_{C} \leq +125^{\circ}C$ unless otherwise specified	types	Min	Max	
Propagation delay time, low to high, clock to Q	t <sub>PLH5</sub>	$V_{CC} = 5.0 \text{ V}, C_L = 50 \text{ pF}, \pm 10\%$ $R_L = 2 \text{ k}\Omega$	03, 04, 11, 12	3	41	ns
Propagation delay time, high to high, clock to Q	t <sub>PHL5</sub>		03, 04, 11, 12	3	45	ns
Propagation delay time, low to high, clock to Q	t <sub>PLH5</sub>		05, 06	3	26	ns
Propagation delay time, high to low, clock to Q	t <sub>PHL5</sub>		05	3	26	ns
			06	3	36	
Propagation delay time, low to high, clock (data) to Q	t <sub>PLH6</sub>		03, 04, 11, 12	3	42	ns
Propagation delay time, high to low, clock (data) to Q	t <sub>PHL6</sub>		03, 04, 11, 12	3	48	ns
Propagation delay time, low to high, EnT to carry	t <sub>PLH7</sub>		03, 04, 11, 12	3	28	ns
Propagation delay time, high to low, EnT to carry	t <sub>PHL7</sub>		03, 04, 11, 12	3	28	ns
Propagation delay time, low to high, ET to RC	t <sub>PLH7</sub>		05	3	18	ns
			06	3	28	
Propagation delay time, high to low, ET to RC	t <sub>PHL7</sub>		05	3	28	ns
			06	3	32	
Propagation delay time, high to low, clear to Q	t <sub>PHL8</sub>		03, 04, 11, 12	3	46	ns
Propagation delay time, low to high, load to Q	t <sub>PLH8</sub>		07, 08	3	63	ns
Propagation delay time, high to low, load to Q	t <sub>PHL10</sub>		07, 08	3	63	ns
Propagation delay time,	t <sub>PLH9</sub>		07, 08	3	60	ns
low to high, counts up and down to Q, $U/\overline{D}$ to RC			05	3	26	
			06	3	32	

Test	Symbol	Conditions	Device	Lin	nits	Unit
	-	$-55^{\circ}C \le T_C \le +125^{\circ}C$ unless otherwise specified	types	Min	Max	
Propagation delay time, high to low, counts up	t <sub>PHL11</sub>	$V_{CC}$ = 5.0 V, $C_L$ = 50 pF, ±10%	07, 08	3	73	ns
and down to Q, U/ $\overline{D}$ to RC		$R_L = 2 \ k\Omega$	05	3	33	
			06	3	37	
Propagation delay time, high to low, clear to Q	t <sub>PHL12</sub>		07, 08	3	56	ns
Propagation delay time, low to high, load to Q	t <sub>PLH10</sub>		09, 13	3	53	ns
Propagation delay time, high to low, load to Q	t <sub>PHL13</sub>		09, 13	3	77	ns
Propagation delay time, low to high, clock to Q	t <sub>PLH11</sub>	•	09, 13	3	41	ns
Propagation delay time, high to low, clock to Q	t <sub>PHL14</sub>		09, 13	3	57	ns
Propagation delay time, low to high, clock to <u>Max</u> Min	t <sub>PLH12</sub>		09, 13	3	66	ns
Propagation delay time,	t <sub>PLH12</sub>		05	3	35	ns
low to high, clock to ripple carry			06	3	38	
Propagation delay time, high to low, clock to <u>Max</u> Min	t <sub>PHL15</sub>		09, 13	3	80	ns
Propagation delay time,	t <sub>PHL15</sub>	]	05	3	37	ns
high to low, clock to ripple carry			06	3	40	

### TABLE I. <u>Electrical performance characteristics</u> - Continued.

<u>1</u>/ Use  $I_{OL}$  +  $I_{IL3(Max)}$  for  $V_{OL}$  test on  $Q_A$ .

- $\underline{2}$ / Not more than one output should be shorted at a time.
- 3/ I<sub>CCH</sub> is measured : (a) With the load input high; and (b) Then again with the load input low with all other inputs high and all outputs open.
- <u>4</u>/ I<sub>CCL</sub> is measured: (a) With the clock input high; and (b) Then again with the clock input low with all other inputs low and all outputs open.

	Subgroups	(see table III)
MIL-PRF-38535 test requirements	Class S	Class B
	devices	devices
Interim electrical parameters	1	1
Final electrical test parameters	1*, 2, 3, 7,	1*, 2, 3,
	9, 10, 11	7, 9
Group A test requirements	1, 2, 3, 7, 8,	1, 2, 3, 7, 8,
	9, 10, 11	9, 10, 11
Group B test when using the method 5005	1, 2, 3, 7	N/A
QCI option	8, 9, 10, 11	
Group C end-point electrical		1, 2, 3
parameters	1, 2, 3, 7, 8	
	9, 10, 11	
Group D end-point electrical parameters	1, 2, 3	1, 2, 3

#### TABLE II. Electrical test requirements.

\*PDA applies to subgroup 1.

4.3 <u>Qualification inspection</u>. Qualification inspection shall be in accordance with MIL-PRF-38535.

4.4 <u>Technology Conformance inspection (TCI)</u>. Technology conformance inspection shall be in accordance with MIL-PRF-38535 and herein for groups A, B, C, and D inspections (see 4.4.1 through 4.4.4).

4.4.1 Group A inspection. Group A inspection shall be in accordance with table III of MIL-PRF-38535 and as follows:

- a. Tests shall be as specified in table II herein.
- b. Subgroups 4, 5, and 6 shall be omitted.

4.4.2 Group B inspection. Group B inspection shall be in accordance with table II MIL-PRF-38535.

4.4.3 Group C inspection. Group C inspection shall be in accordance with table IV of MIL-PRF-38535 and as follows:

- a. End-point electrical parameters shall be as specified in table II herein.
- b. The steady-state life test duration, test condition, and test temperature, or approved alternatives shall be as specified in the device manufacturer's QM plan in accordance with MIL-PRF-38535. The burn-in test circuit shall be maintained under document control by the device manufacturer's Technology Review Board (TRB) in accordance with MIL-PRF-38535 and shall be made available to the acquiring or preparing activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in test method 1005 of MIL-STD-883.

4.4.4 <u>Group D inspection</u>. Group D inspection shall be in accordance with table V of MIL-PRF-38535. End-point electrical parameters shall be as specified in table II herein.

4.5 <u>Methods of inspection</u>. Methods of inspection shall be specified and as follows:

4.5.1 <u>Voltage and current.</u> All voltages given are referenced to the microcircuit ground terminal. Currents given are conventional and positive when flowing into the referenced terminal.

	Device	type 01	Device	type 02	Device	type 03	Device	type 04
		CASES						
Pin	A, B, C,	2	A, B, C,	2	E,F	2	E,F	2
number	and D		and D					
1	<b>BD INPUT</b>	N/C	INPUT B	N/C	CLEAR	N/C	CLEAR	N/C
2	$R_0^{(1)}$	<b>BD INPUT</b>	R <sub>0(1)</sub>	INPUT B	CLOCK	CLEAR	CLOCK	CLEAR
3	$R_0^{(2)}$	$R_0^{(1)}$	R <sub>0(2)</sub>	$R_0^{(1)}$	INPUT A	CLOCK	INPUT A	CLOCK
4	NC	R0 <sup>(2)</sup>	NC	$R_0^{(2)}$	INPUT B	INPUT A	INPUT B	INPUT A
5	V <sub>CC</sub>	N/C	V <sub>CC</sub>	N/C	INPUT C	INPUT B	INPUT C	INPUT B
6	R <sub>9(1)</sub>	N/C	NC	N/C	INPUT D	N/C	INPUT D	N/C
7	R <sub>9(2)</sub>	N/C	NC	N/C	ENABLE P	INPUT C	ENABLE P	INPUT C
8	OUTPUT C	V <sub>CC</sub>	OUTPUT C	Vcc	GND	INPUT D	GND	INPUT D
9	OUTPUT B	R <sub>9</sub> <sup>(1)</sup>	OUTPUT B	N/C	LOAD	ENABLE P	LOAD	ENABLE P
10	GND	$R_9^{(2)}$	GND	N/C	ENABLE T	GND	ENABLE T	GND
11	OUTPUT D	N/C	OUTPUT D	N/C	$Q_D$	N/C	QD	N/C
12	OUTPUT A	OUTPUT C	OUTPUT A	OUTPUT C	Qc	LOAD	Qc	LOAD
13	NC	OUTPUT B	NC	OUTPUT B	Q <sub>B</sub>	Т	Q <sub>B</sub>	Т
14	INPUT A	GND	INPUT A	GND	Q <sub>A</sub>	Q <sub>D</sub>	Q <sub>A</sub>	Q <sub>D</sub>
15		N/C		N/C	CARRY	Qc	CARRY	Q <sub>C</sub>
					OUTPUT		OUTPUT	
16		OUTPUT D		OUTPUT D	Vcc	N/C	Vcc	N/C
17		N/C		N/C		Q <sub>B</sub>		Q <sub>B</sub>
18		OUTPUT A		OUTPUT A		Q <sub>A</sub>		Q <sub>A</sub>
19		N/C		N/C		CARRY		CARRY
						OUTPUT		OUTPUT
20		INPUT A		INPUT A		Vcc		Vcc

FIGURE 1. Terminal connections.

	Device type 05		Device type 06		Device type 07		Device type 08	
	CASES							
Pin number	E, F	2	E, F	2	E, F	2	E, F	2
1	U/D	N/C	U/D	N/C	DATA B INPUT	N/C	DATA B INPUT	N/C
2	СК	U/D	СК	U/D	Q <sub>B</sub>	DATA B INPUT	Q <sub>B</sub>	DATA B INPUT
3	INPUT A	СК	INPUT A	СК	Q <sub>A</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Q <sub>B</sub>
4	INPUT B	INPUT A	INPUT B	INPUT A	COUNT DOWN	Q <sub>A</sub>	COUNT DOWN	Q <sub>A</sub>
5	INPUT C	INPUT B	INPUT C	INPUT B	COUNT UP	COUNT DOWN	COUNT UP	COUNT DOWN
6	INPUT D	N/C	INPUT D	N/C	Q <sub>C</sub>	N/C	Q <sub>C</sub>	N/C
7	ENABLE P	INPUT C	ENABLE P	INPUT C	QD	COUNT UP	Q <sub>D</sub>	COUNT UP
8	GND	INPUT D	GND	INPUT D	GND	Qc	GND	Qc
9	LOAD	ENABLE P	LOAD	ENABLE P	DATA D	Q <sub>D</sub>	DATA D	Q <sub>D</sub>
10	ENABLE T	GND	ENABLE T	GND	DATA C	GND	DATA C	GND
11	Q <sub>D</sub>	N/C	Q <sub>D</sub>	N/C	LOAD	N/C	LOAD	N/C
12	Qc	LOAD	Qc	LOAD	CARRY	DATA D	CARRY	DATA D
13	Q <sub>B</sub>	ENABLE T	Q <sub>B</sub>	ENABLE T	BORROW	DATA C	BORROW	DATA C
14	Q <sub>A</sub>	Q <sub>D</sub>	Q <sub>A</sub>	Q <sub>D</sub>	CLEAR	LOAD	CLEAR	LOAD
15	RIPPLE CARRY OUTPUT	Q <sub>C</sub>	RIPPLE CARRY OUTPUT	Q <sub>C</sub>	DATA A	CARRY	DATA A	CARRY
16	V <sub>cc</sub>	N/C	V <sub>CC</sub>	N/C	V <sub>CC</sub>	N/C	V <sub>CC</sub>	N/C
17		Q <sub>B</sub>		Q <sub>B</sub>		BORROW	ļ	BORROW
18		Q <sub>A</sub>		Q <sub>A</sub>		CLEAR		CLEAR
19		RC		RC		DATA		DATA
		OUTPUT		OUTPUT		Α		Α
20		V <sub>CC</sub>		Vcc		V <sub>CC</sub>		V <sub>CC</sub>

FIGURE 1. <u>Terminal connections</u> - Continued.

MIL-M-38510/3	315D
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	Device type 09 Device		type 10 Device type 11			Device type 12		
			CASES					
Pin number	E, F	2	A,B C, and D	2	E, F	2	E, F	2
1	DATA B	N/C	INPUT BC	N/C	CLEAR	N/C	CLEAR	N/C
2	Q <sub>B</sub>	DATA B	NC	INPUT BC	CLOCK	CLEAR	CLOCK	CLEAR
3	Q <sub>A</sub>	Q <sub>B</sub>	NC	N/C	INPUT A	CLOCK	INPUT A	CLOCK
4	ENABLE G	Q <sub>A</sub>	NC	N/C	INPUT B	INPUT A	INPUT B	INPUT A
5	DOWN UP	ENABLE G	Vcc	N/C	INPUT C	INPUT B	INPUT C	INPUT B
6	Qc	N/C	R <sub>0(1)</sub>	N/C	INPUT D	N/C	INPUT D	N/C
7	Q <sub>D</sub>	DOWN UP	R <sub>O(2)</sub>	N/C	ENABLE P	INPUT C	ENABLE P	INPUT C
8	GND	Q <sub>C</sub>	OUTPUT D	V <sub>CC</sub>	GND	INPUT D	GND	INPUT D
9	DATA D	Q <sub>D</sub>	OUTPUT C	R <sub>0</sub> <sup>(1)</sup>	LOAD	ENABLE P	LOAD	ENABLE P
10	DATA C	GND	GND	R <sub>0</sub> <sup>(2)</sup>	ENABLE T	GND	ENABLE T	GND
11	LOAD	N/C	OUTPUT B	N/C	$Q_{D}$	N/C	Q <sub>D</sub>	N/C
12	MAX/ MIN	DATA D	OUTPUT A	OUTPUT D	Qc	LOAD	Q <sub>C</sub>	LOAD
13	RIPPLE CLOCK	DATA C	NC	OUTPUT C	Q <sub>B</sub>	Т	Q <sub>B</sub>	Т
14	CLOCK	LOAD	INPUT A	GND	Q <sub>A</sub>	Q <sub>D</sub>	Q <sub>A</sub>	Q <sub>D</sub>
15	DATA A	MAX/ MIN		N/C	CARRY OUTPUT	Q <sub>C</sub>	CARRY OUTPUT	Q <sub>C</sub>
16	Vcc	N/C		OUTPUT B	Vcc	N/C	Vcc	N/C
17		Rc		N/C		Q <sub>B</sub>		Q <sub>B</sub>
18		CLOCK		OUTPUT A		Q <sub>A</sub>		Q <sub>A</sub>
19		DATA A		N/C		CARRY		CARRY
						OUTPUT		OUTPUT
20		V <sub>cc</sub>		INPUT A		V <sub>CC</sub>		V <sub>CC</sub>

FIGURE 1. <u>Terminal connections</u> - Continued.

	Device type 13					
	CASES					
Pin number	E, F	2				
1	DATA B	N/C				
2	Q <sub>B</sub>	DATA B				
3	Q <sub>A</sub>	Q <sub>B</sub>				
4	ENABLE	Q <sub>A</sub>				
-	G					
5	DOWN	ENABLE				
	UP	G				
6	Q <sub>C</sub>	N/C				
7	QD	DOWN				
		UP				
8	GND	Q <sub>C</sub>				
9	DATA D	Q <sub>D</sub>				
10	DATA C	GND				
11	LOAD	N/C				
12	MAX/	DATA D				
	MIN					
13	RIPPLE	DATA C				
	CLOCK					
14	CLOCK	LOAD				
15	DATA A	MAX/				
		MIN				
16	Vcc	N/C				
17		Rc				
18		CLOCK				
19		DATA A				
20		Vcc				

FIGURE 1. Terminal connections - Continued

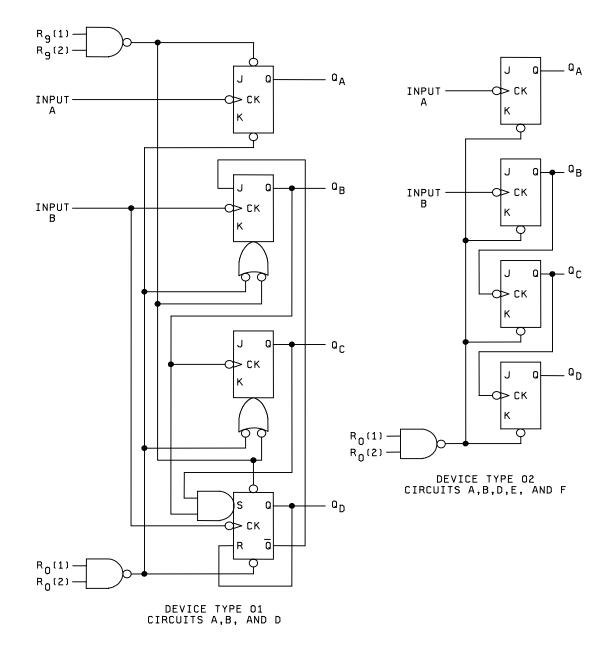
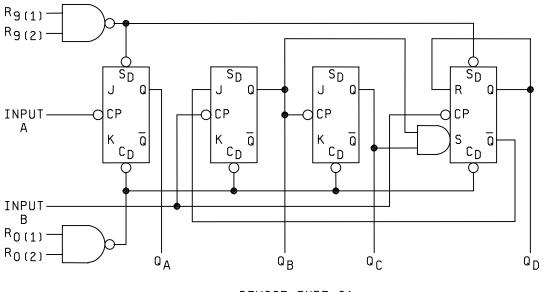


FIGURE 2. Logic diagrams



DEVICE TYPE 01 CIRCUITS E AND F

FIGURE 2. Logic diagrams – Continued.

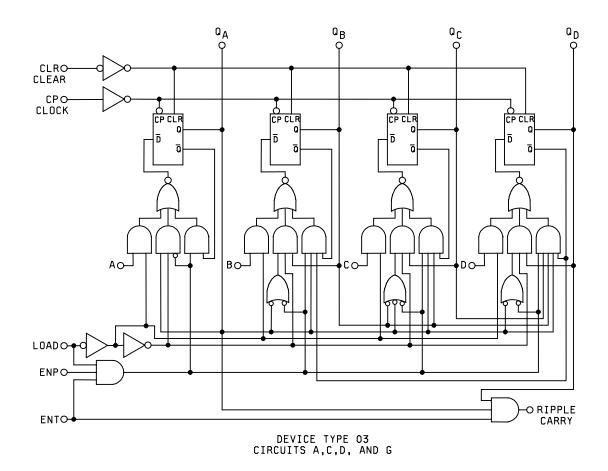


FIGURE 2. Logic diagrams – Continued.

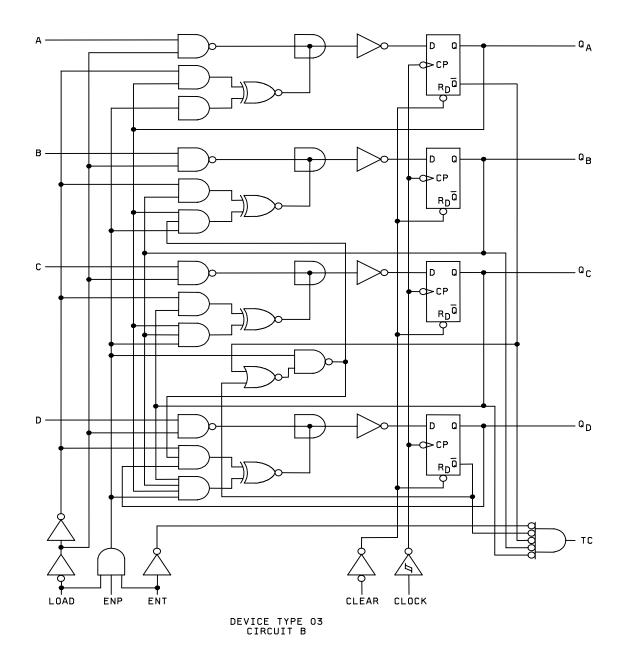


FIGURE 2. Logic diagrams - Continued.

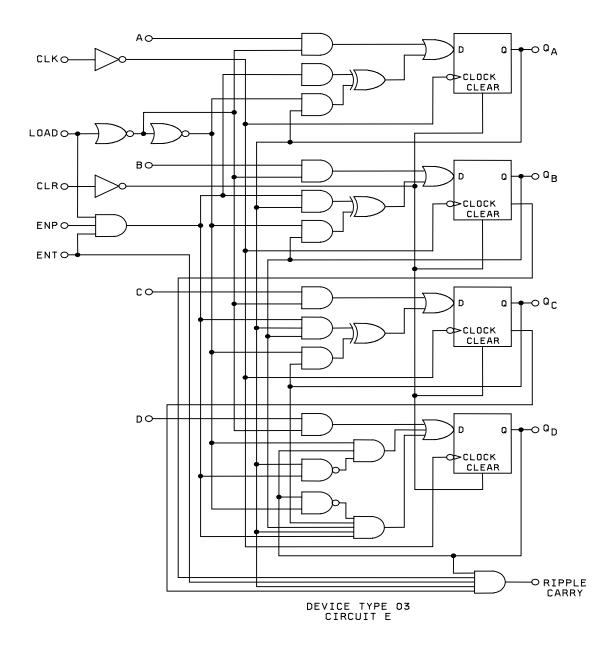


FIGURE 2. Logic diagrams - Continued.

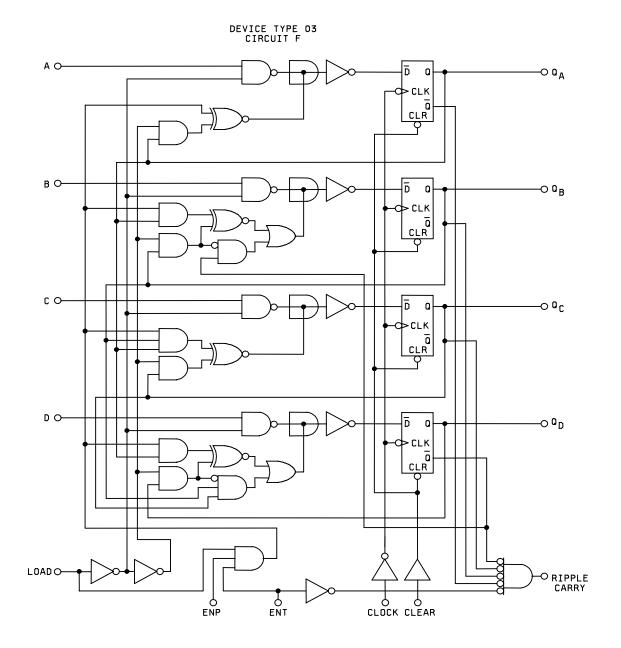
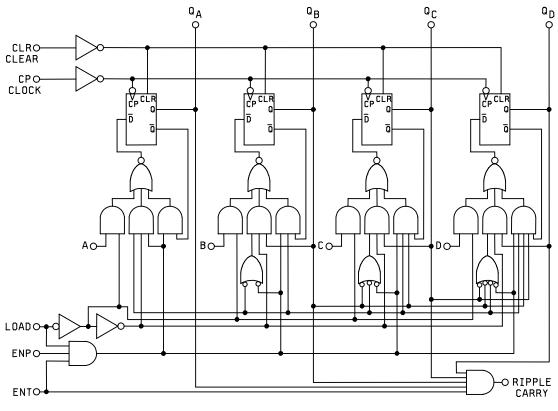


FIGURE 2. Logic diagrams - Continued.



DEVICE TYPE 04 CIRCUITS A,C,D,AND G

FIGURE 2. Logic diagrams - Continued.

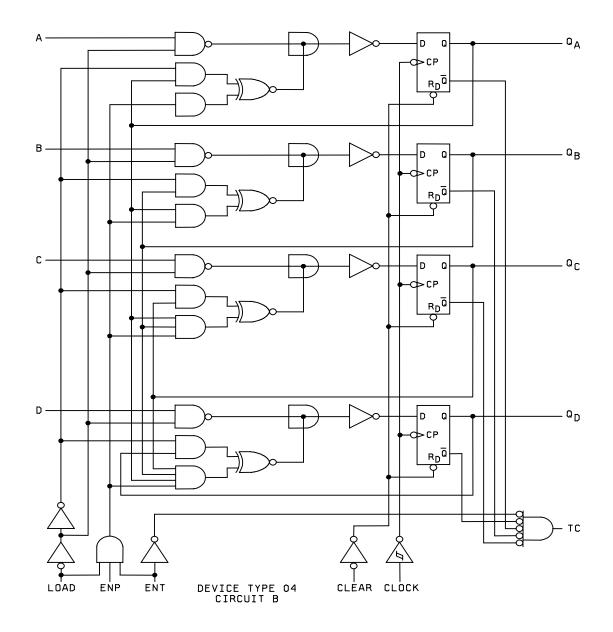


FIGURE 2. Logic diagrams – Continued.

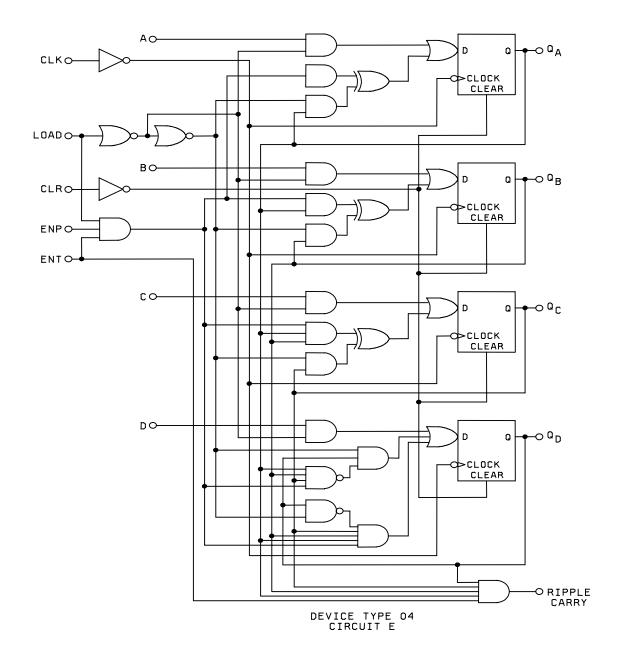


FIGURE 2. Logic diagrams - Continued.

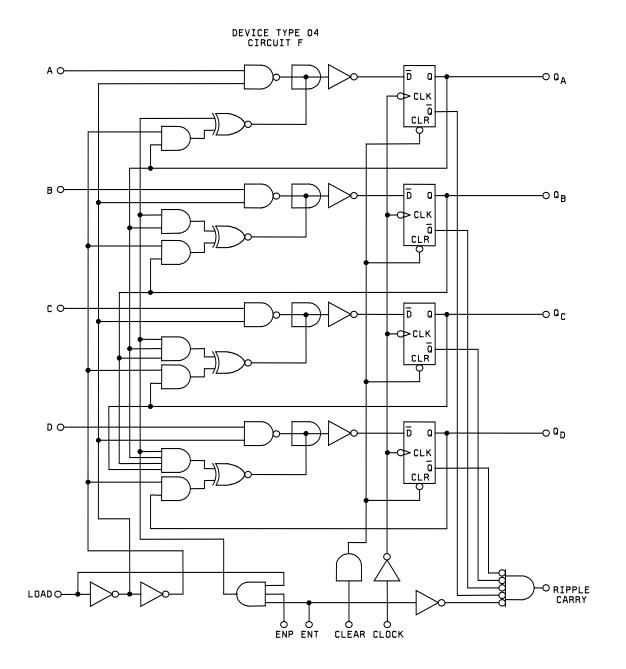


FIGURE 2. Logic diagrams - Continued.



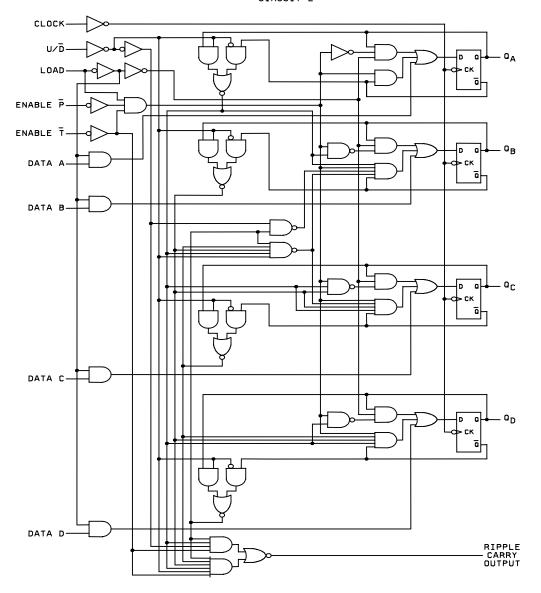


FIGURE 2. Logic diagrams - Continued.

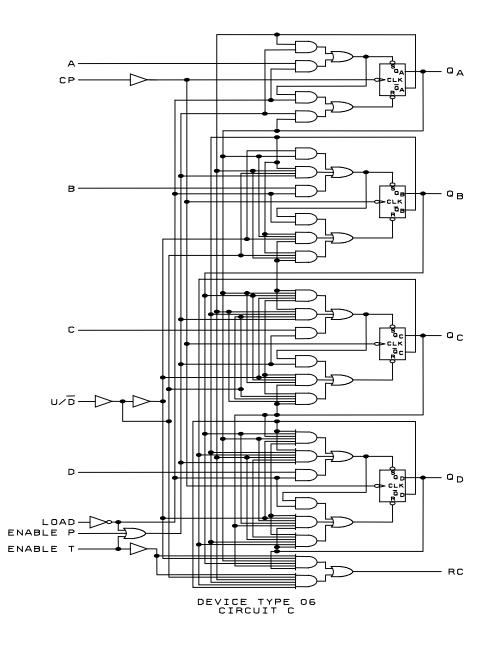


FIGURE 2. Logic diagrams - Continued.

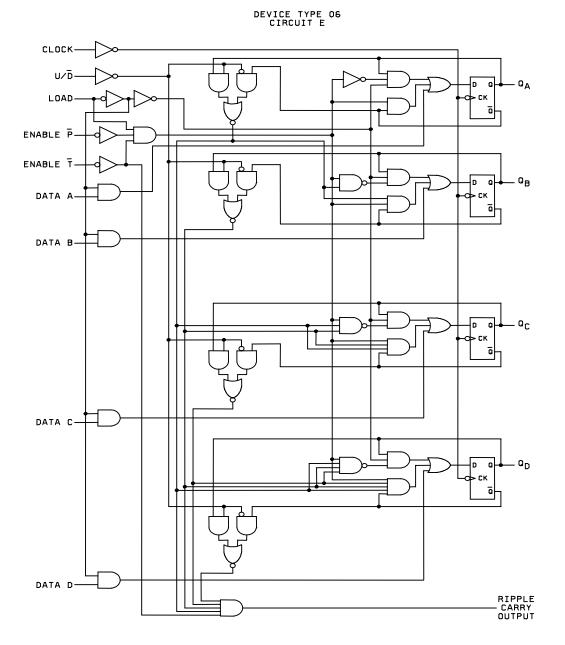


FIGURE 2. Logic diagrams - Continued.

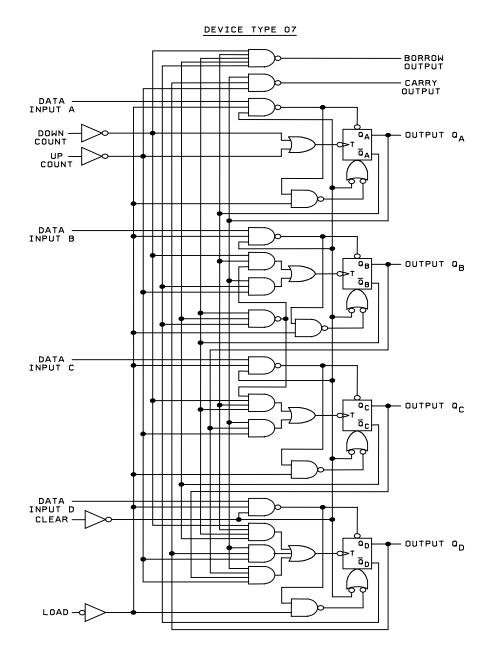


FIGURE 2. Logic diagrams - Continued.

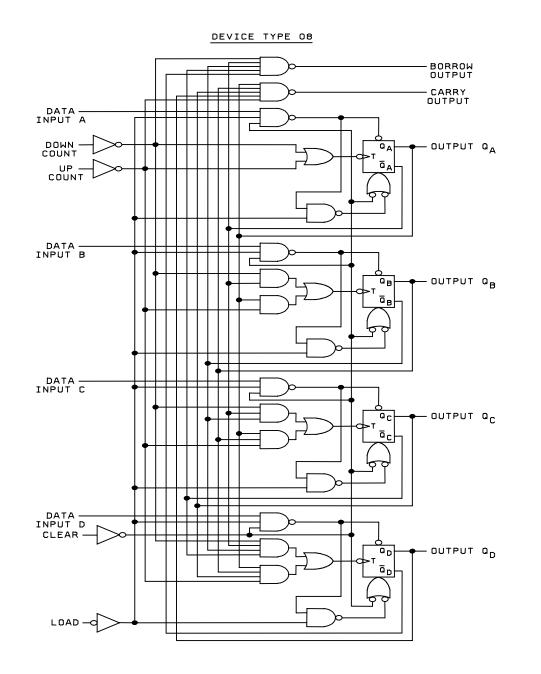


FIGURE 2. Logic diagrams - Continued.

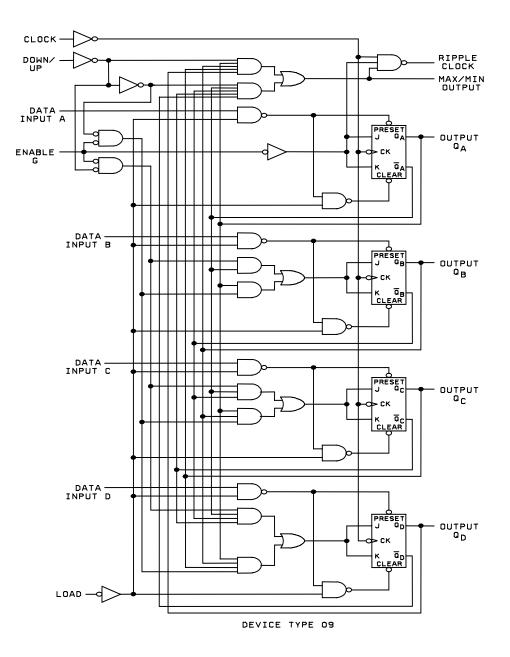


FIGURE 2. Logic diagrams - Continued.

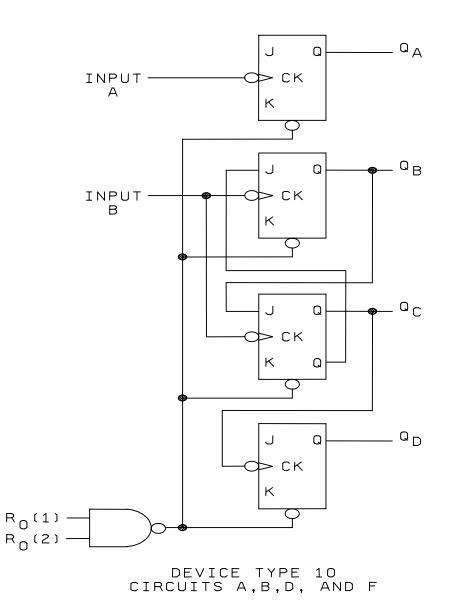
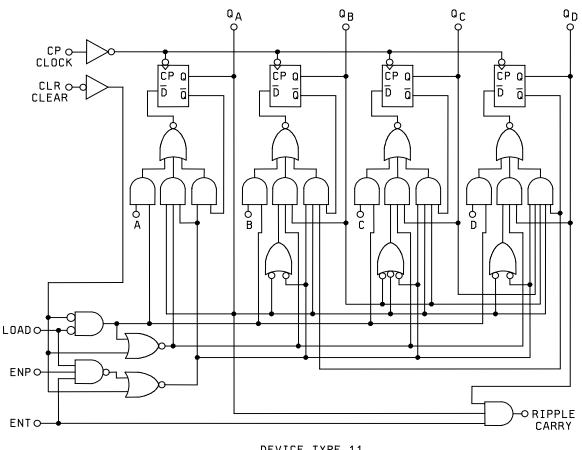


FIGURE 2. Logic diagrams – Continued.



DEVICE TYPE 11 CIRCUITS A,C,D, AND G

FIGURE 2. Logic diagrams – Continued.

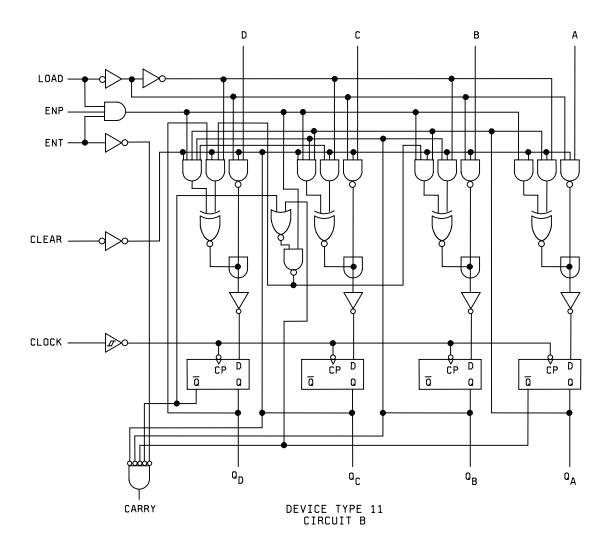


FIGURE 2. Logic diagrams - Continued.

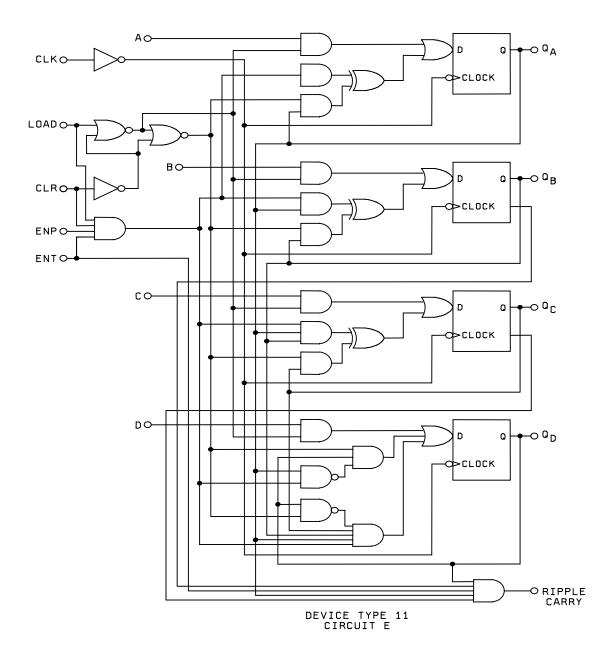


FIGURE 2. Logic diagrams - Continued.

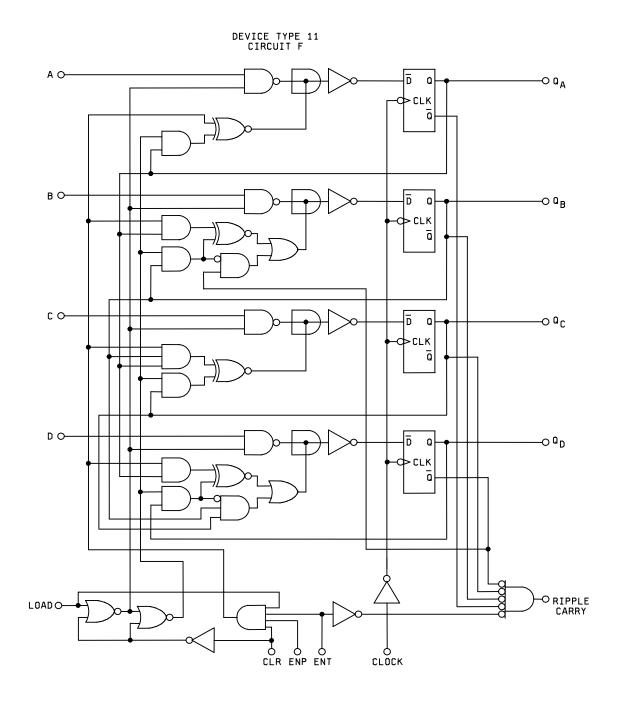
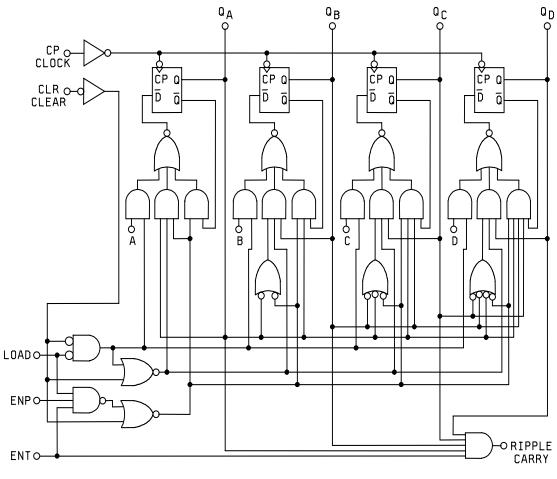


FIGURE 2. Logic diagrams - Continued.



DEVICE TYPE 12 CIRCUITS A,C,D, AND G

FIGURE 2. Logic diagrams – Continued.

37

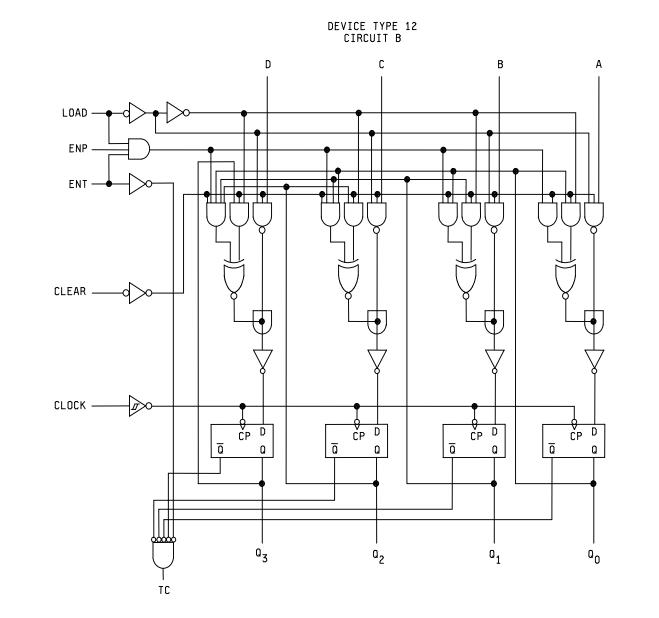


FIGURE 2. Logic diagrams - Continued.

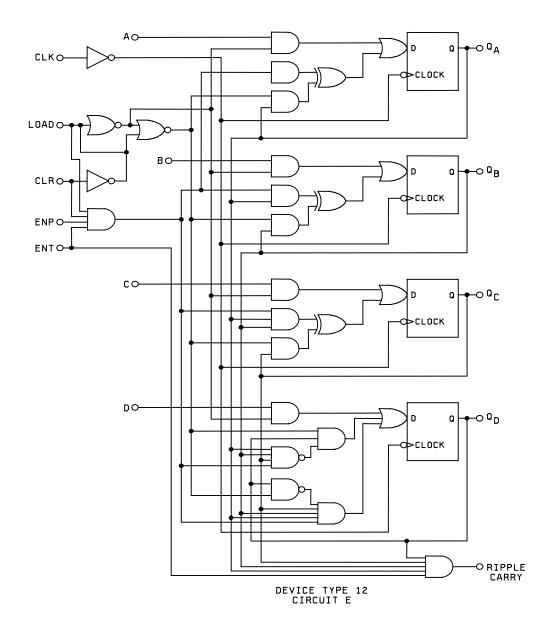


FIGURE 2. Logic diagrams – Continued.

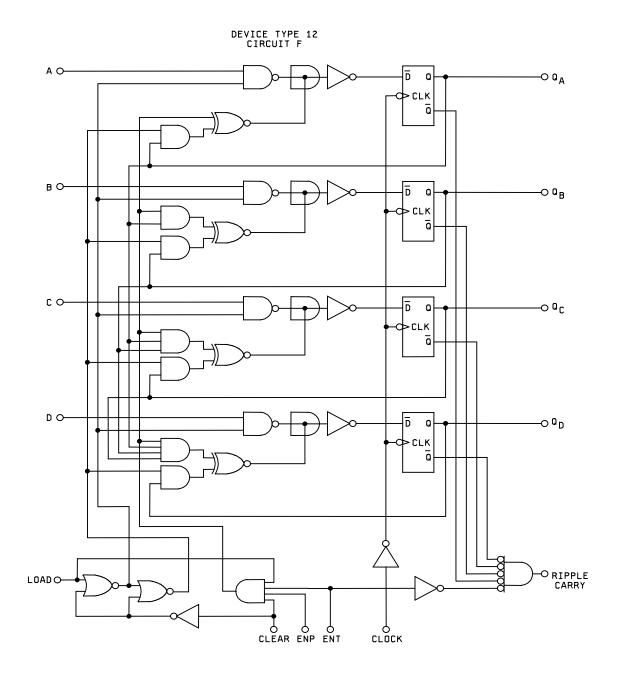


FIGURE 2. Logic diagrams – Continued.

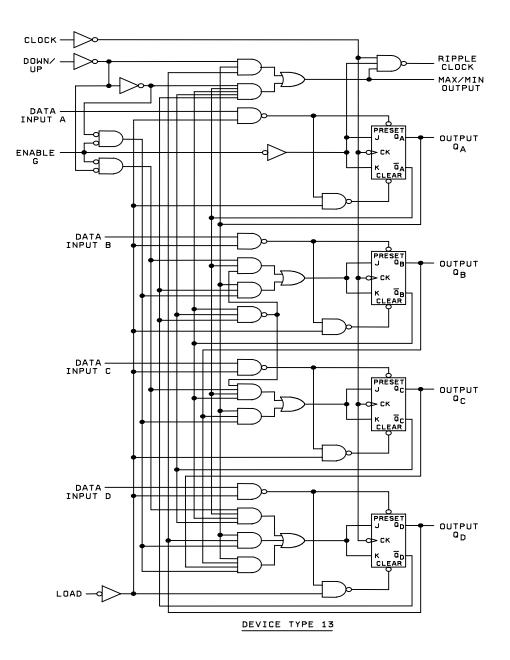


FIGURE 2. Logic diagrams – Continued.

## DEVICE TYPE 01

#### OUTPUT COUNT $\mathsf{Q}_\mathsf{D}$ $\mathsf{Q}_\mathsf{C}$ $\mathsf{Q}_\mathsf{B}$ QA 0 L L L L 1 L L L Н 2 L L Н L 3 L Н Н L 4 L Н L L 5 Н L L Н Н 6 L Н L Н Н Н 7 L 8 Н L L L 9 Н L L Н

# BCD COUNT SEQUENCE (See Note A)

# BI-QUINARY (5-2) (See Note B)

COUNT		OUT	PUT	
COONT	QA	QD	Qc	QB
0	L	L	L	L
1	L	L	L	Н
2	L	L	Н	L
3	L	L	Н	Н
4	L	Н	L	L
5	Н	L	L	L
6	Н	L	L	Н
7	Н	L	Н	L
8	Н	L	Н	Н
9	Н	Н	L	L

# **RESET/COUNT FUNCTION TABLE**

	RESET I	NPUTS			OUT	PUT		
R <sub>0(1)</sub>	R <sub>0(2)</sub>	R <sub>9(1)</sub>	R <sub>9(2)</sub>	QD	Qc	QB	QA	
Н	Н	L	Х	L	L	L	L	
Н	Н	Х	L	L	L	L	L	
Х	Х	Н	Н	Н	L	L	Н	
Х	L	Х	L		COL	JNT	-	
L	Х	L	Х		COL	JNT		
L	Х	Х	L	COUNT				
Х	L	L	Х		COL	JNT		

FIGURE 3. Truth tables.

## DEVICE TYE 02

## COUNT SEQUENCE (See Note)

COUNT		OUTPUT								
COONT	$Q_D$	Qc	QB	QA						
0	L	L	L	L						
1	L	L	L	Н						
2	L	L	Н	L						
3	L	L	Н	Н						
4	L	Н	L	L						
5	L	Н	L	Н						
6	L	Н	Н	L						
7	L	Н	Н	Н						
8	Н	L	L	L						
9	Н	L	L	Н						
10	Н	L	Н	L						
11	Н	L	Н	Н						
12	Н	Н	L	L						
13	Н	Н	L	Н						
14	Н	Н	Н	L						
15	Н	Н	Н	Н						

## DEVICE TYPE 10

#### COUNT SEQUENCE (See Note)

COUNT		OUT	PUT	
COONT	QD	Qc	QB	Q <sub>A</sub>
0	L	L	L	L
1	L	L	L	Н
2	L	L	Н	L
3	L	L	Н	Н
4	L	Н	L	L
5	L	Н	L	Н
6	Н	L	L	L
7	Н	L	L	Н
8	Н	L	Н	L
9	Н	Ĺ	Н	Н
10	Н	Н	L	Ĺ
11	Н	Н	L	Н

# **RESET/COUNT FUNCTION TABLE**

RESET	INPUTS		OUT	PUT	
R <sub>0(1)</sub>	R <sub>0(2)</sub>	QD	Qc	QB	QA
Н	Н	L	L	L	L
L	Х		CO	UNT	
Х	L		CO	UNT	

NOTE: Output Q<sub>A</sub> is connected to input B.

## **RESET/COUNT FUNCTION TABLE**

RESET II	NPUTS		OUT	ΓPUT			
R <sub>0(1)</sub>	R <sub>0(2)</sub>	QD	Qc	QB	QA		
Н	Н						
L	Х		CO	UNT			
Х	L		CO	UNT			

NOTE: Output Q<sub>A</sub> is connected to input B.

FIGURE 3. Truth tables.

	Input at time t <sub>n</sub>									Outputs at time t <sub>n+1</sub>				
Clock	Enable P	Enable T	Load	А	В	С	D	Clear	Q <sub>A</sub>	Q <sub>A</sub> Q <sub>B</sub> Q <sub>C</sub> Q <sub>D</sub>			Carry output	
CP	L	Х	Н	Х	Х	Х	Х	Н	NC	NC	NC	NC	NC	
CP	Х	L	Н	Х	Х	Х	Х	Н	NC	NC	NC	NC	L	
CP	Н	Н	Н	Х	Х	Х	Х	Н	Pr	evious c (not		s 1	H if count = 9 L if count < 9	
CP	Х	Н	L	Х	Х	Х	Х	Н				H if count = 9 L if count < 9		
CP	Х	L	L	Х	Х	Х	Х	Н	Α	В	С	D	L	
CP	Х	Х	Х	Х	Х	Х	Х	L	L	L	L	L	L	

## SYNCHRONOUS TRUTH TABLE, DEVICE TYPES 3 AND 11

# ASYNCHRONOUS TRUTH TABLE, DEVICE TYPE 3

	Inputs at time t <sub>n</sub>									Outp	uts at t	ime t <sub>n</sub>	+1
Clock	Enable P	Enable T	Load	А	В	С	D	Clear	Q <sub>A</sub>	$Q_B$	Qc	QD	Carry output
Х	X X X X X X X L									L	L	L	L

## NOTES:

- 1. See up count sequence table.
- 2.  $L = V_{IL}$  for inputs,  $V_{0L}$  for outputs. 3.  $H = V_{IH}$  for inputs,  $V_{0H}$  for outputs.
- 4.  $X = V_{IH}$  or  $V_{IL}$ .
- 5. CP = Clock pulse.
- 6. NC = No change.

#### UP COUNT SEQUENCE TABLE

Q <sub>A</sub> (LSB)	Q <sub>B</sub>	Q <sub>C</sub>	Q <sub>D</sub> (MSB)
(LSB)			(MSB)
L	L	L	L
Н	L	L	L
L	Н	L	L
Н	Н	L	L
L	L	Н	L
Н	L	Н	L
L	Н	Н	L
Н	Н	Н	L
L	L	L	Н
Н	L	L	Н

FIGURE 3. Truth tables - Continued.

			nput at t	time t <sub>n</sub>					Outputs at time t <sub>n+1</sub>				
Clock	Enable P	Enable T	Load	А	В	С	D	Clear	Q <sub>A</sub>	Q <sub>B</sub>	Qc	$Q_D$	Carry output
CP	L	Х	Н	Х	Х	Х	Х	Н	NC	NC	NC	NC	NC
CP	Х	L	Н	Х	Х	Х	Х	Н	NC	NC	NC	NC	L
CP	Н	Н	Н	Х	Х	Х	Х	Н	Pr	evious c	ount plu	s 1	H if count = 15
										(not	e 1)		L if count < 15
CP	Х	Н	L	Х	Х	Х	Х	Н	А	В	С	D	H if count = 15
									L			L if count < 15	
CP	Х	L	L	Х	Х	Х	Х	Н	А	В	С	D	L
CP	Х	Х	Х	Х	Х	Х	Х	L	L	L	L	L	L

## SYNCHRONOUS TRUTH TABLE, DEVICE TYPES 4 AND 12

## ASYNCHRONOUS TRUTH TABLE, DEVICE TYPE 4

	Inputs at time t <sub>n</sub>									Outp	uts at t	ime t <sub>n</sub>	+1
Clock	Clock P T Load A B C D Clear								Q <sub>A</sub>	$Q_B$	Q <sub>C</sub>	$Q_D$	Carry output
Х	X X X X X X X L								L	L	L	L	L

NOTES:

- 1. See up count sequence table. 2. L =  $V_{IL}$  for inputs,  $V_{0L}$  for outputs. 3. H =  $V_{IH}$  for inputs,  $V_{0H}$  for outputs.

4.  $X = V_{IH}$  or  $V_{IL}$ .

5. CP = Clock pulse.

6. NC = No change.

## UP COUNT SEQUENCE TABLE

Q <sub>A</sub>	QB	Q <sub>C</sub>	$Q_D$
Q <sub>A</sub> (LSB)			Q <sub>D</sub> (MSB)
L	L	L	Ĺ
Н	L	L	L
L	Н	L	L
Н	Н	L	L
L	L	Н	L
Н	L	Н	L
L	Н	Н	L
Н	Н	Н	L
L	L	L	Н
Н	L	L	Н
L	Н	L	Н
Н	Н	L	Н
L	L	Н	Н
Н	L	Н	Н
L	Н	Н	Н
Н	Н	Н	Н

FIGURE 3. <u>Truth tables</u> – Continued.

# Device type 05

# UP COUNT SEQUENCE TABLE

Q <sub>A</sub> (LSB)	Q <sub>B</sub>	Q <sub>C</sub>	Q <sub>D</sub> (MSB)
(LSB)			(MSB)
L	L	L	L
Н	L	L	L
L	Н	L	L
Н	Н	L	L
L	L	Н	L
Н	L	Н	L
L	Н	Н	L
Н	Н	Н	L
L	Ĺ	Ĺ	Н
Н	L	L	Н

# Device type 06

# UP COUNT SEQUENCE TABLE

Q <sub>A</sub>	Q <sub>B</sub>	Q <sub>C</sub>	$Q_{D}$
Q <sub>A</sub> (LSB)			Q <sub>D</sub> (MSB)
Ĺ	L	L	Ĺ
Н	L	L	L
L	Н	L	L
Н	Н	L	L
L	L	Н	L
Н	L	Н	L
L	Н	Н	L
Н	Н	Н	L
L	L	L	Н
Н	L	L	Н
L	Н	L	Н
Н	Н	L	Н
L	L	Н	Н
Н	Ĺ	Н	Н
L	Н	Н	Н
Н	Н	Н	Н

# Device types 05 and 06

# MODE SELECT TABLE

L	EP	ET	U/D	Action on Rising Clock Edge
L	Х	Х	Х	Load $(D_n \rightarrow Q_n)$
Н	L	L	Н	Count Up (increment)
Н	L	L	L	Count Down (decrement)
Н	Н	Х	Х	No Change (Hold)
Н	Х	Н	Х	No Change (Hold)

H = High voltage level L = Low voltage X = Don't care

FIGURE 3. <u>Truth tables</u> – Continued.

DEVICE TYPE 7 TRUTH TABLE
---------------------------

	Inputs at time t <sub>n</sub>							Outputs at time t <sub>n=1</sub>					
Count Up	Count Down	Load	А	В	с	D	Clear	Q <sub>A</sub>	Q <sub>B</sub>	Q <sub>c</sub>	Q <sub>D</sub>	Carry	Borrow
Ĥ	Н	Н	Х	Х	Х	Х	L	NC	NC	NC	NC	H	Н
Н	Н	Н	Х	Х	Х	Х	Н	L	L	L	L	Н	Н
Н	Н	L	Х	Х	Х	Х	L	Α	В	С	D	Н	Н
P	Н	Н	Х	Х	Х	Х	L	Prev	ious co (note	ount plu e 1)	us 1	Н	Н
Н	Р	Н	Х	Х	Х	Х	L	Previ	ous co (note	unt min e 2)	ius 1	Н	Н
N	Н	Н	Х	Х	Х	Х	L	NC	ŃC	ŃC	NC	N if count = 9 H if count $\neq$ 9	Н
Н	N	Н	Х	Х	Х	Х	L	NC	NC	NC	NC	Н	N if count = 0 H if count $\neq 0$

NOTES:

- 1. See up count sequence table.
- 2. See down count sequence table.
- 3. L=  $V_{IL}$  for inputs,  $V_{OL}$  for outputs.
- 4.  $H = V_{IH}$  for inputs,  $V_{OH}$  for outputs. 5.  $X = V_{IH}$  or  $V_{IL}$ . 6. NC = No change.

- 7. NA = Not applicable.
- P = Positive going pulse.
   N= Negative going pulse.

FIGURE 3. <u>Truth tables</u> – Continued.

## **DEVICE TYPE 07**

## UP COUNT SEQUENCE TABLE

Q <sub>A</sub> (LSB)	Q <sub>B</sub>	Q <sub>C</sub>	Q <sub>D</sub> (MSB)	Carry
(LSB)			(MSB)	
L	L	L	L	Н
Н	L	L	L	Н
L	Н	L	L	Н
Н	Н	L	L	Н
L	L	Н	L	Н
Н	L	Н	L	Н
L	Н	Н	L	Н
Н	Н	Н	L	Н
L	L	L	Н	Н
Н	L	L	Н	L

#### DOWN COUNT SEQUENCE TABLE

Q <sub>A</sub> (LSB)	Q <sub>B</sub>	Q <sub>C</sub>	Q <sub>D</sub> (MSB)	Borrow
(LSB)			(MSB)	
Н	L	L	Н	Н
L	L	L	Н	Н
Н	Н	Н	L	Н
L	Н	Н	L	Н
Н	L	Н	L	Н
L	L	Н	L	Н
Н	Н	L	L	Н
L	Н	L	L	Н
Н	L	L	L	Н
L	L	L	L	L

#### **DEVICE TYPE 8 TRUTH TABLE**

Input at time t <sub>n</sub>								Outputs at time t <sub>n=1</sub>					
Count	Count												
up	down	Load	А	В	С	D	Clear	QA	QB	Q <sub>C</sub>	$Q_D$	Carry	Borrow
Н	Н	Н	Х	Х	Х	Х	L	NC	NC	NC	NC	Н	Н
Н	Н	Н	Х	Х	Х	Х	Н	L	L	L	L	Н	Н
Н	Н	L	Х	Х	Х	Х	L	Α	В	С	D	Н	Н
Р	Н	Н	Х	Х	Х	Х	L	Pre	vious co	ount plu	us 1	Н	Н
									(no				
Н	Р	Н	Х	Х	Х	Х	L	Prev	ious co	unt mir	nus 1	Н	Н
									(not	e 2)			
N	Н	Н	Х	Х	Х	Х	L	NC	NC	NC	NC	N if count = 15	Н
												H if count ≠ 15	
Н	N	Н	Х	Х	Х	Х	L	NC	NC	NC	NC	Н	N if count = $0$
													H if count ≠ 0

NOTES:

- 1. See up count sequence table.
- 2. See down count sequence table.

3.  $L = V_{IL}$  for inputs,  $V_{OL}$  for outputs.

- 4.  $H = V_{IH}$  for inputs,  $V_{OH}$  for outputs.

5.  $X = V_{IH}$  or  $V_{IL}$ . 6. NC = No change.

- 7. NA = Not applicable.
- 8. P = Positive going pulse.
- 9. N = Negative going pulse.

## FIGURE 3. Truth tables - Continued.

## **DEVICE TYPE 08**

# UP COUNT SEQUENCE TABLE

## DOWN COUNT SEQUENCE TABLE

Q <sub>A</sub> (LSB)	Q <sub>B</sub>	Q <sub>C</sub>	Q <sub>D</sub> (MSB)	Carry
L	L	L	L	Н
Н	L	L	L	Н
L	Н	L	L	Н
Н	Н	L	L	Н
L	L	Н	L	Н
Н	L	Н	L	Н
L	Н	Н	L	Н
Н	Н	Н	L	Н
L	L	L	Н	Н
Н	L	L	Н	Н
L	Н	L	Н	Н
Н	Н	L	Н	Н
L	L	Н	Н	Н
Н	L	Н	Н	Н
L	Н	Н	Н	Н
Н	Н	Н	Н	L

Q <sub>A</sub> (LSB)	Q <sub>B</sub>	Qc	Q <sub>D</sub> (MSB)	Borrow
(LSB)			(MSB)	
Н	Н	Н	Н	Н
L	Н	Н	Н	Н
Н	L	Н	Н	Н
L	L	Н	Н	Н
Н	Н	L	Н	Н
L	Н	L	Н	Н
Н	L	L	Н	Н
L	L	L	Н	Н
Н	Н	Н	L	Н
L	Н	Н	L	Н
Н	L	Н	L	Н
L	L	Н	L	Н
Н	Н	L	L	Н
Ĺ	Н	L	Ĺ	Н
Н	Ĺ	L	Ĺ	Н
L	L	L	L	L

## DEVICE TYPES 09 AND 13

#### Mode select table

	Inputs								
Load	Enable G	U/D	CLK	Mode					
Н	L	L		Count up					
Н	L	Н		Count down					
L	Х	Х	Х	Preset (Asyn)					
Н	Н	Х	Х	No change (Hold)					

#### Ripple carry truth table

Inp	outs	Outputs			
Enable			RC		
G	CLK	Max/Min	output		
L		Н			
Н	Х	Х	Н		
Х	Х	L	Н		

L = Low voltage level

H = High voltage level

X = Don't care

\_\_\_ = Low-to-high clock transition

I = Negative going clock pulse

NOTE: The up count and down count sequence for device type 09 is identical as that for device type 08.

The up count and down count sequence for device type 13 is identical as that for device type 07.

FIGURE 3. <u>Truth tables</u> – Continued.

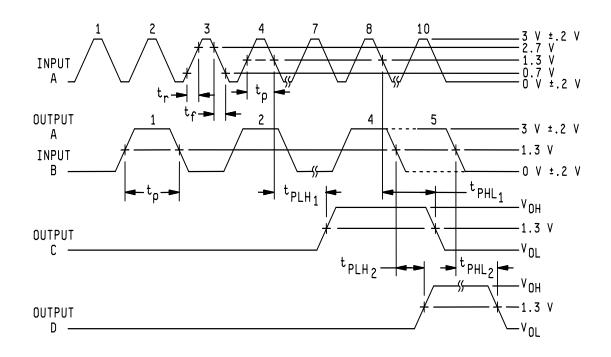
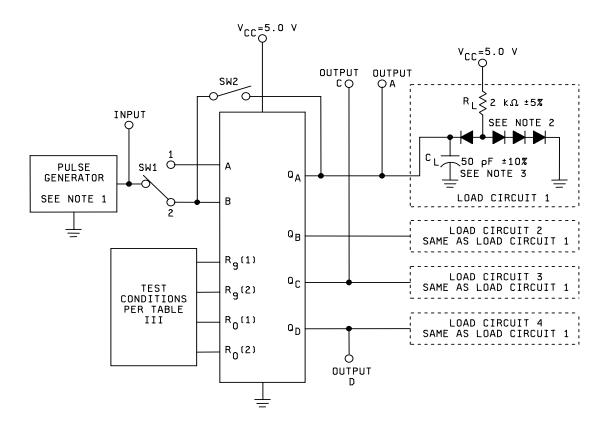


FIGURE 4. Switching time test circuit and waveforms for device type 01.



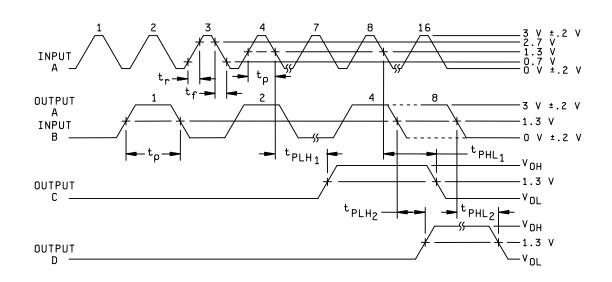
TEST	SWITCH POSITION							
	SW1	SW2						
F MAX	1	CLOSED						
A TO Q <sub>C</sub>	1	CLOSED						
B TO Q <sub>D</sub>	2	OPEN						

# TEST CIRCUIT

## NOTES:

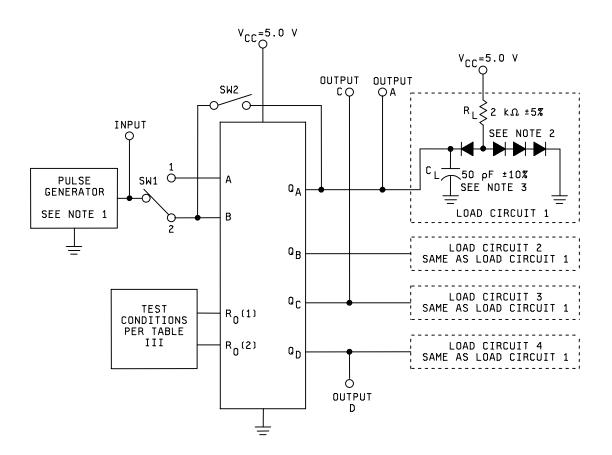
- 1. The pulse generator has the following characteristics:  $\,V_{gen}$  = 3 V,  $t_r \leq$  15 ns,
- $t_f \leq 6 \text{ ns, } t_p \texttt{=} .5 \ \mu \texttt{s, } \mathsf{PRR} \leq 1 \ \mathsf{MHz, } Z_{\mathsf{out}} \ \approx \ 50 \Omega.$
- 2. All diodes are 1N3064 or equivalent.
- 3.  $C_L$  includes probe and jig capacitance.
- 4. Voltage values are with respect to ground terminal.
- 5.  $F_{MAX}$ :  $t_r = t_f \leq 6 \text{ ns.}$

FIGURE 4. Switching time test circuit and waveforms for device type 01 - Continued.



VOLTAGE WAVEFORMS

FIGURE 5. Switching time test circuit and waveforms for device type 02.



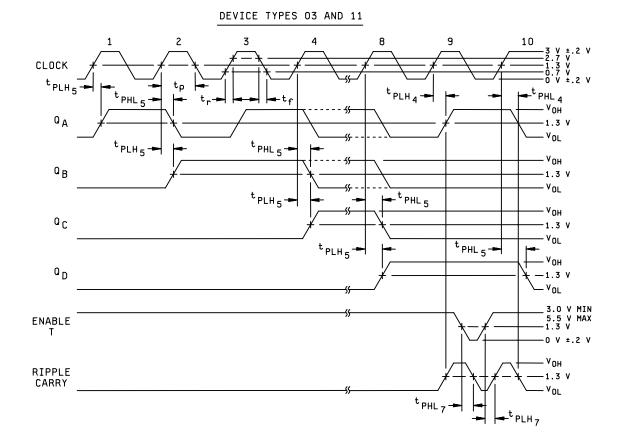
TEST	SWITCH POSITION								
	SW1	SW2							
F MAX	1	CLOSED							
A TO Q <sub>C</sub>	1	CLOSED							
B TO Q <sub>D</sub>	2	OPEN							

**TEST CIRCUIT** 

NOTES:

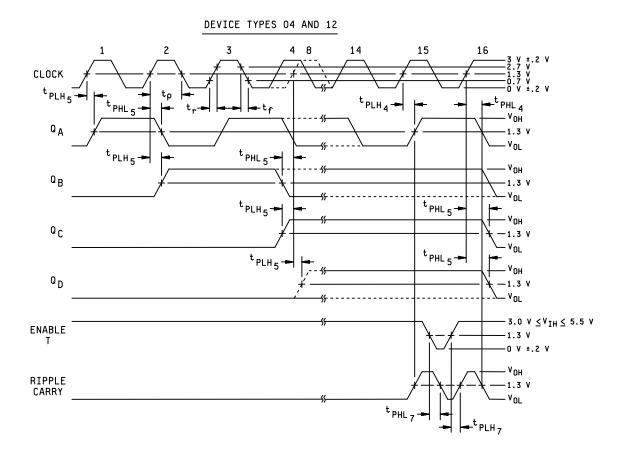
- 1. The pulse generator has the following characteristics:  $V_{gen} = 3 \text{ V}, t_r \le 15 \text{ ns}, t_f \le 6 \text{ ns}, t_p = .5 \ \mu\text{s}, \text{PRR} \le 1 \text{ MHz}, Z_{out} \approx 50\Omega.$
- 2. All diodes are 1N3064 or equivalent.
- 3.  $C_L$  includes probe and jig capacitance.
- 4. Voltage values are with respect to ground terminal.
- 5.  $F_{MAX}$ :  $t_r = t_f \le 6$  ns.

FIGURE 5. Switching time test circuit and waveforms for device type 02 - Continued.



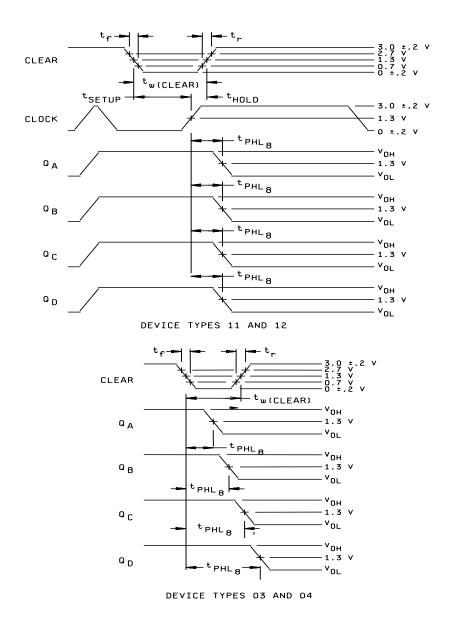
#### VOLTAGE WAVEFORMS

# FIGURE 6. Switching time test circuit and waveforms for device types 03, 04, 11, and 12.



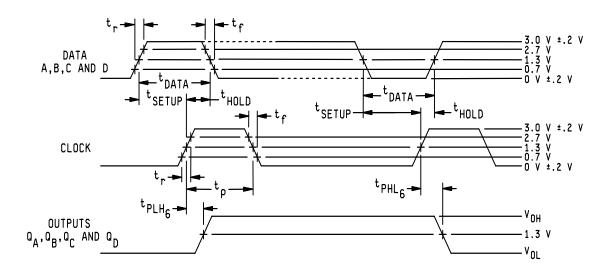
## VOLTAGE WAVEFORMS





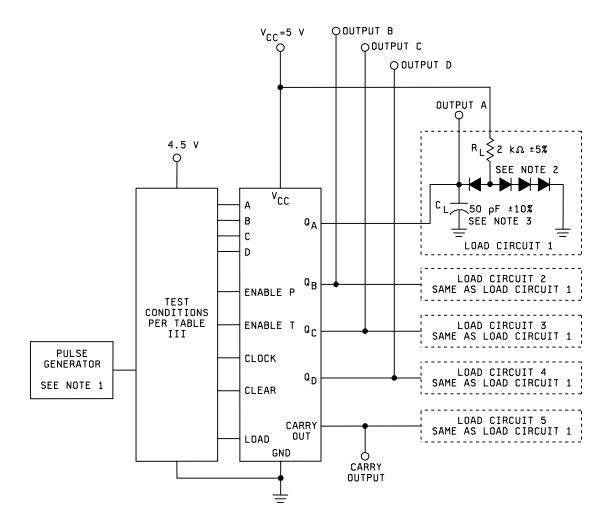
NOTE: The clear pulse generator has the following characteristics:  $V_{gen}$  = 3.0 V,  $t_r \leq 15$  ns,  $t_f \leq 6$  ns, 20 ns  $\leq t_{w(clear)} \leq 25$  ns for types 11 and 12, 20 ns  $\leq t_{setup} \leq 25$  ns,  $t_{hold}$  = 0 ns.

FIGURE 6. Switching time test circuit and waveforms for device types 03, 04, 11, and 12 - Continued.



NOTE: The data pulse generator has the following characteristics: V<sub>gern</sub> = 3.0 V,  $t_r \leq$  15 ns,  $t_f \leq$  6 ns,  $t_{DATA}$  = 30 ns,  $t_{setup}$  = 20 ns,  $t_{HOLD}$  = 10 ns.

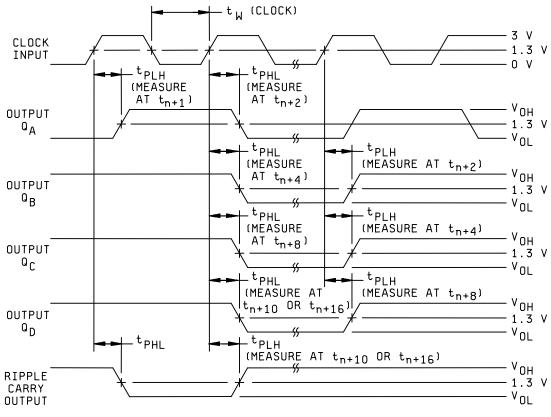
FIGURE 6. Switching time test circuit and waveforms for device types 03, 04, 11, and 12 - Continued.



NOTES:

- 1. The pulse generator has the following characteristics: V<sub>gen</sub> = 3 V, t<sub>r</sub>  $\leq$  15 ns, t<sub>f</sub>  $\leq$  6 ns, t<sub>p</sub> = .5 µs, PRR  $\leq$  1 MHz, Z<sub>out</sub>  $\approx$  50 $\Omega$ .
- 2. All diodes are 1N3064 or equivalent.
- 3.  $C_{L}$  includes probe and jig capacitance.
- 4. Voltage values are with respect to ground terminal.
- 5.  $F_{MAX}$ :  $t_r = t_f \le 6$  ns.

FIGURE 6. Switching time test circuit and waveforms for device type 03, 04, 11, and 12 - Continued.



UP-COUNT VOLTAGE WAVEFORMS

FIGURE 7. Switching time test circuit and waveforms for device types 05 and 06.

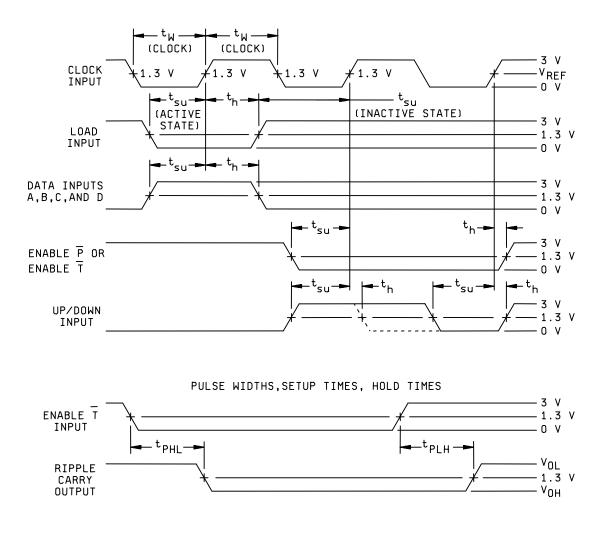
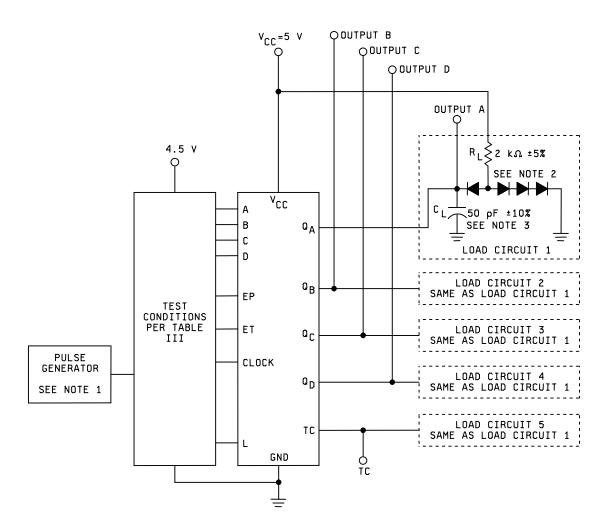


FIGURE 7. Switching time test circuit and waveforms for device types 05 and 06 - Continued.



#### NOTES:

- 1. The pulse generator has the following characteristics: V<sub>gen</sub> = 3 V, t<sub>r</sub> ≤ 15 ns, t<sub>f</sub> ≤ 6 ns, t<sub>p</sub> = .5  $\mu$ s, PRR ≤ 1 MHz, Z<sub>out</sub> ≈ 50 $\Omega$ .
- 2. All diodes are 1N3064 or equivalent.
- 3. C<sub>L</sub> includes probe and jig capacitance.
- 4. Voltage values are with respect to ground terminal.
- 5.  $F_{MAX}$ :  $t_r = t_f \le 6$  ns.
- 6. The clear pulse generator has the following characteristics:  $V_{gen} = 3.0 \text{ V}$ ,  $t_r \le 15 \text{ ns}$ ,  $t_f \le 6 \text{ ns}$ ,  $t_{w(CLEAR)} = 20 \text{ ns}$ .

FIGURE 7. Switching time test circuit and waveforms for device types 05 and 06 - Continued.

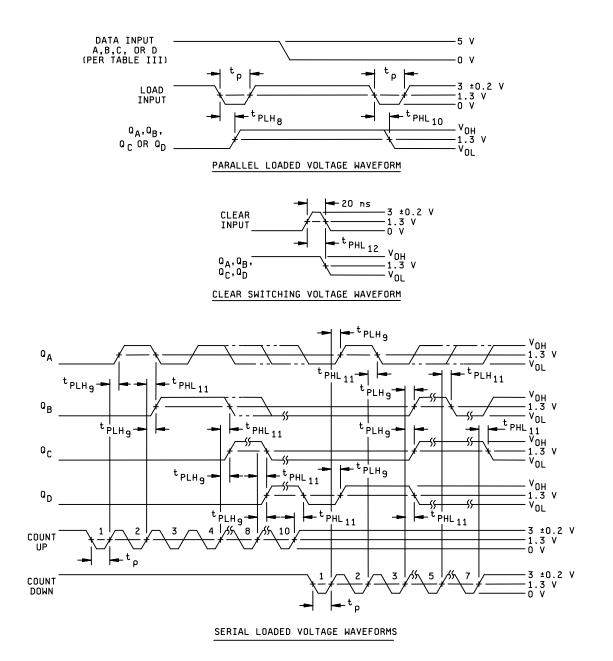
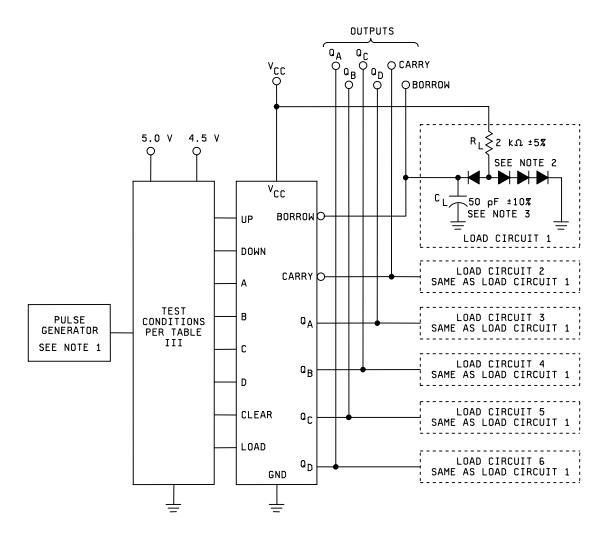


FIGURE 8. Switching time test circuit and waveforms for device types 07.



## NOTES:

- 1. The pulse generator has the following characteristics:  $V_{gen} = 3 V$ ,
- $t_p$  = .5 µs, PRR ≤ 1 MHz,  $Z_{out} \approx 50\Omega$ ,  $t_r \le 15$  ns,  $t_f \le 6$  ns between 0.7 V and 2.7 V.
- 2. All diodes are 1N3064 or equivalent.
- 3.  $C_L$  includes probe and jig capacitance.
- 4. Voltage values are with respect to ground terminal.
- $5. \quad F_{MAX}: \ t_r = t_f \leq 6 \ ns.$
- 6. The clear pulse generator has the following characteristics: V<sub>gen</sub> = 3.0 V,  $t_r \le 15$  ns,  $t_f \le 6$  ns, between 0.7 V and 2.7 V,  $t_{w(CLEAR)} = 20$  ns.

FIGURE 8. Switching time test circuit and waveforms for device types 07 and Continued.

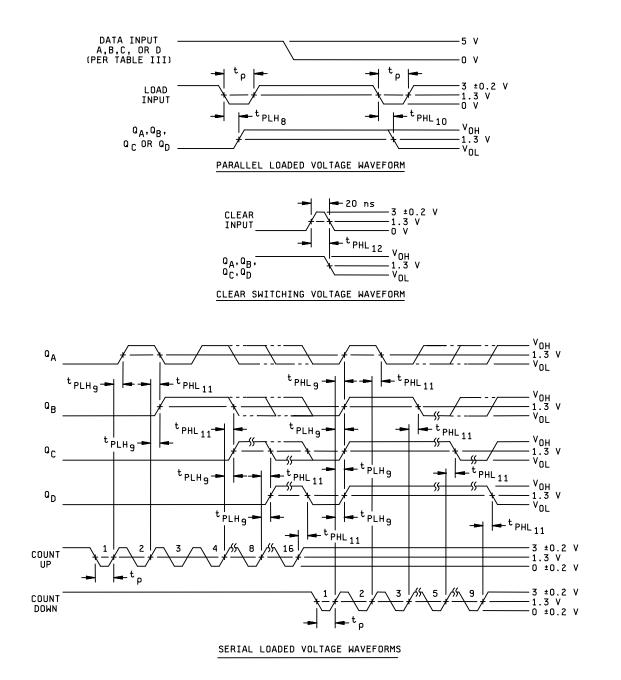
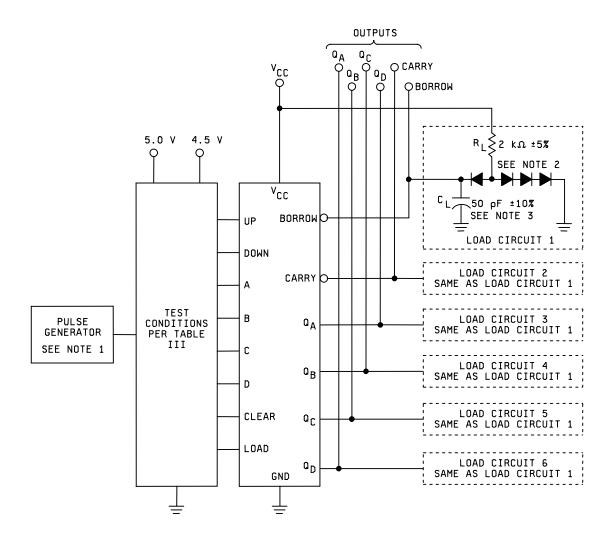


FIGURE 9. Switching time test circuit and waveforms for device type 08.



#### NOTES:

- 1. The load and count pulse generators have the following characteristics:  $V_{gen} = 3 V$ ,  $t_{p} = .5 \ \mu s, \ PRR \leq 1 \ MHz, \ Z_{out} \ \approx \ 50 \Omega, \ t_{r} \leq 15 \ ns, \ t_{f} \leq 6 \ ns \ between \ 0.7 \ V \ and \ 2.7 \ V.$
- 2. All diodes are 1N3064 or equivalent.
- C<sub>L</sub> includes probe and jig capacitance.
   Voltage values are with respect to ground terminal.
- 5.  $F_{MAX}$ :  $t_r = t_f \le 6$  ns.
- 6. The clear pulse generator has the following characteristics:  $V_{gen} = 3.0 V$ ,
  - $t_r \leq$  15 ns,  $t_f \leq$  6 ns, between 0.7 V and 2.7 V,  $t_{w(CLEAR)}$  = 20 ns.

FIGURE 9. Switching time test circuit and waveforms for device type 08 - Continued.

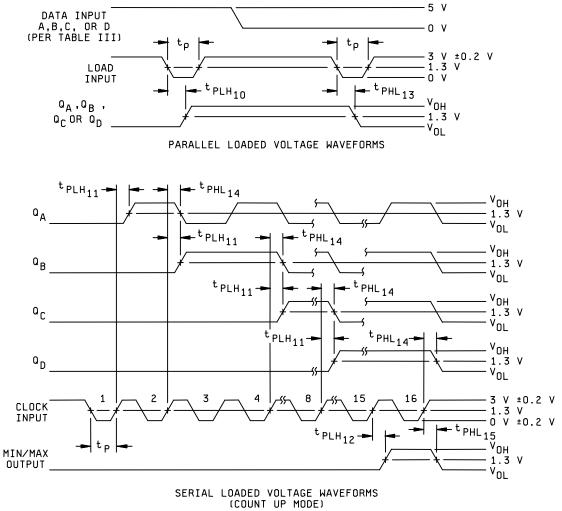
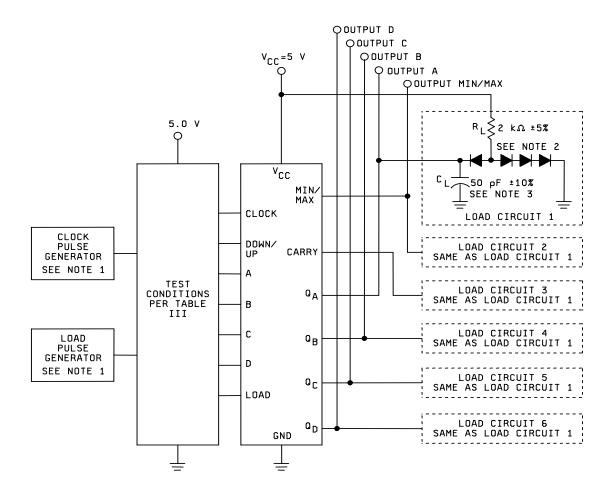


FIGURE 10. Switching time test circuit and waveforms for device type 09.

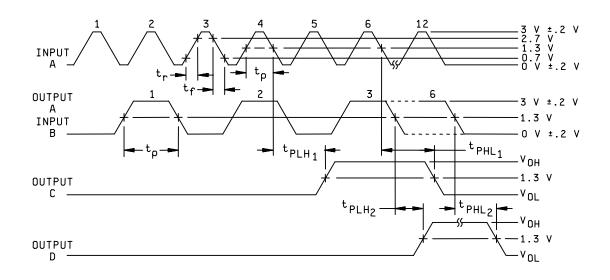


#### **TEST CIRCUIT**

#### NOTES:

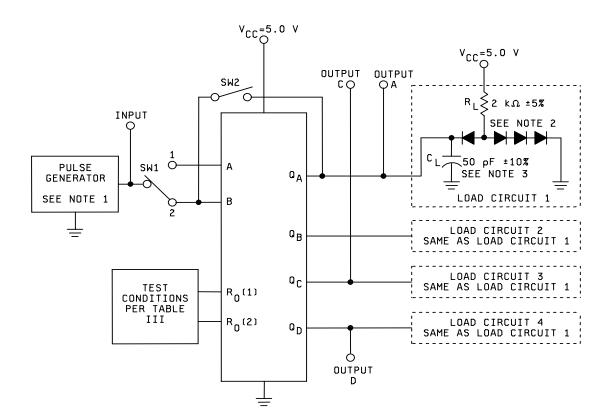
- 1. The pulse generator has the following characteristics:  $V_{gen} = 3 V$ ,
- $t_p = .5 \ \mu\text{s}, \ \text{PRR} \le 1 \ \text{MHz}, \ Z_{out} \ \approx \ 50\Omega, \ t_r \le 15 \ \text{ns}, \ t_f \le 6 \ \text{ns} \ \text{between 0.7 V and 2.7 V}.$
- 2. All diodes are 1N3064 or equivalent.
- C<sub>L</sub> includes probe and jig capacitance.
   Voltage values are with respect to ground terminal.
- 5.  $F_{MAX}$ :  $t_r = t_f \le 6$  ns.

FIGURE 10. Switching time test circuit and waveforms for device type 09 - Continued.



VOLTAGE WAVEFORMS

FIGURE 11. Switching time test circuit and waveforms for device type 10.



TEST	SWITCH POSITION							
	SW1	SW2						
F MAX	1	CLOSED						
A TO Q <sub>C</sub>	1	CLOSED						
B TO Q <sub>D</sub>	2	OPEN						

**TEST CIRCUIT** 

NOTES:

- 1. The pulse generator has the following characteristics:  $V_{gen}$  = 3 V,  $t_r \le$  15 ns,
- $t_{f} \leq 6 \text{ ns}, \, t_{p} = .5 \; \mu \text{s}, \, \text{PRR} \leq 1 \; \text{MHz}, \, Z_{out} \; \approx \; 50 \Omega.$
- 2. All diodes are 1N3064 or equivalent.

FIGURE 11. Switching time test circuit and waveforms for device type 10 - Continued.

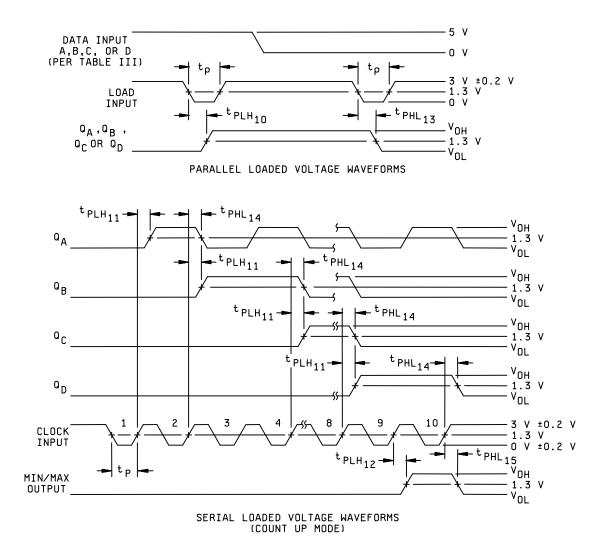
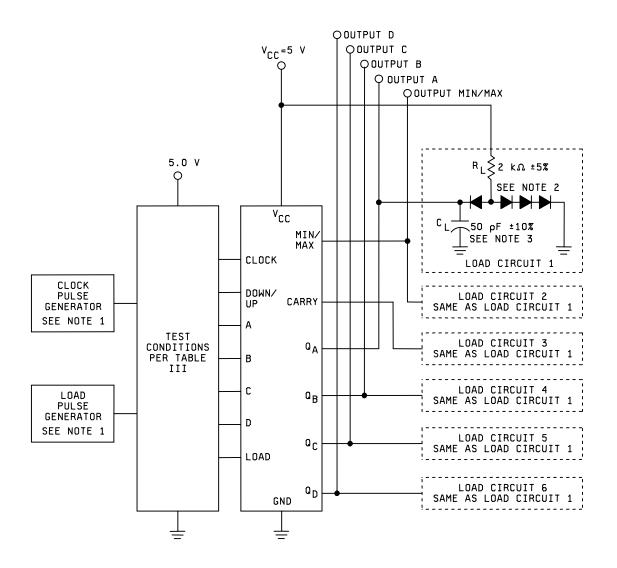


FIGURE 12. Switching time test circuit and waveforms for device type 13.



NOTES:

- 1. The pulse generator have the following characteristics:  $V_{gen} = 3 V$ ,
- $t_p = .5 \ \mu s$ , PRR  $\le 1 \ MHz$ ,  $Z_{out} \approx 50\Omega$ ,  $t_r \le 15 \ ns$ ,  $t_f \le 6 \ ns$ , between 0.7 V and 2.7 V.
- 2. All diodes are 1N3064 or equivalent.
- 3.  $C_L$  includes probe and jig capacitance.
- 4. Voltage values are with respect to ground terminal.
- 5.  $F_{MAX}$ :  $t_r = t_f \le 6$  ns.

Figure 12. Switching time test circuit and waveforms for device type 13 - Continued.

											hay be H										
		MIL-STD- 883	Cases A,B,C,D	1	2	3	4	5	6	7	8	9	10	11	12	13	14		Lir	nits	
Subgroup	Symbol	method	Cases <u>1</u> / 2	2	3	4	6	8	9	10	12	13	14	16	18	19	20	Measured			Unit
			Test no.	В	R <sub>0</sub> (1)	R <sub>0</sub> (2)	NC	V <sub>CC</sub>	R9(1)	R9(2)	Q <sub>C</sub>	Q <sub>B</sub>	GND	QD	Q <sub>A</sub>	NC	Α	terminal	Min	Max	
1	Vol	3007	1	2.0 V	2.0 V	2.0 V		4.5 V	GND	GND	4mÅ		GND				GND	Q <sub>C</sub>		0.4	V
Tc = 25°C			2	"	"	"		"	GND	GND		4 mA	"				"	Q <sub>B</sub>		=	"
			3	"	"	"		"	2.0 V	0.7 V			"	4 mA			"	Q <sub>D</sub>		=	"
			4	GND	"	"		"	0.7 V	2.0 V			"		<u>2</u> /		2.0 V	Q <sub>A</sub>		"	"
			5	2.0 V	-	0.7 V		-	2.0 V	"	4 mA		-				GND	Q <sub>c</sub>		=	
		"	6	2.0 V	0.7 V	2.0 V			"	"		4 mA					"	Q <sub>B</sub>		=	"
	V <sub>OH</sub>	3006	7	2.0 V	2.0 V	0.7 V		"	"	"			"	-0.4 mA			"	Q <sub>D</sub>	2.5		"
		"	8	GND	0.7 V	2.0 V		"	"	"			"		-0.4 mA		2.0 V	Q <sub>A</sub>			"
			9	2.0 V	"	0.7 V		"	"	"			-	-0.4 mA			GND	QD	"		"
			10	GND	"	0.7 V		"	"	"					-0.4 mA		2.0 V	Q <sub>A</sub>	"		"
			11	<u>3/ 4/</u>	<u>3</u> /	<u>3/</u>		"	0.7 V	0.7 V	-0.4 mA						GND	Q <sub>C</sub>			
			12	<u>3/ 5</u> /	<u>3</u> /	<u>3/</u>			0.7 V	0.7 V		-0.4 mA	"				GND	Q <sub>B</sub>	"	0/	
	I <sub>IL1</sub>	3009	13		0.4 V	5.5 V		5.5 V										R <sub>0</sub> (1)	<u>6</u> /	<u>6/</u>	mA "
			14 15		5.5 V	0.4 V			0.4 V	5.5 V								R <sub>0</sub> (2) R9(1)			
			15						0.4 V 5.5 V	0.4 V								R9(1) R9(2)		"	
									5.5 V <u>3</u> /	<u>0.4 v</u> <u>3</u> /		-		-							
	I <sub>IL2</sub>		17		GND	GND		"									0.4 V	A	"	"	"
	I <sub>IL3</sub>		18	0.4 V	GND	GND		"	<u>3</u> /	<u>3</u> /			"					В	-	-	"
	VIC		19					4.5 V	-18 mA				"					R9(1)		-1.5	V
			20					"		-18 mA			"					R9(2)		-	"
			21					"					"				-18 mA	A		-	"
			22	-18 mA									"					B			
			23		-18 mA	10.1												R <sub>0</sub> (1)			
			24			-18 mA			0.714									R <sub>0</sub> (2)			
	I <sub>IH1</sub>	3010	25					5.5 V	2.7 V	0714								R9(1)		20	μA
		"	26		071/					2.7 V								R9(2)			
		"	27 28		2.7 V	2.7 V							"					R <sub>0</sub> (1)			
	1	**	28			2.7 V			5.5 V									R <sub>0</sub> (2) R9(1)		100	
	I <sub>IH2</sub>	**	30						5.5 V	5.5 V								R9(1)		100	
		**	30		5.5 V					5.5 V								R <sub>0</sub> (1)			
		"	32		5.5 V	5.5 V		"										$R_0(1)$		"	"
		**	33			5.5 V							"				2.7 V	A		80	
	I <sub>IH3</sub>	66																			
	I <sub>IH4</sub>		34					"					"				5.5 V	A		400	
	I <sub>IH5</sub>		35	2.7 V				"					"					В		160	"
	I <sub>IH6</sub>	£5	36	5.5 V				"					"					В		800	**

TABLE III. Group A inspection for device type 01. Terminal conditions (pins not designated may be  $H \ge 2.0 \text{ V}$ ; or  $L \le 0.7 \text{ V}$ ; or open).

See footnotes at end of device types 01.

Subport         Mile of biology         As construint of biology         Note of b							Termir	al condition	is (pins not	designated	I may be H 2	≥ 2.0 V or L	≤ 0.7 V or 0	open).								
Singo     Nime     Nime     Case of point     Nime     Ni				Cases A.B.C.D	1	2	3	4	5	6	7	8	9	10	11	12	13	14	Measured	Lim	its	Unit
Image: constraint of the second sec	Subgroup	Symbol		Cases 1/	2	3	4	6	8	9	10	12	13	14	16	18	19	20				
1         1/2         0/10         0/1					В	$B_0(1)$	R <sub>0</sub> (2)	NC	Vcc	R9(1)	R9(2)	Qc	Qn	GND	Qn	QA	NC	Α		Min	Max	1
Tc - 2/C         I<	1	los						-				0	0				-		Qn			
Image: standard of the		05	"											"	-	GND					"	
Image: constraint of the set of			"		3/5/				"				GND	"		-		GND			"	
cc         cc<					3/ 4/				"			GND		"				"			"	
1       Same tests, tormal conditions, and timits as for subjuct 1, except 1		Icc		41	GND														V <sub>cc</sub>		15	
Transmit         3014         4.2         A.V         A.V         4.5 Y         A.         A.         L         L         GNO         H <td>2</td> <td>Same tests,</td> <td>terminal condi</td> <td>tions, and limits</td> <td>as for sub</td> <td>group 1, e</td> <td>except T<sub>C</sub> =</td> <td>125°C and</td> <td>V<sub>IC</sub> tests are</td> <td>e omitted.</td> <td></td>	2	Same tests,	terminal condi	tions, and limits	as for sub	group 1, e	except T <sub>C</sub> =	125°C and	V <sub>IC</sub> tests are	e omitted.												
India         · <td>3</td> <td>Same tests,</td> <td>terminal condi</td> <td>tions, and limits</td> <td>as for sub</td> <td>group 1, e</td> <td>except T<sub>C</sub> =</td> <td>-55°C and \</td> <td>/<sub>IC</sub> tests are</td> <td>omitted.</td> <td></td>	3	Same tests,	terminal condi	tions, and limits	as for sub	group 1, e	except T <sub>C</sub> =	-55°C and \	/ <sub>IC</sub> tests are	omitted.												
tesh         ·							A <u>8</u> /		4.5 V				L									
Image: Display of the second secon	$T_{C} = +25^{\circ}C$						"		"				"	"							1	
-       446       B       B       -       A       -       -       -       H							"						"	"							1	1
		<u>Z</u> /	"																		1	1
-     48     A     A     ·     ·     ·     B     · </td <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td> </td> <td></td> <td>1</td> <td></td>																					1	
-       400       A       A       -       -       B       -							A			В					L						1	
-       500       A       A       -																						
*     51     B     A     * </td <td></td> <td>A "</td> <td></td>											A "											
-       52       A       B       -							"						"									
*       53       B       B       *							"															
·         ·			"				"				"	"	н			"						
*     55     B     *     *     *     *     H     L     *     *     *       *     56     A     *     *     *     *     *     *     *     *     *     *       *     57     B     *     *     *     *     *     *     *     *     *     *     *       *     58     A     *     *     *     *     *     *     H     *     *     *     *       *     60     A     *     *     *     *     *     *     H     *     *     *     *       *     61     B     * <t< td=""><td></td><td></td><td>"</td><td></td><td></td><td></td><td>"</td><td></td><td></td><td></td><td>"</td><td></td><td></td><td></td><td></td><td>"</td><td></td><td></td><td></td><td></td><td></td><td></td></t<>			"				"				"					"						
			"				"		"		"	Н		"	"	"						
*     57     B     * </td <td></td> <td></td> <td>"</td> <td>56</td> <td>A</td> <td>"</td> <td>"</td> <td></td> <td>"</td> <td></td> <td>"</td> <td></td> <td>L</td> <td>"</td> <td>"</td> <td>"</td> <td></td> <td></td> <td>See <u>9</u>/</td> <td></td> <td></td> <td></td>			"	56	A	"	"		"		"		L	"	"	"			See <u>9</u> /			
*       59       B       *       *       *       *       L       L       H       *       *         *       60       A       * <td></td> <td></td> <td>"</td> <td>57</td> <td>В</td> <td></td> <td>"</td> <td></td> <td>"</td> <td></td> <td>"</td> <td>"</td> <td>Н</td> <td>"</td> <td>"</td> <td>"</td> <td></td> <td>"</td> <td>_</td> <td></td> <td></td> <td></td>			"	57	В		"		"		"	"	Н	"	"	"		"	_			
*       60       A       *       *       *       *       *       *       *       H       *         *       62       B       *       B       *       *       B       *       *       B       * <td></td> <td></td> <td>"</td> <td></td> <td></td> <td></td> <td>"</td> <td></td> <td></td> <td></td> <td>-</td> <td>-</td> <td>Н</td> <td></td> <td>-</td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td>			"				"				-	-	Н		-							
**       61       B       *							"															
**       62       B       *       *       B       *			"				"		"				"			"						
*       63       A       *							"		"		"		"		L	"						
000       R       A       *       R       *							В				B											
**       65       A       *																						
						A "	"															
**       67       A       **							"					Ц										
**       68       B       **			"				"															
"       69       A       "			"				"				"	"				"						
"       70       B       "       "       "       "       "       L       L       "       H       "         "       71       A       " <td></td> <td></td> <td>"</td> <td></td> <td></td> <td></td> <td>"</td> <td></td> <td>"</td> <td></td> <td>"</td> <td></td> <td></td> <td></td> <td>"</td> <td>"</td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td>			"				"		"		"				"	"						
"       71       A       "			"				"		"		"	L			Н							
"       72       B       "			"				"		"		"			"		"						
"       74       A       B       "			"				"		"		"		"	"		"						
1       1			"	73	В	В	"		"	В	"			"		"		"				
"       76       A       "			"			В	"		"		"	-	-		"	"		"				
"       77       B       "       "       "       "       H       L       "       "       "       "         "       78       A       "       "       "       "       "       L       "       "       "       "         "       78       A       "       "       "       "       "       L       "       "       "       "       "         "       79       B       "       "       "       "       H       " <td< td=""><td></td><td></td><td>"</td><td></td><td>В</td><td>А</td><td>"</td><td></td><td></td><td></td><td>A</td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td></td<>			"		В	А	"				A											
"       78       A       "			"				"		"						"	"						
100       1			"				"		"			Н			"							
1       1							"														1	
"     81     B     B     "     "     A     "     "     "     "     "       "     82     A     "     "     "     "     "     "     "     "     "       "     82     A     "     "     "     "     "     "     "     "     "       "     83     B     "     "     "     "     "     "     "     "       "     84     A     "     "     "     "     "     "     "     "																					1	1
"         82         A         "						_	A					L	L								1	
"83         B         "						B		<u> </u>		A											1	1
"84         A         "																					1	
04 A П																					1	
			"	84	B		"					Н	H L								1	

### TABLE III. Group A inspection for device type 01 - Continued

See footnotes at end of device type 01.

											≥ 2.0 V or L										
			Cases A,B,C,D	1	2	3	4	5	6	7	8	9	10	11	12	13	14	Moogurod	Lim	its	Unit
Subgroup	Symbol	MIL-STD-	Cases 1/	2	3	4	6	8	9	10	12	13	14	16	18	19	20	Measured terminal			
		883 mothod	2 Toot no	D	B (1)	P (2)	NC	V	P0(1)	P0(2)	0	0	CND	0	0	NC	٨		Min	Max	4
7	E	3014         88         A         4.5V         A         B         H         L         GND         L	wax																		
7	Func-	3014			<u>в 8</u> /			4.5 V	A				GND				B				
$T_C = +25^{\circ}C$	tional											Н									
	tests											L									
	<u>7</u> /	"		"	"				"	В	"						"				
	··         ··<																				
"         96         A         "		"		"																	
	н н н н н н н н н н н н н н н н н н н	97	В	"	"			"			Н					"					
		"	98	Α	"	"			"			Н		"	"		"				
		"	99	В	А	A					L	L									
		"	100						"	"				"	"		"	See 9/			
		"			"	"		"	"	"	"	"		"	"		"				
	1	"			"	"	1	"	"	"	"	Н		"	"		"		1	1	1
		"				"															
	"     100     B     B     B       "     101     A     "     "       "     102     B     "     "       "     103     A     "     "       "     103     A     "     "       "     104     B     "     "       "     105     A     "     "       "     106     B     "     "       "     107     A     "     "       "     108     A     "     "       "     109     B     "     "       "     108     A     "     "					н				"		"									
		-         -																			
		"	·         ·																		
		"																			
		"																			
		see         1         88         A         '         B         '         '         A         L         L         '         H         H           1         88         -         A         A         A         A         -         B         -         -         H <td></td> <td></td>																			
				"																	
				"		В															
		"		"		"			"												
				"	"	"			"	-											
				"	"	"				-											
		"		"																	
		"	125	"	A	A			"	A	"		"	"	"	H B * A * B * A					
8	Same tests,	terminal condit	tions, and limits	as for sub	group 7, e	except T <sub>C</sub> =	125°C and ·	-55°C.									A B B IN <u>10</u> / A to Q <sub>A</sub> 29				
9	F <sub>MAX</sub>		126		GND			5.0 V	GND				GND		OUT		IN <u>10</u> /	A to Q <sub>A</sub>	29		MHz
$T_{C} = +25^{\circ}C$	1											]									
	t <sub>PLH1</sub>	"	127		<u>11/</u>	A <u>8</u> /	]	"	"	]	OUT	]			IN A to Q <sub>C</sub> 3 IN A to Q <sub>C</sub> "	3	53	ns			
	t <sub>PHL1</sub>	"	128	GND         "         OUT         "         IN         A to Q_C         "           IN         11/         A         "         "         "         OUT         B to Q_D         "	58																
	t <sub>PLH2</sub>	"	128         GND         III         A to Q_c           "         129         IN         11/         A         "         "         U         B to Q_c         "           "         130         IN         GND         "         "         U         B to Q_c         "																		
	t <sub>PHL2</sub>	"			GND		1	"	"         OUT         B to Q <sub>D</sub> "         3           "         OUT         B to Q <sub>D</sub> "         44												
10	_	"	130 IN GND " " OUT B to Q <sub>D</sub> " 4		MHz																
T <sub>C</sub> = +125°C	$\begin{array}{c c c c c c c c c c c c c c c c c c c $																				
		3	74	ns																	
		"	133		GND		1	"	"	1	OUT	1					IN	A to Q <sub>C</sub>	"	81	
	t <sub>PLH1</sub> t <sub>PHL1</sub>			IN		Δ	1			1	-	1							"	52	
			134		11/																
	IpHi1         "         133         GND         "         "         OUT         "         IN         A to Q_C         "         a           IpHi1         "         134         IN         11/         A         "         "         "         U         "         U         B to Q_D         "         4	56	"																		

# TABLE III. <u>Group A inspection for device type 01</u> - Continued Terminal conditions (pins not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open).

See footnotes at end of device type 01.

- 1/ Case 2 pins not referenced are N/C.
- 2/ Test 4, Pin 12; 4 mA + I<sub>IL3(MAX).</sub>
- 3/ Apply 4.5 V pulse then ground prior to taking measurements to set device in the desired state.
- $\underline{4}$  Apply two pulses after R<sub>0</sub> (reset) pulse.
- $\underline{5}$ / Apply one pulse after R<sub>o</sub> (reset) pulse.
- <u>6/</u> I<sub>IL</sub> limits (mA) min/max values for circuits shown:

Parameter	Terminals				Circuits			
		А	В	С	D	E	F	G
I <sub>IL1</sub>	R <sub>0</sub> (1)	-12/36	03/40		03/40	-12/36	-12/36	
	R <sub>0</sub> (2)	"	"		"	"	"	
	R9(1)	"	"		"	"	"	
	R9(2)	"	н		"	"	"	
I <sub>IL2</sub>	А	-0.5/-2.0	-1.0/-2.4		-1.0/-2.4	-1.0/-2.4	-0.5/-2.0	
I <sub>IL3</sub>	В	-0.4/-1.6	-1.3/-3.2		-1.3/-3.2	-1.3/-3.2	-1.0/-2.4	

7/ Only a summary of attributes data is required.

- <u>8</u>/ A = 3.0 V minimum, B = 0.0 V or GND.
- <u>9</u>/ H > 1.5 V; L < 1.5 V.
- $\underline{10}$ /  $F_{MAX}$  minimum limit specified is the frequency of the input pulse. The output pulse shall be one-half of the input frequency.
- 11/ Momentary 3.0 V (min), then ground. Maintain ground for measurement.

Symbol V <sub>oL</sub> V <sub>oн</sub>	MIL-STD- 883 method 3007 " " " " " 3006	A,B,C,D Cases <u>1</u> / 2 Test no. 1 2 3	2 B GND 2.0 V	3 R <sub>0</sub> (1) 2.0 V	4 R <sub>0</sub> (2) 2.0 V	6 NC	8 V <sub>cc</sub>	9	10	12	13	14	16	18	19	20	Measured terminal			Unit
	3007 " "	Test no. 1 2 3	GND			NC	Vcc	NO												1
	"	1 2 3						NC	NC	Q <sub>C</sub>	Q <sub>B</sub>	GND	QD	Q <sub>A</sub>	NC	Α		Min	Max	1
V <sub>OH</sub>	"	3	2.0 V				4.5 V					GND	-	2/		2.0 V	Q <sub>A</sub>		0.4	V
V <sub>OH</sub>	"			"	"		"				4 mA	"		-		GND	Q <sub>B</sub>		"	"
V <sub>OH</sub>			"	"	"		"			4mA		"				"	Q <sub>C</sub>		"	"
V <sub>OH</sub>	3006	4	"	"			-					"	4 mA			"	QD		"	-
		5	GND	<u>3</u> /	<u>3</u> /		"					"		-0.4 mA		<u>3/ 4</u> /	Q <sub>A</sub>	2.5		
		6	<u>3/ 4/</u>	<u>3</u> /	"		"				-0.4 mA	"				GND	Q <sub>B</sub>	"		"
	"	7	<u>3/ 5/</u>	"	"		"			-0.4 mA		"				"	Qc	"		
	"	8	<u>3/ 6</u> /	"	"		"					"	-0.4 mA			"	QD	"		"
VIC		9	10 1													-18 mA	A		-1.5 mA	
		10 11	-18 mA	-18 mA													B R <sub>0</sub> (1)		"	
				-18 MA	10 m A							"					$R_0(1)$		"	
h	3000			0.4.V			55V					"						7/	7/	mA
UL1	"						3.3 V					"						"	"	"
I <sub>IL2</sub>				<u>3/</u>	<u>3/</u>		"					"				0.4 V		"	"	"
	"		041	3/	<u>3</u> /							"						"		
	3010	-	0.4 V	27V	GND							"							20	μA
	"						"					"								μ/
	"						"					"								"
I <sub>IH2</sub>	"						"					"								"
I <sub>IH3</sub>	"	21		5.5 V	"		"					"				2.7 V	A		80	"
I <sub>IH4</sub>		22		"	"		"					"				5.5 V	А		400	
I <sub>IH5</sub>	"	23	2.7 V	"	"		"					"					В		80	"
I <sub>IH6</sub>	"	24	5.5 V	"	"		"					"					В		400	
l	2011			2/	2/							"		GND		2/ 1/	0.	15		m/
IOS	3011			<u>-3/</u> "	<u>-5/</u> "						GND	"		GND				-15	-100	"
	"			"	"		"			GND	OND	"				"		"	"	"
	"			"	"		"			0.10		"	GND			"		"	"	"
Icc	3005	29	GND				"					"	0				V <sub>cc</sub>		15	"
	III.3 III.1 III.2 III.2 III.3 III.4 III.4 III.6 II.6 II.6	"           IL2         "           IL3         "           IH1         3010           IH1         "           IH2         "           IH2         "           IH3         "           IH4         "           IH5         "           IH6         "           IN6         "           IN6         "	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$								

TABLE III. Group A inspection for device type 02. Terminal conditions (pins not designated may be  $H \ge 2.0$  V; or  $L \le 0.7$  V; or open).

See footnotes at end of device types 02.

				1						may be H						r		-	r		
			Cases A,B,C,D	1	2	3	4	5	6	7	8	9	10	11	12	13	14	Measured	Lim	its	Unit
Subgroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	6	8	9	10	12	13	14	16	18	19	20	terminal			
		method	Test no.	В	R <sub>0</sub> (1)	R <sub>0</sub> (2)	NC	V <sub>cc</sub>	NC	NC	Q <sub>C</sub>	Q <sub>B</sub>	GND	Q <sub>D</sub>	Q <sub>A</sub>	NC	Α		Min	Max	
7	Func-	3014	30	B <u>9</u> /	A <u>9</u> /	A		4.5 V			L	L	GND	L	L		В <u>9</u> /				
Tc = 25°C	tional	"	31	A		"										-					
10 - 20 0	tests	"	32	В		"															
	<u>8</u> /	"	33	B		В										-					j l
	<u>o</u> ,	"	34	A		"															j l
		"	35	В		"						Н			"	-					1
		"	36	"		A						L			"	-					1
		"	37	"	В	"										-					1
		"	38	A		"										-					1
		"	39	A		В										-					1
		"	40	В		"						Н				-					1
		"	41	A		"						H			"						1
		"	42	В		"					Н	L			"						1
		"	43	A		"						L			"		"				1
		"	44	В		"	1	"	1		"	H		"	"	1				1	
		"	45	Α		"						Н		"	"		"				1
		"	46	В		"					L	L		Н	"						1
		"	47	A		"					"	L		"	"		"				
		"	48	В		"						Н			"		"	See 10/			
		"	49	А		"						Н			"		"				
		"	50	В		"					Н	L									
		"	51	А		"						L									
		"	52	В		"						Н		-							
		"	53	A		"					"	Н		"	"						
		"	54	В		"					L	L		L	"		"				
		"	55	A		"						L				_					
			56	В		"					"	Н		"		_					1
			57	A								Н									
			58	В			-				H	L				-					
			59	A			-									_					
			60	B								Н				-					
			61	AB		"						H				-					
		"	62 63	A		"	-		-		L	L		H		-					1
		"	64	B		"	-		-			H									1
		"	65	B	A	"			-							-					
		"	66	A	"	"										-					1
		"	67	В		"					Н	L				-					1
		"	68	A		"					"	L		"	"	-					
		"	69	В		"						H			"						
		"	70	Ā		"						H		"	"						
		"	71	Α		Α					L	L		L	"		"				
		"	72	В		A					"	"		"							
		"	73	"	В	В									"		Α				1
		"	74	"		"					"			"	Н		В				
		"	75	"		"					"			"	Н		Α				
		"	76	"	"	"							"		L		В				
8	Same tests,	terminal condi	tions, and limits	as for sub	ogroup 7, e	except T <sub>C</sub> =	+125°C and	I-55°C.													
9 T <sub>C</sub> = +25°C	F <sub>MAX</sub>	3003 (Fig. 5)	77		GND			5.0 V					GND		OUT		IN <u>11</u> /	A to Q <sub>A</sub>	29		MHz
1C - 723 C	t <sub>PLH1</sub>	(119.0)	78		<u>12/</u>	A <u>9</u> /	1		1		OUT					1	IN	A to Q <sub>C</sub>	3	53	ns
	t <sub>PHI 1</sub>	"	78		GND	<u> </u>	1		1		OUT		"			1	IN	A to Q <sub>C</sub>	- 3	58	"
	t <sub>PLH2</sub>	"	80	IN	<u>12/</u>	A	1		1			<u> </u>	"	OUT	1	1		B to Q <sub>D</sub>		56	
	t <sub>PHL1</sub>	"	81	IN	GND		1	"	1		-		"	OUT	1	1		B to Q <sub>D</sub>		56	
L	*PHL1				00		1						1			1	1		1	~~	لــــــــــــــــــــــــــــــــــــــ

# TABLE III. <u>Group A inspection for device type 02</u> - Continued Terminal conditions (pins not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open).

See footnotes at end of device type 02.

## TABLE III. <u>Group A inspection for device type 02</u> - Continued

			Cases	- 1	2	erminal co	4	E	6	7	8	0	10	11	12	10	14		Lim	ito	Unit
			A,B,C,D	1	2	3	4	5	0	1	0	9	10	11	12	13	14	Measured	LIII	115	Unit
Subgroup	Symbol	MIL-STD- 883	, , ,	2	3	4	6	8	9	10	12	13	14	16	18	19	20	terminal			
		method	Test no.	В	R <sub>0</sub> (1)	R <sub>0</sub> (2)	NC	V <sub>cc</sub>	NC	NC	Q <sub>C</sub>	Q <sub>B</sub>	GND	Q <sub>D</sub>	Q <sub>A</sub>	NC	Α		Min	Max	1
10	F <sub>MAX</sub>	3003	82		GND			5.0 V					GND		OUT		IN <u>11</u> /	A to Q <sub>A</sub>	29		MHz
$T_{C} = +125^{\circ}C$		(Fig. 5)																			
	t <sub>PLH1</sub>	"	83		<u>12</u> /	Α		"			OUT		"				IN	A to Q <sub>C</sub>	3	74	ns
	t <sub>PHL1</sub>	"	84		GND			"			OUT		"				IN	A to Q <sub>C</sub>	=	81	"
	t <sub>PLH2</sub>	"	85	IN	<u>12</u> /	A		"					"	OUT				B to Q <sub>D</sub>	=	78	"
	t <sub>PHL2</sub>	"	86	IN	GND			"					"	OUT				B to Q <sub>D</sub>		78	"
11	Same test	s, terminal c	onditions, an	d limits a	as for sub	ogroup 10	except, T	<sub>c</sub> = 55°C													

1/ Case 2 pins not referenced are N/C.

<u>2</u>/ For test 1, 4 mA +I<sub>IL3</sub> (max).

78

- $\underline{3}/$  Apply 4.5 V pulse, then ground prior to taking measurements to set device in the desired state. Maintain ground for measurement.
- $\underline{4}$  Input pulse must be applied one time after R<sub>0</sub> pulse.
- 5/ Input pulse must be applied twice after R<sub>0</sub> pulse.
- $\underline{6}$  Input pulse must be applied four times after R<sub>0</sub> pulse.
- $\underline{7}$ / I<sub>IL</sub> limits (mA) min/max values for circuits shown:

Parameter	Terminals				Circuits			
		A	В	С	D	E	F	G
I <sub>IL1</sub>	R <sub>0</sub> (1)	-12/36	03/40	-12/36	03/40	-12/36	-12/36	
	R <sub>0</sub> (2)	"	"	"	"	"	"	
I <sub>IL2</sub>	А	-0.5/-2.0	-1.0/-2.4	-0.5/-2.0	-1.0/-2.4	-1.0/-2.4	-0.5/-2.0	
I <sub>IL3</sub>	В	-0.4/-1.6	-0.4/-1.6	-0.4/-1.6	-0.4/-1.6	65/-1.6	-0.4/-1.6	

Te

#### 8/ Only a summary of attributes data is required.

 $\underline{9}$ / A = 3.0 V minimum; B = 0.0 V or GND.

<u>10</u>/ H > 1.5 V; L < 1.5 V.

- $\underline{11}/\,$  F\_{MAX} min limit specified is the frequency of the input pulse. The output frequency shall be one-half the input frequency.
- 12/ Momentary 3.0 V (min), then ground. Maintain ground for measurement.

	1		Cases E, F	1	2	3	4	5	6	not desig	nated ma	ybeH≥2 9	10 V; 01 L :	<u>≤ 0.7 V; 0</u> 11	12	13	14	15	16	r	1.5	nits	—
Subgroup	Symbol	MIL-STD-	Cases E, F Cases <u>1</u> /	2	2	4	4 5	5 7	8	9	0 10	9 12	10	14	12	13	14	15	20	Measured	LII	niits	Unit
		883 method	2	_		-	-		-						-				-	terminal	Min	Max	
			Test no.	Clear	Clock	A	В	С	D	EnP	GND	Load	EnT	QD	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	Vcc		WIN	Max	
1	V <sub>OL</sub>	3007	1	4.5 V	<u>2</u> /				0.7 V		GND	GND		4 mA					4.5 V	QD		0.4	V
c = +25°C			2					0.7 V			"	"			4 mA				-	Qc		-	
			3	"			0.7 V					"				4 mA			-	Q <sub>B</sub>		-	
		"	4			0.7 V					"	"					4 mA		-	Q <sub>A</sub>		-	"
			5								"	"	0.7 V					4 mA		Ripple carry			
	V <sub>OH</sub>	3006	6		<u>2</u> /				2.0 V		"	GND		4 mA					-	Q <sub>D</sub>	2.5		
			7		"			2.0 V			"	"			4 mA				-	Q <sub>C</sub>	"		"
			8		"		2.0 V				"	"				4 mA				Q <sub>B</sub>	"		
		"	9			2.0 V						"					4 mA			Q <sub>A</sub>	"		
		66	10			2.0 V	<u>3</u> /	<u>3</u> /	2.0 V			"	2.0 V					4 mA		Ripple carry	"		
	VIC		11	-18 mA							"									Clear		-1.5	
			12		-18 mA						"									Clock		-	
			13			-18 mA					"									Α		ш	"
			14				-18 mA				"								-	В		-	
			15					-18 mA			"								-	С			"
			16						-18 mA		"								-	D			"
			17							-18 mA	"									EnP			
			18									-18 mA								Load			
			19										-18 mA						-	EnT		-	
	$I_{IL4}$	3009	20	0.4 V							"								5.5 V	Clear	<u>4</u> /	<u>4</u> /	μA
	I <sub>IL6</sub>		21		0.4 V						"								"	Clock	"	"	
	$I_{IL4}$		22			0.4 V					"	GND							"	A	"	"	"
			23				0.4 V				"	"							"	В	"	"	"
			24					0.4 V			ű	"							"	С	"	"	"
		"	25						0.4 V		"	"							"	D	**	"	"
			26							0.4 V	"	4.5 V	4.5 V						"	EnP	"	"	"
	I <sub>IL5</sub>		27							4.5 V	"	0.4 V	4.5 V						"	Load	"	"	"
	$I_{IL5}$		28 <u>5</u> /							4.5 V	"	4.5 V	0.4 V						"	EnT	"	ш	"
	I <sub>IH13</sub>	3010	29 <u>13</u> /	2.7 V							"								66	Clear		20	
	I <sub>IH9</sub>	"	30		2.7 V						"								"	Clock		40	"
	I <sub>IH11</sub>	"	31			2.7 V	1			1	"	1	1	1	1				"	A	1	20	"
		"	32				2.7 V				"								"	В		"	"
		"	33					2.7 V			"								"	С		"	**
		"	34						2.7 V		"								"	D		"	"
		"	35							2.7 V	"	GND	GND						"	EnP		"	"
	I <sub>IH9</sub>	"	36							GND	"	2.7 V	GND						"	Load		40	"
	I <sub>IH9</sub>	"	37							GND	"	GND	2.7 V						"	EnT		40	"

TABLE III. <u>Group A inspection for device types 03, 04, 11, and 12.</u> Terminal conditions (pins not designated may be  $H \ge 2.0 \text{ V}$ ; or  $L \le 0.7 \text{ V}$ ; or open).

See footnotes at end of device types 03, 04, 11, and 12.

			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Lir	nits	
Subgroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured terminal			Unit
		method	Test no.	Clear	Clock	А	В	С	D	EnP	GND	Load	EnT	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>CC</sub>		Min	Max	
1	I <sub>IH14</sub>	3010	38 <u>13</u> /	5.5 V							GND								5.5 V	Clear		100	μA
Fc = +25°C	I <sub>IH10</sub>		39		5.5 V														-	Clock		200	
	I <sub>IH12</sub>		40			5.5 V														A		100	"
			41				5.5 V				"								-	В		-	"
		"	42					5.5 V												С		"	
		"	43						5.5 V		"								-	D		u	
			44							5.5 V	"	GND	GND							EnP		"	
	IH10	"	45							GND		5.5 V	GND							Load		200	
	I <sub>IH10</sub>		46	4 = 14	<u> </u>					GND		GND	5.5 V	0.115						EnT		200	
	los	3011	47	4.5 V	<u>2</u> /			4.5.1	4.5 V			GND		GND							-15	-100	mA
		"	48 49				4.5 V	4.5 V							GND	GND				Q <sub>c</sub>	"		
		66	49 50			4.5 V	4.5 V					"				GND	GND			Q <sub>B</sub>	"	"	"
		"	51	"	"	4.5 V	<u>6</u> /	<u>6</u> /	4.5 V		"	"	4.5 V				GND	GND	"	Ripple carry	"	"	
	I <sub>CCH</sub>	3005	52	5.5 V	5.5 V	5.5 V	5.5 V	5.5 V	5.5 V	5.5 V		5.5 V	5.5 V							V <sub>CC</sub>		31	
	ICCH	"	53	5.5 V	5.5 V	5.5 V	5.5 V	5.5 V	5.5 V	5.5 V	"	GND	5.5 V							"		31	"
	ICCL	"	54	GND	GND	GND	GND	GND	GND	GND	"	GND	GND						-			32	
	ICCL	"	55	GND	GND	GND	GND	GND	GND	GND		GND	GND						-			32	
2	Same te	sts, termin	al conditions	, and limit	ts as for s	ubgroup	1, excep	ot $T_c = 1$	25°C an	d V <sub>IC</sub> tes	ts are or	nitted.											
3	Same te	sts, termin	al conditions	, and limit	ts as for s	ubgroup	1, excep	ot T <sub>C</sub> = -{	55°C and	I V <sub>IC</sub> test	ts are on	nitted.											

## TABLE III. <u>Group A inspection for device types 03, 04, 11, and 12 – Continued.</u>

80

MIL-M-38510/315D

						-							0.7 V or ope										<del></del>
			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured	Lim	its	Unit
Subgroup	Symbol	MIL-STD-	Cases 1/	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		883	2																				
		method	Test no.	Clear	Clock	Α	В	С	D	EnP	GND	Load	EnT	QD	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple	V <sub>CC</sub>		Min	Max	
																		carry					
7	Func-	3014	56	В <u>8</u> /	A <u>8</u> /	A <u>8</u> /	A <u>8</u> /	A	A	A	GND	A	A	L	L	L	L	L	4.5 V				
Tc = +25°C	tional	"	57	A	A	В	В	В	В	"		"	В	"	"	"			"				
	tests	"	58	u	В	Α	A	Α	Α	"		"	A	"	"	и	"	"	"				
	7/	"	59	"	A	A	A	A	A	"		"	A	"	"	"	н	"	"				
	<u> </u>	"	60	"	A	B	B	B	В	u			B	"	"								
				"	B							"			"								
			61			A	A	A	A	"			A					"					
			62		A	A	A	A	A				A			Н	L						
		"	63		A	В	В	В	В				В		"				"				
		"	64		В	A	A	A	A			"	A	"	"				"				
		"	65	"	A	A	A	A	A			"	A	"	"	"	н		"				
		"	66	"	Α	В	В	В	В			"	В	"	"	"							
		"	67		В	А	A	Α	Α			"	A	"	"	"			"				
		"	68		А	Α	A	Α	Α			"	A	"	Н	L	L		"				
		"	69		A	В	В	В	В			"	В	"	"				"				
		"	70		B	A	A	A	A			"	A	"	"				"				1
			70		A	A	A	A	A			"	A	"	"		н					1	1
		"												"	"								
			72		A	B	B	B	B				B								1	1	1
			73		В	A	A	A	A				A										
		"	74	"	A	A	A	A	A				A	"	"	Н	L			See <u>9</u> /			1
			75	"	A	В	В	В	В			"	В		"		-						
			76	"	В	A	A	A	A			"	A	"	"	"			"				
		"	77	"	Α	A	A	A	Α			"	A	"	"	"	Н						
		"	78	"	A	В	В	В	В			"	В	"	"	"		"	"				
		"	79	"	В	Ā	Ā	Ā	Ā			"	A	"	"	"			"				
		"	80	"	A	A	A	A	A			"	A	Н	L	L	L		"				
		"	81	"	A	B	B	B	В			"	B		"	"	"						
			82	"								"			"								
				"	В	A	A	A	A			"	A		"								
			83		A	A	A	A	A				A				Н	Н					
			84		A	В	В	В	В				В					L					
		"	85	"	В	A	A	A	A	"		"	A	"	"	"		Н	"				
		"	86	"	A	-		"				"		L	"	"	L	L	"				
		"	87	В	Α	"		"				"		"	"	-			-				
		"	88	A	A	"		"	"	В		"		"	"	"			"				
		"	89	"	В	-	"	"	"			"		"	"	"			"				
		"	90	"	Α	"		"				"		"	"				"				
		"	91	"	A	В	В	В	В	A		"	В	"	"				"				
			92		A	A	A	A	A	"		"	"	"	"				"				
			93	"	B	<u></u>	A	A	A			"			"								
				"								"											
			94		A	"	A	A	A			5										1	1
			95	"	A		В	В	B			B									1	1	1
			96		В		В	В															
		"	97	"	A	"	В	В	"			"	"	"	"		н		"		1	1	1
		"	98	"	A		A	A				"		"	"				"				
		"	99	"	В	"		"				"		"	"				"				1
		"	100	"	А	"	"	"	"		"	"		"	Н	Н			"			1	1
		"	101	"	Α	"	"	"	"	"		Α		"	"	"	"	"	"	1			1
		"	102	"	B	"	"	"	"		"	"		"	"				"	1	1	1	1
		"	102	"	A	"		"				"		"	"				"	1			1
			103		A	"	В	В	A			В		"	"					1	1	1	1
							D #	D "	- A			 "		"	"							1	1
			105		B											<u> </u>	-	-					1
			106		A									Н	L	L					1	1	1
			107	"	A				-			A		"	"						1	1	1
		"	108		В		-	"	-			"		"	"		-				1	1	1
		"	109	"	A	"	"	"	"	"	"	"		"	"	"			"		1	1	1
		"	110	В	A	"	A	A	"			В	A	L	"		L	"	"	1	1	1	1
		"	111	Ā	A	"	"	"	"			"		"	"				"	1	1	1	1
		"	112	A	В		"	"	"			"		"	"	"			"	1		1	1
		"	113	A	A			"				"		н	н	н	н	Х	"				
	1																		"		1	1	
	1		114	В	A							A		L	L	L	L	L	-	1	1	1	1

#### TABLE III. <u>Group A inspection for device type 03</u> – Continued. Terminal conditions (pins not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open).

#### See footnotes at end of device types 03, 04, 11, and 12.

### TABLE III. Group A inspection for device type 03 – Continued.

			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured	Lin	iits	U
Subgroup	Symbol	MIL-STD-	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		method	Test no.	Clear	Clock	А	В	С	D	EnP	GND	Load	EnT	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>		V <sub>CC</sub>		Min	Max	:
7	Func-	3014	115	A 8/	A 8/	A 8/	B 8/	В	В	В	GND	В	В	L	L	L	L	L	4.5 V				+
c = +25°C	tional	"	116	"	В	"	"	"	ű	"	"	"	"	"	"	"	L	"	"				
	tests	"	117	"	А	"	u	"	"	"	"	"	"	"	"	"	н	"	"				
	7/	"	118	"	Α	В	u	"	Α	Α	"	"	Α	"	"	u	"	"	"				
	-	"	119	"	В	"	"	"	"	"	"	"	"	"	"	"	"	"	"				
		"	120	"	А	"	u	"	"	"		-	=	Н	"	=	L		"				
		"	121		A	"	А	u	В	В		"	u	=	"	"	"	"	"				
		"		"	В	"	u	"	ű	"	ű	"	u	u	"	"	"	"	"				
					A									L		Н							
														"		"		"					
																"		"					
														H		L							
							A																
							"								"								
												"		"		-	"						
Subgroup         Null-STD, 883 method         Cases 1/ 2         2         3         4         5         7         8         9         10         12         13         14         15         17         18         19         20         terminal           7         Rono         No         No         Load         EnT         Qo         Qo																							
	method         Test no.         Clear         Clock         A         B         C         D         EnP         GND         Load         EnT         Q0         QC         Q6         Q6         Q6         Q6         Rep         Rep         VCC           7         Finc-         116         A g/         Ag/         Bg/         Bg         B         B         B         C         C         C         C         Ga         C																						
		$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$																					
					A	"					-	-		H	_	-	L		"				
							ű		В			"		"	"	-			"				
					_				"		"	-		-	"	-	-						
														_									
							B	A															
																	L						
	1				_												Ц						
	1									"		"		"			"		"				
	1	"	140		B	<u>В</u> "	"	"				"		"	"				"				
		"	149		A	"		"						"	"	н			"				

See footnotes at end of device types 03, 04, 11, and 12.

MIL-M-38510/315D	

							Terminal c	onditions (p	oins not de	esignated m	ay be H≥2	.0 V or L ≤	0.7 V or ope	en).									
			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured	Lin	nits	Ur
Subgroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		method	Test no.	Clear	Clock	A	В	С	D	EnP	GND	Load	EnT	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>CC</sub>		Min	Max	1
7	Func-	3014	56	B <u>8</u> /	A <u>8</u> /	A <u>8</u> /	A	A	А	A <u>8</u> /	GND	А	A	L	L	L	L	L	4.5 V				
c = +25°C	tional	"	57	А	А	В	В	В	В	"		-	В	"		-			=				
	tests	"	58	"	В	A	A	A	A	u	"	"	A	"	"	ű	"	"					
	<u>7</u> /	"	59	"	Α	Α	A	A	A	"			A	"	"	"	Н	"	"				
		"	60	"	A	B	B	B	B	"			B	"									
			61 62		B A	A	A	A	A	"		"	A			Ĥ	Ľ	"					
		"	63		A	B	B	B	B			"	B	"		"	"						
		"	64		B	A	A	A	A				A	"	"				"				
		"	65		A	A	A	A	A			"	A	"	"		Н		"				
		"	66	"	A	В	В	В	В	"	"	"	В	"	"			"	"				
		"	67	"	В	А	А	A	A	"	"	=	А	"	"	=		"	=				
		"	68		А	А	A	A	А				А	"	Н	L	L		-				
		"	69		A	В	В	В	В			-	В	"	"	-		"	-				
			70		В	A	A	A	A				A	"	"				"			1	1
			71 72		A	A B	A	A B	A				A B				H						1
			72		A B	A	B A	A	B				A										1
			73		A	A	A	A	A				A			Н	L			See <u>9</u> /			1
		"	75	"	A	B	B	B	B				B	"	"				"	000 <u>0</u> /			
		"	76	"	B	Ā	A	Ā	Ā		"	"	Ā	"	"			"	"				
		"	77	"	Α	А	Α	A	Α	"	"	"	A	"	"		Н	"	"				
		"	78	"	А	В	В	В	В	"			В	"	"	-		"	-				
		"	79	"	В	A	A	A	A				A	"	"	-							
		"	80	"	A	A	A	A	A	"			A	Н	L	L	L		"				
			81		A	B	B	В	В				B										
			82 83		B	A	A	A	A				A				H	"					
			83		A A	A B	A B	A B	A B				B				н "	"					
		"	85	"	B	A	A	A	A				A	"	"			"	"				
		"	86	"	A	A	A	A	A		"	"	A	"	"	Н	L	"	"				
		"	87	"	Α	В	В	В	В	"	"	-	В	"	"	-	"	"	-				
		"	88	u	В	А	A	A	A	и	"	-	A	"	"	=		"	-				
		"	89	"	A	A	A	A	A	"	"	=	A	"		-	Н	"	=				
		"	90	"	A	В	В	В	В	"			В	"									
			91		B	A	A	A	A				A										
			92 93		A A	A B	A B	A B	A B				A B		H	L	L						
		"	93		B	A	A	A	A			"	A	"									
		"	95	"	A	A	A	A	A			"	A	"			Н		"				
		"	96	"	A	В	В	B	B		"	"	B	"	"			"	"				
		"	97	"	В	А	Α	A	Α	"	"	"	A	"	"		"	"	"				
		"	98		А	А	A	A	А				А	"	-	Н	L		-				
		"	99	"	A	В	В	В	В			-	В	"	"	-		"	-				
		"	100	"	В	A	A	A	A				A	"	"	"	"	"	"				
			101 102		A	A	A	A	A				A				H	H	"				
		"	102	"	A B	B A	B A	B A	B A			"	B A	"				H	"				
		"	103		A	A	A	A	A			"	A	L	L	1	L		"				
		"	105	В	A	A	A	A	A				A	"	"			"	"				
		"	106	A	A	A	A	A	A	В	"	"	A	"	"	"	"	"	"				1
		"	107		В	"	"	"	"	В		"	В	"	"				"				1
		"	108		Α	"	"	"	"	A		"	"	"	"	-			"				1
		"	109		В	"	В	В	В	"			"	"	"	-			"				1
		"	110	"	A	"	"	"	"	"	"	"	"	"	"		"	"	"				1
			111	"	В			"				B											1
			112 113	"	A A		~	" A						"	"	"	H	"	"				1
			11.5		A		A	I A													1	1	

# TABLE III. Group A inspection for device type 04 – Continued. Terminal conditions (pins not designated may be H > 2.0 V or L < 0.7 V or

#### See footnotes at end of device types 03, 04, 11, and 12.

			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured	Lin	nits	U
Subgroup	Symbol	MIL-STD-	Cases <u>1</u> /	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		883 method	2 Test no.	Clear	Clock	А	В	С	D	EnP	GND	Load	EnT	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>cc</sub>		Min	Max	
7	Func-	3014	115	A <u>8</u> /	A <u>8</u> /	А	Α	А	В	А	GND	В	В	L	Н	Н	Н	L	4.5 V				+
c = +25°C	tional	"	116		Α	"	"	"		"	"	Α	"	"	"				"				
0 - 120 0	tests	"	117	"	В	"	"	"		и	"	"	"	"	"	"	"	"	"				
	Z/	"	118	"	A	"	"	"		"	"	"		"	"				"				
	-	"	119	"	В	"	В	В	А	"	"	В	"	"	"				"				
		"	120	"	А	"	В	В			"	"		Н	L	L			"				
		"	121	В	A	"	A	A		"	"	"	Α	L	"		L	"	"				
		"	122	A	А	"	"	"			"	"	"	"	"								
		"	123	"	В	"	"	"			"	"		"	"	"		"	"				
		"	124	"	A	"	"	"		"	"	"	"	Н	Н	Н	Н	Н	"				
		"	125	"	В	"	-	"			-	"		"	"			-	"				
		"	126	В	A	"	-	"	-		-	A		L	L	L	L	L	-				
		"	127	A	A	В	"	"		"	"	В	"	"	"				"				
		"	128		В	"	"	"		"	"	"	"	"	"		-		-				
		"	129	"	A	"	"	"		"	"	"	"	Н	Н	Н							
		"	130	"	A	"	"	В	В	"	"	"		"	"	"			"				
		"	131		В	"																	
		"	132		A									L	L								
			133		A	A														See <u>9</u> /			
			134 135		B																		
			135		A									"	"		H						
			136	"	B	B "	B "	A				"		"	"								
		"	137	"	A	"		"				"	"	"	Н	-	L						
		"	139	"	A	A		"				"		"	"	-							
		"	139	"	В		"	"				"	"	"	"				"				
		"	140	"	A	"		"				"		"	"		Н		"				
		"	142	"	A	В	А	"				"	"	"	"	"		"	"				
		"	143	"	B	"	"	"		"	"	"	"	"	"			"	"				
		"	144	"	A	"	"	"		"	"	"		"	"	Н	L	"	"				
		"	145	"	A	"	В	В	А		"	"	"	"	"				"				
		"	146	"	В	"		"		"	"	"	"	"	"	"		"	"				
		"	147	"	A	"	"	"		"	"	"		Н	L	L			"				
		"	148	"	A	А	A	"		"	"	"	"	"	"								
		"	149	"	В	"		"			"	"		"	"				"				
		"	150	"	A	"	"	"		"		"		"	"	Н	Н		"				
		"	151	"	A	В	В	A				"		"	"		-						
		"	152	"	В	"		"		"		"	"	"	"	-	-	-	-				1
		"	153	"	A	"	"	"			"	"	"	"	Н	L	L		"				1
		"	154	"	A	A	"	"			"	"		"	"				"				1
		"	155		В	"									"								1
		"	156		A												н			1	1	1	1

TABLE III. Group A inspection for device type 04 – Continued.

See footnotes at end of device types 03, 04, 11, and 12.

r	T												0.7 V or ope		40	40		1.15	40	40				1
		MIL-STD-	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Measured terminal	Lim	its	Unit
Subgroup	Symbol	883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20		terminal			
		method	Test no.	Clear	Clock	A	В	С	D	EnP	GND	Load	EnT	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>cc</sub>	V <sub>cc</sub>		Min	Max	
7	Func-	3014	56	B <u>8</u> /	В <u>8</u> /	В <u>8</u> /	В	В	B <u>8</u> /	A <u>8</u> /	GND	В	A	Х	Х	Х	Х	Х	4.5 V	4.5 V				
Tc = +25°C	tional	"	57	В	Α	"	"	"	"	"	"	"		L	L	L	L	L	"	"				
	tests	"	58	A	В	"	"			"	"			"	"	**	**	"	"	"				
	<u>Z/</u>	"	59	Α	Α	"		"		"		"	"	"	"	"		"	"	"				
	-	"	60	B	A	А	А	Α	Α	"		A	"	"	"				"	"				
		"	61	B	В	A	A	A	A			"		"	"				"	"				
		"	62	B	A	A	A	A	A	"		"		"	"			"	"	"				
		"	63	A	A	В	В	B	B			"	В	"	"				"	"				
		"	64	"	В	Ā	A	Ā	Ā			"	Ā	"					"					
		"	65		A	A	A	A	A			"	A	"			н		"					
		"	66	"	A	В	B	B	B	"		"	В	"					"	"				
		"	67		B	Ā	Ā	A	A			"	Ā	"	"				"	"				
		"	68		A	A	A	A	A	"	"	"	A	"	"	Н	L		"	"				
1	1	"	69		A	В	B	В	B	"		"	В	"	"		"		"	"				
	1	"	70		B	A	A	A	A	"			A	"	"				"	"			1	
	1	"	70	"	A	A	A	A	A	"	"	"	A	"	"		н		"	"			1	
	1	"	72		A	B	B	B	B	"	"	"	B	"	"				"	"			1	
	1	"	73		B	A	A	A	A	"		"	A	"	"				"	"			1	
	1	"	74	"	A	A	A	A	A	"		"	A	"	н	L	L		"	"	See <u>9</u> /			
		"	75	"	A	В	В	В	B			"	В	"	"				"		<u>000 <u>o</u>/</u>			
		"	76	"	B	A	A	A	A	"		"	A	"	"				"	"				
		"	77		A	A	A	A	A			"	A	"			н		"					
		"	78		A	B	B	B	B			"	B	"					"					
		"	79		B	A	A	A	A			"	A	"					"					
		"	80	"	A	A	A	A	A			"	A		"	н	L		"	"				
		"	81		A	B	B	B	B			"	B				"		"					
		"	82		B	A	A	A	A			"	A	"					"					
		"	83		A	A	A	A	A			"	A	"			н	"	"					
		"	84		A	B	B	B	B		"		B					"	"					
		"	85	"	B	A	A	A	A			"	A					"	"					
		"	86		A	A	A	A	A			"	A	Н	L	L	L		"					
		"	87	u	A	B	B	B	B			"	B		"	-			"					
		"	88	ű	B	B	B	B	B	"		"	B						"					
		"	89		B	A	A	A	A				A											
		"	90	"	A	A	A	A	A			"	A		"		н	н	"	"				
		"	90	"	A	В	В	B	B	"			B		"			L	"	"				
		"	92	"	B	A	A	A	A			"	A		"			H	"	"				
		"	93	"	A	"		"	"	"		"	A	L	"		L	L	"	"				
	1	"	93	"	A	"		"		В		"	-	"	"		"		"	"			1	
	1	"	95	"	B	"		"		"		"		"					"				1	
	1	"	96	"	A	"								"	"				"	"			1	
1	1	"	97	"	B	"	"	"		А	"	"	В	"	"		"		"	"				
1	1	"	98	"	A	"	В	В	В	"	"	"	"	"	"				"	"			1	
1	1	"	99	"	B	"	"	"	"	"		В		"	"				"	"				
	1	"	100	"	A	"	"	"		"		"		"	"	"	н		"	"			1	
	1	"	100	"	A	"	А	А		"	"	"	"	"	"	"			"	"				
1	1	"	101	"	B	"		"		"	"	"	"	"	"				"				1	
	1	"	102	"	A	"	"	"		"				"	н	н			"	"			1	
	1	"	103		A	"	"	"		"		А		"	"				"					
	1	"	104	"	B	"	"	"		"	"	"	"	"	"				"	"			1	
	1	"	105	А	A	"		"		А		"		"	"	"			"	"				
	1	"	100	-	B	"	В	В	Α	-		В		"					"				1	
	1	"	107		A	"	"	"	"	"		B		Н	L	L			"	"				
1	1	"	108		A	"		"				A			"				"	"				
1	1	"	110	"	B	"	"	"				"	"	"	"		"		"	"			1	
	1		111	"	A	"						"							"				1	
1	1	"	112	В	B	"	A	A				"	A	"				н	"	"				
	1	"	112	B	A	"	-	"				"	"	L	"	"	L	L	"	"			1	
1	1	"	113	A	A	"	"	"				В			"	"	L	L	"	"				
L	1	1	114	~	~			1				ם	1	L	1		Ĺ		1	1		L	<u>ــــــــــــــــــــــــــــــــــــ</u>	لــــــــــــــــــــــــــــــــــــــ

#### TABLE III. <u>Group A inspection for device type 11</u> – Continued. Terminal conditions (pins not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open).

			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured	Lin	nits	U
Subgroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		method	Z Test no.	Clear	Clock	A	В	С	D	EnP	GND	Load	EnT	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple	V <sub>cc</sub>	•	Min	Max	_
		methou	restrio.	Cieai	CIUCK	^	В	C	D	LIF	GND	LUau	LIII	ЧD	QC	QB	QA	carry	V CC		IVIIII	IVIAA	•
7	Func-	3014	115	A <u>8</u> /	B <u>8</u> /	A	В	В	A	A	GND	В	A	L	L	L	L	L	4.5 V				
= +25°C	tional	"	116	"	A	"		"			"	"		Н	"		Н	Н	"				
	tests	"	117	"	В	"		"		"	"	"		"	"	"	"	"	"				
	7/	"	118	"	А	"		"		"	"	"		"	"			"	"				
	-	"	119	В	В	"	"	"		"	"	"		"	"				"				
		"	120	В	Α	"	"	"			"	"		L	"		L	L	"				
		"	121	A	A	В		"	В	"	"	u	В	"	"			"	"				
		"	122	"	В	"	A	"			"	"		"	"			"	"				
		"	123	"	Α	"	А	"			"	"		"	"	Н		"	"				
		"	124	"	Α	"	В	"	Α		"	"		"	"			"	"				
		"	125	"	В	"		"			"	"		"	"			"	"				
		"	126	"	Α	"		"			"	"		Н	"	L		"	"				
		"	127	"	Α	"		"	В		"	"	А	"	"	-	-	"	"				
		"	128		В	"		"			"	"		"	"		-		"				
		"	129		А	"		"				"		L	"	-	=	"	-				
		"	130	-	А	"	A	А	Α		-	"		"	"		-		=				
		"	131	-	В	"			-		-	"		"	"		-		=				
		"	132		А	"		"	-		"	"		H	Н	Н			-				
		"	133	"	A	A		В	В		"	"		"	"			"	"	See <u>9</u> /			
		"	134	"	В	"		"			"	"		"	"			"	"				
		"	135	"	A	"		"			"	"		L	L		Н	"	"				
		"	136	"	A	В	В	A			"	"		"	"			"	"				
		"	137	"	В	"	"	"		"	"	"		"	"			"					
		"	138	"	A	"		"		"			"	"	Н	L	L	"					
			139	"	A	A		"				"	"	"	"								
		"	140		В	"								"									
		"	141		A									"			Н	"					
			142	"	A	B	A	"										"					
			143		В													"					
			144		A									"		H	L						
			145	"	A		B	B "	A														
			146 147	"	B					"													
					A									H	L	L							
			148		A	A "														-			
	1		149 150		B					"							H	H		4			
	1		150		A		A	A				A			"		"	"		4			
	1		151		B	"	А "	А "				A "		"	"					4			
	1	"	152		A	"						"						<u> </u>		4			

### TABLE III. <u>Group A inspection for device type 11</u> – Continued. Terminal conditions (pins not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open).

See footnotes at end of device types 03, 04, 11, and 12.

	1				-	-							0.7 V or ope					<b></b>			<del></del>		<u> </u>
			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured	Limi	its	Unit
Subgroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		method	Test no.	Clear	Clock	A	В	С	D	EnP	GND	Load	EnT	Q <sub>D</sub>	Qc	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>CC</sub>		Min	Max	
7	Func-	3014	56	B <u>8</u> /	B <u>8</u> /	В <u>8</u> /	В	В	В	A <u>8</u> /	GND	В	Α	Х	Х	Х	Х	X	4.5 V		<u> </u>	<u> </u>	
Tc = +25°C	tional	"	57	<u>в</u>	A .	"		"		"	"	"	"	L	L	L	L	Ĺ	"				
10 = +25 0	tests	"	58	A	B	"		"		"		"		"	L	"	"	"	"				
	<u>7</u> /	"	59	A		"		"		"					"	"		"	"				
	<u>1</u> /	"	59 60	B	A				A	"		A			"				"				
					A B	A	A	A "	A "			A "		"					"				
		"	61	В		"		"		"		"		"	"			"	"				
			62	B A	A		В						В										
		"	63	A "	A	B		B	B			"			"								
			64		B	A	A	A	A				A										
			65	"	A	A	A	A	A				A				н						
			66		A	B	B	B	B				B										
			67		B	A	A	A	A				A										
			68		A	A	A	A	A				A			H	L "						
			69		A	B	B	B	B				B									1	
			70 71		B A	A	A	A	A				A				H					1	
			71			A	A	A				"					H "				1	1	
			72		A B	B	B A	B	B A				B							1	1	1	
			73	"	A	A	A	A					A		Н	-				Sec 0/	1	1	
			74 75	"	A	A B	B	B	A B			"	B	"	н		L			See <u>9</u> /		1	
		"	76	"	B							"			"				"				
		"		"		A	A	A	A			"	A	"	"				"				
			77 78	"	A	A	A B	A	A B				A		"		H						
		"	78	"	A	B		B				"	B	"					"				
		"		"	B A	A	A	A	A			"	A	"	"	Н			"				
		"	80	"		A	B	A				"	B		"		L						
		"	81 82		A B	B	A	B A	B				A		"								
		"	83	"	A	A	A	A	A			"	A		"		н	"	"				
			84	"	A	B	B	B	B			"	B	"	"		"	"					
		"													"			"					
		"	85	"	B	A	A	A	A			"	A	Ц	-	-			"				
		"	86 87	"	A A	A B	A B	A B	A B			"	A B	H	L	L	L		"				
		"	88	"	B	A	A	A	A	"		"	A	"	"				"				
		"	89	"	A	A	A	A	A			"	A		"		н		"				
		"	90	"	A	B	B	B	B			"	B		"		<u> </u>		"				
		"	90	"	B	A	A	A	A	"		"	A		"				"				
		"	91	"	A	A	A	A	A			"	A		"	Н	L		"				
		"	93	"	A	B	B	B	B			"	B	"	"		"		"				
		"	94	"	B	A	A	A	A			"	A	"	"				"				
		"	95	"	A	A	A	A	A			"	A	"	"		н		"			1	
		"	96	"	A	В	B	B	В			"	B	"	"				"	1	1	1	
		"	97	"	B	A	A	A	A	"	"	"	A	"	"			"	"	1	1	1	
		"	98	"	A	A	A	A	A	"	"	"	A	"	н	1	L	"	"	1	1	1	
		"	99	"	A	B	B	B	B			"	B	"	"		"		"	1	1	1	
		"	100	"	B	A	A	A	A	"		"	A	"	"	u			"	1		1	
		"	100	"	A	A	A	A	A	"	"	"	A	"	u	u	н		"	1	1	1	
		"	102	"	A	B	B	B	В	"	"	"	B	"	"				"	1		1	
		"	102	"	B	A	A	A	A	"	"	"	A	"	"		"	"	"	1	1	1	
		"	100	"	A	A	A	A	A	"		"	A	"	"	Н	L	"	"	1	1	1	
		"	105		A	В	B	В	В	"	"	"	В	"	"				"	1	1	1	
		"	106		B	A	A	A	A	"	"	"	A	"	u	u			"	1		1	
		"	100	"	A	A	A	A	A	"	"	"	A	"	"		н	Н	"	1	1	1	
		"	108		A	B	B	В	В	"	"	"	В	"	"			L	"	1		1	
		"	109		B	A	A	A	A	"	"	"	A	"	"			H	"	1		1	
		"	110	"	A	"	"	"	"	"		"	A	L	L	L	L	L	"	1	1	1	
		"	110	"	B	"	"	"		В		"	В	"	"	"	"	"	"	1	1	1	
		"	112	"	A	"		"	"	"	"	"		"	"			"	"	1		1	
		"	113	"	B	"	"	"		Α	"	"	"	"	u	u			"	1	1	1	
		"	114	"	A	"	В	В	В	A	"	"		"	"	"			"	1		1	
L	1	1	114	1	~		U U	U U	U U	~		1		1						1	L	L	I

#### TABLE III. Group A inspection for device type 12 – Continued. Terminal conditions (pins not designated may be $H \ge 2.0$ V or L $\le 0.7$ V or open).

See footnotes at end of device types 03, 04, 11, and 12.

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	1		Cases E, F	1	2	3	4	5	6	7	ayberr≥z 8	9	0.7 V or ope 10	11	12	13	14	15	16	Measured	Lin	nits	Ur
Cubarous	Cumhal	MIL-STD-				4													20	terminal	LIII	1115	U
Subgroup	Symbol	883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	torrinia			
		method	Test no.	Clear	Clock	А	В	С	D	EnP	GND	Load	EnT	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple	V <sub>cc</sub>		Min	Max	-
		metriod	rest no.	orour	Olook	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~		Ŭ	U	<b>L</b>	OND	Loud	2	αŋ	Sec.	αB	<b>G</b> A	carry	• 00			max	
7	Func-	3014	115	A <u>8</u> /	В	Α	B <u>8</u> /	B <u>8</u> /	В	А	GND	В	В	L	L	L	L	L	4.5 V				1
c = +25°C	tional	"	116		A		B	B			"	"		"	"		H	"	"				
0 = 725 0	tests		117	"	A	"	A	A		"	"	"			"	"	"	"	"				
	<u>7/</u>		117	"	B	"	A "			"		"			"				"				
	<u>1</u> /	"	118	"	A					"					н	Н			"				
		"	120	"	A	"		"				A	"	"	"	"	"	"	"				
		"	120	"	B	"			"	"		" "	"		"			"	"				
		"	121			"	В	В	٨			"			"				"				
			122		A B	"	<u>В</u> "	 "	A			В			"	"			"				
		"	123				"		"			В							"				
		"		"	A	"	^	^					^	H	L	L			"				
		"	125 126		A		A	A					A	"		"			"				
		"	126		B A	"			"				"		Н				"				
		"													"	H		H	"				
			128		A	B		"						"	"				"				
			129 130		B	A	В		В						"				"				
		"	130			A	 "	B "	 "			"		L		L		L	"				
		"	131		A "	B						"		"	L "	"			"				
		"			"		"		^										"	Cas O/			
			133		"	A		A	A										"	See <u>9</u> /			
			134	"	"	B			A					"	"		"		"				
		"	135	"	"	A	"	"	B "						"				"				
			136	"	"	B	^								"				"				
			137 138	"	"	B A	A	B							"				"				
		"	130	"	В	А "						"			"				"				
		"	139	"	A	"						"			"	Ц			"				
		"	140	"	A	В	В	A				"			"	H			"				
		"	141	"	B	"	в "	- <u>-</u>			"	"			"			"	"				
		"	142	"	A	"		"				"			н	L	L	"	"				
			143	"	A	A						"			"			"	"				
		"	144	"	B	A "		"						"	"				"				
		"	145	"	A	"									"		н		"				
		"	140	"	A	В	А			"	"	"			"				"				
		"	147	"	B										"				"				
		"	149	"	A	"									"	Н	L		"				
		"	149	"	A	"	В	В	А	"		"		"	"		"		"				
		"	150	"	B	"	"	"	"			"		"	"				"				
		"	152	"	A	"					"	"		Н	L	L			"				
		"	153	"	A	"	А	"				"			"	-			"				
		"	154		B	"	"	"				"		"	"				"				
		"	155		A	"		"				"		"	"	Н			"				
		"	156		A	А		"				"		"	"				"				
		"	157		B	"		"				"		"	"				"				
		"	158		A	"		"				"		"	"		Н		"				
		"	159	"	A	В	В	Α				"		"	"	"			"				
		"	160	"	В	"	"	"				"		"	"	"			"				
		"	161	"	A	"		"			"	"		"	Н	L	L		"				
		"	162		A	A		"			"	"		"	"				"		1	1	1
		"	163	"	B	"		"				"	"	"	"				"		1		
		"	164	"	A	"		"				"	"	"	"		Н		"		1		
		"	165		A	"		"				А		"	"				"		1		
		"	166		B	"		"				"		"	"				"		1		
		"	167		A	"		"				"	"	"	"	Н	1		"				
			101		17		1			1	1							1			1		

#### TABLE III. <u>Group A inspection for device type 12</u> – Continued. Terminal conditions (pins not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open).

		MIL-STD- 883		Ca E,	ses F		1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Lir	mits	
Subgroup	Symbol	method		Cas			2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit
			([	Tes Device	t no. e types	;)	Clear	Clock	А	В	С	D	EnP	GND	Load	EnT	$Q_D$	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>CC</sub>	terminal	Min	Max	
9 Tc = +125°C	F <sub>MAX</sub> <u>10</u> /	3003 (Fig 6)	151	157	154	168	4.5 V	IN					4.5 V	GND	4.5 V	4.5 V				OUT		5.0 V	Q <sub>A</sub>	22		MHz
	t <sub>PLH4</sub>	-	152	158	155	169	"	"					"	"	"	"					OUT	"	Clk to carry	3	40	ns
	t <sub>PHL4</sub>	"	153	159	156	170	"	"					"	"	"	"					OUT	"	Clk to carry	"	40	
	t <sub>PLH5</sub>		154	160	157	171	"	"					"	"	"	"				OUT		"	Clk to Q <sub>A</sub>	"	29	"
		u	155	161	158	172	"	"					"	"	66	"			OUT			"	Clk to Q <sub>B</sub>	u	и	"
		"	156	162	159	173	"	"					"	"	66	"		OUT				"	Clk to Q <sub>C</sub>	"		"
			157	163	160	174	u	u					u	"	"	"	OUT					"	Clk to Q <sub>D</sub>	"		
	t <sub>PHL5</sub>		158	164	161	175	u	u					u	"	"	"				OUT		"	Clk to Q <sub>A</sub>	"	32	
		"	159	165	162	176	"	u					"	"	"	"			OUT			"	Clk to Q <sub>B</sub>	"	u	"
		u	160	166	163	177	"	"					66	"	66	66		OUT				"	Clk to Q <sub>C</sub>	u	и	"
		"	161	167	164	178	"	"					66	"	66	66	OUT					"	Clk to Qp	"	u	"
	t <sub>PLH6</sub>	"	162	168	165	179	"	"	IN					"	GND					OUT		"	Clk to Q <sub>A</sub>	"	29	"
	t <sub>PHL6</sub>	u	163	169	166	180	"	"	IN	-				"	"					OUT		"	Clk to Q <sub>4</sub>	"	32	
	t <sub>PLH6</sub>	u	164	170	167	181	"	"		IN				"	"				OUT			"	Clk to Q <sub>B</sub>	"	29	"
	t <sub>PHL6</sub>	"	165	171	168	182	"	"		IN				"	"				OUT			"	Clk to Q <sub>B</sub>	"	32	
	t <sub>PLH6</sub>	"	166	172	169	183	"	u			IN			"	"			OUT				"	Clk to Q <sub>C</sub>	"	29	"
	t <sub>PHL6</sub>	"	167	173	170	184	"	"			IN			"	"			OUT				u	Clk to Q <sub>C</sub>	"	32	
	t <sub>PLH6</sub>	"	168	174	171	185	"	"				IN		"	"		OUT					u	Clk to Q <sub>D</sub>	"	29	"
	t <sub>PHL6</sub>	u	169	175	172	186	"	u				IN		"	"		OUT					"	Clk to Q <sub>D</sub>	"	32	
	t <sub>PLH7</sub>	u	170	176	173	187	"	u					4.5 V	"	4.5 V	IN					OUT	"	EnT to C <sub>v</sub>	u	19	
	t <sub>PHL7</sub>	"	171	177	174	188	"	"					4.5 V	"	4.5 V	IN					OUT		EnT to	u	19	"
	t <sub>PHL8</sub>		172	178	175	189	IN	<u>12</u> /	4.5 V					"	GND					OUT			Clr to	u	<u>11/</u> 33	"
	t <sub>PHL8</sub>				176		"	"		4.5 V				"	"				OUT				Q <sub>A</sub> Clr to	"	u	"
	t <sub>PHL8</sub>		174	180		191	"	"			4.5 V			"	"			OUT					Q <sub>B</sub> Clr to	u	"	"
	t <sub>PHL8</sub>	"	175	181		192	"	"				4.5 V		"	"		OUT						Q <sub>C</sub> Clr to	u	u	u
	'11L0		1																				QD			

TABLE III. Group A inspection for device types 03, 04, 11, and 12. Terminal conditions (pins not designated may be  $H \ge 2.0 V$ ; or  $L \le 0.7 V$ ; or open).

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					ises , F		1		2	3	4	5	6	7	ay be ⊓ ≥ 8	9	10	11	12	13	14	15	16		Lir	nits	
Subgroup	Symbol	MIL-STD-			se <u>1</u> /		2		3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit
		883 method		(Device	t no. e types		Clea	ar	Clock	А	В	С	D	EnP	GND	Load	EnT	$Q_D$	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>cc</sub>	terminal	Min	Max	
10	F	3003	03	04 182		12																		Clk to	22		MHz
Tc = +125°C	F <sub>MAX</sub> 10/	(Fig 6)	170	102	179	195																		QA	22		IVITIZ
	t <sub>PLH4</sub>	"	177	183	180	194																		Clk to Carry	3	56	ns
	t <sub>PHL4</sub>		178	184	181	195																		Clk to carry	"	56	
	t <sub>PLH5</sub>		179	185	182	196	ĺ																	Clk to Q <sub>A</sub>	"	41	
		"	180	186	183	197																		Clk to Q <sub>B</sub>	**	"	"
		"	181	187	184	198																		Clk to Q <sub>C</sub>	"	"	"
			182	188	185	199																		Clk to Q <sub>D</sub>	"	"	"
	t <sub>PHL5</sub>	"	183	189	186	200																		Clk to Q <sub>A</sub>	"	45	
		"	184	190	187	201																		Clk to Q <sub>B</sub>	"	"	"
		"	185	191	188	202																		Clk to Q <sub>C</sub>	"	"	
		"	186	192	189	203																		Clk to Q <sub>D</sub>	"	"	"
	t <sub>PLH6</sub>	"	187	193	190	204																		Clk to Q <sub>A</sub>	"	42	
	t <sub>PHL6</sub>	"	188	194	191	205	Sa	ame te	erminal c	conditions	s as for su	ubgroup 9												Clk to Q <sub>A</sub>	"	48	
	t <sub>PLH6</sub>	"	189	195	192	206																		Clk to Q <sub>B</sub>	"	42	"
	t <sub>PHL6</sub>	u	190	196	193	207																		Clk to Q <sub>B</sub>	"	48	
	t <sub>PLH6</sub>	"	191	197	194	208																		Clk to Q <sub>C</sub>	"	42	
	t <sub>PHL6</sub>	"		198		209																		Clk to Q <sub>C</sub>	"	48	"
	t <sub>PLH6</sub>	ű		199		210	Į																	Clk to Q <sub>D</sub>	"	42	
	t <sub>PHL6</sub>	u	194	200	197	211	Į																	Clk to Q <sub>D</sub>	"	48	
	t <sub>PLH7</sub>	ű	195	201	198	212	Į																	EnT to carry	"	28	"
	t <sub>PHL7</sub>			202		213	ļ																	EnT to carry	"	28	"
	t <sub>PHL8</sub>	"	197	203																				CIr to Q <sub>A</sub>	"	46	"
	t <sub>PHL8</sub>			204																				CIr to Q <sub>B</sub>	"	46	"
	t <sub>PHL8</sub>	"			202																			Clr to Q <sub>C</sub>	u	46	ű
	t <sub>PHL8</sub>	"	200	206	203	217																		Clr to Q <sub>D</sub>	**	46	"
11	Same tes	ts, terminal	condi	tions, a	and lim	its as	for sub	group	10, exce	ept T <sub>C</sub> = -	55°C.																

TABLE III. Group A inspection for device types 03, 04, 11, and 12. Terminal conditions (pins not designated may be  $H \ge 2.0$  V; or  $L \le 0.7$  V; or open).

- 1/ For case 2, pins not referenced are NC.
- 2/ Apply one pulse prior to measurement as follows:



- 3/ Apply 0.7 V for types 03 and 11; apply 2.0 V for types 04 and 12.
- $\underline{4}$ / I<sub>IL</sub> limits (µA) min/max values for circuits shown:

Parameter	Terminals				Circuits			
		А	В	С	D	E	F	G
	Clear 03	-160/-400	-30/-300	-120/-360	-160/-400	-120/-360	-0/-100	-16/-400
	Clear 04	**	**	**	**	"	**	"
	Clear 11	66	66		66	"	-150/-450	"
	Clear 12	55	55	-290/-630	55		-130/-430	"
	EnP	"	"	-120/-360	"	-120/-360	-150/-380	"
	A, B, C, D	"	"	-160/-400	"	-150/-380	-0/-100	"
I <sub>IL5</sub>	Load	-320/-800	-30/-300	-290/-630	-320/-800	-120/-360	-160/-400	-320/-800
'IL5	EnT	020/000	00, 000	-340/-860	020/000	-240/-720	-300/-760	020,000
I <sub>IL6</sub>	Clock	-160/-400	-0/-100	-290/-630	-160/-400	-180/-420	-0/-100	-160/-400

- 5/ For types 03 and 11, set outputs to 9<sup>th</sup> count (Q<sub>A</sub> = 1, Q<sub>D</sub> = 1, Q<sub>B</sub> and Q<sub>C</sub> = 0) prior to measurement.
  - For types 04 and 12, set outputs to  $15^{th}$  count (Q<sub>A</sub>, Q<sub>B</sub>, Q<sub>C</sub> and Q<sub>D</sub> = 1) prior to measurement.
- 6/ Apply GND for types 03 and 11; apply 4.5 V for types 04 and 12.
- 7/ Only a summary of attributes data is required.
- <u>8</u>/ A = 3.0 V minimum; B = 0.0 V or GND.
- <u>9</u>/ H > 1.5 V; L < 1.5 V; X = don't care.
- $\underline{10}$ / The F<sub>MAX</sub> minimum limit specified is the frequency of the input pulse. The output frequency shall be one-half of the input frequency. For type 04, circuit C, 20 MHz minimum.
- 11/ The limit for circuit B shall be 23 ns.
- 12/ For types 03 and 04, apply one clock pulse prior to test. For types 11 and 12 apply one clock pulse prior to test and another pulse during test.
- <u>13</u>/  $I_{IH13}$  limit for types 11 and 12; 40 µA maximum.

I<sub>IH14</sub> limit for types 11 and 12; 200 µA maximum.

						-						y be H ≥ 2.											
			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Lir	nits	1
Subgroup	Symbol	MIL-STD- 883	Case <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit
ſ		method	Test no.	U/ D	СК	A	В	С	D	EP	GND	L	ET	Q <sub>D'</sub>	Q <sub>C'</sub>	Q <sub>B'</sub>	Q <sub>A'</sub>	Ripple carry	$V_{CC}$	terminal	Min	Max	
1	Vol	3007	1	4.5 V	2/	0.7 V	0.7 V	0.7 V	0.7 V	4.5 V	GND	0.7 V	4.5 V	4 mA					4.5 V	Q <sub>D</sub>		0.4	V
Γc = +25°C	02		2		"		"		"	"		"	"		4 mA					Q <sub>c</sub>			
			3		"		"		"	"		"	"			4 mA			"	Q <sub>B</sub>		"	"
			4		"		"		"	"		"	"				4 mA			Q <sub>A</sub>			
		"	5	0.7 V	"		"		"	0.7 V		"	0.7 V					4 mA	"	Ripple carry		u	
	V <sub>OH</sub>	3006	6	4.05 V		2.0 V	2.0 V	2.0 V	2.0 V	"		"		4 mA						Q <sub>D</sub>	2.5		
	- OH		7				"	"	"	"		"			4 mA					Q <sub>c</sub>	"		
			8		"		"		"	"		"				4 mA				Q <sub>B</sub>	"		
		"	9				"		"	"		"					4 mA			QA	**		
		"	10	0.7 V	"		"		"	"		"	"					4 mA		Ripple carry	u		
ľ	V <sub>IC</sub>		11	-18 mA							"								"	U/ D		-1.5	
'			12		-18 mA														"	СК			
			13			-18 mA													"	A		"	66
			14				-18 mA													В			
			15					-18 mA												С		"	"
			16						-18 mA		**								u	D		"	"
			17							-18 mA	**								u	EP		"	"
			18								"	-18 mA							u	L		"	"
			19								"		-18 mA						u	ET		и	"
	I <sub>IL12</sub>	3009	20			0.4 V					**	GND							5.5 V	A	<u>3</u> /	<u>3</u> /	μA
		"	21				0.4 V				**	"							u	В			"
		u	22					0.4 V			"	"							u	С			"
		u	23						0.4 V		"	"							u	D			"
l	I <sub>IL13</sub>	"	24	0.4 V							"								u	U/ D	<u>3</u> /	<u>3</u> /	"
		u	25		0.4 V						"								u	CK			"
		u	26								"	0.4 V							u	L			"
	I <sub>IL14</sub>	"	27							0.4 V	"									EP	<u>3</u> /	<u>3</u> /	"
	$I_{\rm IL15}$	u	28								"		0.4 V						u	ET	<u>3</u> /	<u>3</u> /	"
	I <sub>IL17</sub>	3010	29	2.7 V							"								u	U/ D		20	"
'		"	30	L	2.7 V						"								u	CK		"	"
		u	31			2.7 V					"								u	A		u	"
		u	32				2.7 V				"								"	В		"	"
'		u	33					2.7 V			"								u	С		u	"
'		u	34						2.7 V		"								u	D		"	"
		u	35	ļ						2.7 V	"								"	EP		"	"
'		"	36	ļ						ļ	"	2.7 V							u	L		"	"
	I <sub>IH19</sub>	u	37								"		2.7 V						"	ET		40	"

TABLE III. <u>Group A inspection for device types 05 and 06.</u> Terminal conditions (pins not designated may be  $H \ge 2.0 V$ ; or  $L \le 0.7 V$ ; or open).

See footnotes at end of device types 05 and 06.

		MIL-STD-	Cases E, F	1	2	3	4	5	6	7	8	9	10	≦ 0.7 V; or 11	12	13	14	15	16		Lin	nits	
Subgroup	Symbol	883 method	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Uni
			Test no.	U/ D	СК	A	В	С	D	EP	GND	L	ET	Q <sub>D</sub>	Q <sub>c</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	$V_{CC}$	terminal	Min	Max	
1	I <sub>IH18</sub>	3010	38	5.5 V							GND								5.5 V	U/ D		100	μA
c = +25°C		"	39		5.5 V														"	CK			
			40			5.5 V														A			
			41				5.5 V													В			
		"	42					5.5 V			"									С		"	
		"	43						5.5 V											D		"	
			44							5.5 V										EP		"	
			45									5.5 V								L			
	I <sub>IL20</sub>	"	46										5.5 V							ET		200	
	I <sub>0S</sub>	3011	47	5.5 V	<u>2</u> /	5.5 V	5.5 V	5.5 V	5.5 V	5.5 V		GND	5.5 V	GND					"	Q <sub>D</sub>	-15	-100	
			48				"	-	"	"		-	-		GND					Q <sub>c</sub>	"	и	
			49	"	"		"	-	"	"		"	-			GND				Q <sub>B</sub>	"	"	
			50	"	"		"		"	"	"	-	-				GND			Q <sub>A</sub>	"	"	"
		-	51	"			"		"	"		=	-					GND		Ripple carry	"		
	I <sub>CC</sub>	3005	52	GND	"	GND	GND	GND	GND	GND		5.5 V	GND							V <sub>cc</sub>		34	
2	Same te	sts, termina	al conditions	, and limit	s as for s	subgroup	1, excep	ot $T_c = +$	125°C a	nd V <sub>IC</sub> te	ests are o	omitted.			•	•	•						-
3	Same te	sts, termina	al conditions	, and limit	s as for s	ubgroup	1, excep	ot $T_c = -$	55°C and	d V <sub>IC</sub> test	s are on	nitted.											

# TABLE III. <u>Group A inspection for device types 05 and 06.</u> Terminal conditions (pins not designated may be $H \ge 2.0 V$ ; or $L \le 0.7 V$ ; or open).

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			Cases E, F	1	2	3	4	5	6	7	8	9	0.7 V or ope 10	11	12	13	14	15	16	Measured	Limits	1
Subgroup	Symbol	MIL-STD-	Cases <u>1</u> /	2	3	4	5	7	8	9	10	12	13	14	15	10	18	10	20	terminal	Emito	
5 1	-,	883 method	2 Test no.		СК	A	В	С	D	EP	GND	L	ET	Q <sub>D</sub>	Q <sub>c</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple	V <sub>cc</sub>		Min Ma:	22
				U/ D			В		D	L1				y o	3	GB	<b>Y</b> A	carry			IVIIII IVICA	~
7	Func-	3014	53	A <u>5</u> /	B <u>5</u> /	В	В	В	В	В	GND	В	В	Х	Х	Х	Х	Х	4.5 V			
c = +25°C	tional	"	54		A	"	"	"	"	"		В		L <u>5</u> /	L	L	L	H <u>5</u> /	"			
	tests		55	"	В		"	"		"		A		"		"	L	"	"			
	<u>4/</u>		56 57	"	A B	"		"		"					"	"	H H					
			58	"	A	"		"				"		"		Н		"	"			
			59	"	В	u		"	"	"		"	"	"	"		L	"	"			
			60		A	"	"	"	"	"		"		"	"		H		"			
		"	61	"	В	"	"	"	"	"		"		"	"	u	Н		"			
		"	62	"	A	"	"	"	"			"		"	Н	L	L		"			
			63	"	В		"	"					"	"			L					
			64	•	A				"				"		"	"	Н	"				
			65		B	"											Н					
			66 67		B	u		"						"		H			"			
		"	68	"	A	u	"	"	"	"		"	"	"	"		H		"			
		"	69	"	В	"	"	"	"	"		"	"	u	"	"	Н	"	"			
			70	"	A	"	"	"	"	"		=		Н	_	L	L		=			
			71	"	В	"	"	"	"			"		"	"		L		"	See <u>6</u> /		
		"	72	"	A	"		"	"					"	"		Н	L	"			
			73		B	"	"	"		A								L				
			74 75		A B		"	"		A B												
			76	"	A	u		"		В "			A	"	"			н				
		"	77	"	A	"	"	"	"	"		"	A	"	"			Н	"			
		"	78	"	В	"	"	"	"	"	"	"	В	"	"	u		L	"			
		"	79	"	A	"	"	"	"	"	"	-	"	L	-	"	L	Н	-			
		"	80	"	В	А	"	"	A		"	В	"	L	-	ű	L	"	-			
			81	-	A	"	"	"				В		H	"	"	Н	L	"			
			82	B	B							A		"			Н	н				
		"	83 84	"	A B	"		"				"		"	"		L		"			
			85	"	A	u	"	"		"				-	Н	Н	H		"			
			86	"	В	"		"				"		"	"		H		"			
		"	87	"	A	"		"	"	"		"		"	"	u	L		"			
		"	88	"	В	"	"	"	и	"		"		"	"	Н	L		"			
		"	89	"	A	"		"						"	"	L	Н		"			
			90		B	"	"															
			91 92		A B			"									L					
		"	93	"	A	"		"				"		"	L	Н	H		"			
			94	"	В	u		"		"		"	"	"	"		H		"			
		"	95	"	Ā	"	"	"	"	"	"	"	"	"	"	"	L	"	"			
			96	"	В	"	"	"	"	"		=		"	=		L		=			
		"	97		A	"	"	"		"		-		"	=	L	Н	-	-			
		"	98	"	В	"		"						"	"	"	H		"			
			99		A	"											Ľ	Ļ				
			100 101		B A					A												
		"	101		B	"	"	"		B		"		"	"		u		"	1		
		"	102	"	B	"	"	"	"	"		"	A	"	"		"	н	"			
		"	104	"	A	"	"	"	"	"	"	"	A	"	"	"	"	н	"	1		
		"	105	"	В	"	"	"	"	"		"	В	"	"	"	u	L	"			
		"	106	"	В	В	A	A	"	"	"	В	"	"	ű	u	ű	L	**			
	1	"	107	"	A	В	A	A	"	"	"	В	"	"	"	н	н	н	"	1	1 1	

TABLE III. <u>Group A inspection for device type 05</u> – Continued. Terminal conditions (pins not designated may be  $H \ge 2.0$  V or  $L \le 0.7$  V or open).

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			Cases E, F	1	2	3	4	5	6	7	8	9	10.7 V 01 0pe	11	12	13	14	15	16	Measured	Lim	its	Unit
Subgroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		method	Test no.	U/ D	СК	А	В	С	D	EP	GND	L	ET	QD	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>CC</sub>		Min	Max	
7	Func-	3014	53	A <u>5</u> /	В <u>5</u> /	В	В	В	В	В	GND	В	В	Х	х	Х	Х	X	4.5 V				
Tc = +25°C			54	"		"	"	"	"	"	UND	B				L		H <u>5</u> /	<b>4.5</b> ♥	-			
$10 = +25^{\circ}$ C	tional	"	55	"	A B		"	"		"		A		L <u>5</u> /	L	"	 	" <u>"</u>		-			
	tests			"						"		A "		"	"		H			-			
	<u>4</u> /		56 57	"	A B					"					"	"	Н		"	-			
			57	"	A							"		"	"	Н	L	"		-			
			59	"	B	"		"	"	"		"	"	"	"	"	 	"		-			
			59 60		A		66	"	"			"		"	"		H			-			
		"	61		B		**					"		"	"	"	H		"	-			
		"	62		A	"	"		u			"		"	Н	L	L		"	-			
			63	"	B		"	"					"		"		L		"	-			
		"	64		A							"		"	"	"	H		"	-			
		"	65		B				"			"	"	"	"	"	H	ű	"	-			
		"	66		A	"		"				"		"	"	Н	L		"	1			
	1	"	67		B	"		"				"		"	"		L		"	1			
		"	68		A	"	"	"	ű	"		"		"	"		H		"	1			
	1	"	69		B	"		"				"		"	"	и	Н	"	"	1			
		"	70		A	"		"				"		Н	L	L	L		"	1			
		"	71	"	В	"	**	"	"			"		"	-	"	L		"	See <u>6</u> /			
		"	72	"	A	"		"	u		"	"		"	"		Ĥ	u	"	<u> </u>			
		"	73	"	В	"		"	"		"	"		"	"	"	H		"				
		"	74	"	A	"	**	"				"		"	"	Н	L		"				
		"	75	"	В	"	"	"			"	"		"	"	"	Ĺ	"	"				
		"	76	"	Α	"		"			"	"		"	"	"	Н	"	"				
		"	77	"	В	"		"			"	"		"	"	"	Н	"	"				
		"	78	"	А	"		"	"	"	"	"		"	Н	L	L	"	"				
		"	79	"	В	"	"	u	"	"	"	"		"	"		L	"	"				
		"	80	"	Α			**			"	"	"	"		"	Н	"	"				
		"	81	"	В			"			"	"		"	"	"	Н	"	"				
		"	82	"	Α	"		"				"		"	"	Н	L	"	"				
		"	83	"	В	"	"	"		"	"	"		"	"	"	L	"	"				
		"	84	"	А	-		"	-		-	"		"	=		Н	L	-				
		"	85	"	В					A		"		"	"				"				
		"	86	"	Α		-	"		A		"	-	"	-								
		"	87	"	В					В		"		"	"	"			"				
		"	88		В	-	"	ű	u	"		"	A	"	-	-	-	Н	"				
		"	89	"	A	-		"		"		"	A	"	-			н	"				
		"	90	"	В	-		"			"	"	В	"	"	u	"	L	"				
			91	"	A	"	"		"			"		L	L	L	L	Н	"	4			
	1		92		B	A "	A	A "	A			В		L	L	L	L	н		4			
			93		A	"						B		H	Н	H	Н	L		4			
	1		94	B "	B							A "					Н	H		4			
	1		95 96		A B												L			4			
			96 97			"	"	"						"			L			1			
	1	"	97 98		A B											L "	H			1			
		"	98		A	"		"				"		"	"	и			"	1			
	1		100		B	"						"		"	"		L		"	1			
		"	100		A	"		"				"		"	L	Н	H		"	1			
	1	"	101		B	"		"				"		"	"		H		"	1			
	1	"	102		A			"				"		"	"		L		"	1			
	1	"	103		B			"		"	"	"		"	"				"	1			
	1	"	105		A	"	"	"	"	"	"	"	"	"	"	L	H		"	1			
		"	105	"	B	"	"	"	"	"	"	"	"	"	"	"	Н	"	"	1			
	1	"	100	"	A	"		"	u	"	"	"	"	u	u		L		"	1			
	1	"	108	"	B	"	"	"		"	"	"	"	"	"	"	L	"	"	1			
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#### TABLE III. <u>Group A inspection for device type 06</u> – Continued. Terminal conditions (pins not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open).

			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured	Limit	.s	Un
Subgroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		method	Test no.	U/ D	СК	A	В	С	D	EP	GND	L	ET	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>cc</sub>		Min	Max	
7	Func-	3014	109	B <u>5</u> /	A <u>5</u> /	А	A	А	Α	В	GND	А	В	L	Н	Н	Н	Н	4.5 V				
c = +25°C	tional		110	"	В		u	u	"	и	"	"		u	"	u	Н	u					
	tests		111	"	A		u	u	"	и	"	"		"		u	L	u					
	4/		112	"	В		"	"	"	u	"	"		"		"	L						
			113	"	A			"	"	u	"	"		"	"	L	Н						
			114	"	В			-	"	-	"	и	-	u		u	Н	u					
			115	"	A	**		"	"	и	"	"	"	"		"	L	"					
			116	"	В		u	u	"	-	"			"		"	L						
			117		A		"	"			"	"			L	Н	Н						
			118	"	В		ű	"	"		"			"	"	"	Н			See <u>6</u> /			
			119	"	A		u	u	"	-	"		"	"		"	L		-				
			120	"	В		"	"	"	"	"	"		"		"	L	"					
			121	"	A		"	-	"	-	"	"	"	"	"	L	Н	"					
			122	"	В	"	"	-	"	-	"			"			Н	"	-				
			123	"	A	"		-	"	-	"			u		"	L	L	-				
			124	"	В	"	ű	u	"	A	"			"		"	"						
			125	"	A	"		-	"	A	"	"	"	u	"	ű	"	"					
			126	"	В	"		-	"	В	"		A	"		"		Н					
			127	"	A	"	ű	u	"	-	"		A	"		"	"	Н	-				
			128		В	**			**		"		В			"		L					

#### TABLE III. <u>Group A inspection for device type 06</u> – Continued. Terminal conditions (pins not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open).

			Cases E, F	1	2	3	4	5	6	7	8	9	0.7 V or ope 10	11	12	13	14	15	16	Measured	Lin	nits	Unit
Subgroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		method	Test no.	U/ D	СК	A	В	С	D	EP	GND	L	ET	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>CC</sub>		Min	Max	1
9	t <sub>PLH5</sub>	See	108	5.0 V	IN <u>7</u> /	GND	GND	GND	GND	GND	GND	IN <u>7</u> /	GND				OUT		5.0 V	CK TO Q <sub>A</sub>	3	22	ns
Tc = +25°C		fig. 7	109	"	IN	"	"	u	u	"	"	5.0 V				OUT			"	CK TO Q <sub>B</sub>	"	"	"
		"	110	u	IN 2/	"	"	u	u	"	"	"			OUT				"	CK TO Q <sub>C</sub>	u	"	"
		"	111	"	IN <u>8</u> /	"	"	"	"	"	"	"		OUT					"	CK TO Q <sub>D</sub>	"	"	"
	t <sub>PHL5</sub>	"	112	u	IN <u>7</u> /	5.0 V	"	ű	u	"	"	IN					OUT		"	CK TO Q <sub>A</sub>	"	"	"
		"	113	"	"	"	5.0 V	"	u	"	"	"				OUT			"	CK TO Q <sub>B</sub>	"	"	"
		"	114	"	"	"	u	5.0 V	u	u	u	"			OUT				"	CK TO Q <sub>C</sub>	u	"	"
		"	115	"	"	"	"	"	5.0 V	"	"	"		OUT					"	CK TO Q <sub>D</sub>	"	"	"
	t <sub>PHL15</sub>	"	116	"	"	"	"	"	"	"	"	"						OUT	"	CK TO RC	"	32	"
	t <sub>PLH12</sub>	"	117	"	IN	"	"	u	"	"	"	5.0 V						OUT	"	CK TO RC	"	30	"
	t <sub>PLH5</sub>	"	118	GND	IN <u>9</u> /	IN	GND	GND	GND	"	u	GND					OUT		"	CK TO Q <sub>4</sub>	"	22	"
	t <sub>PHL5</sub>	"	119	"	IN	GND	GND	"	"	"	u						OUT		"	CK TO Q <sub>A</sub>	"	"	"
	t <sub>PLH5</sub>	"	120	"	"	"	5.0 V	"	u	"	"					OUT			"	CK TO Q <sub>B</sub>	и	"	"
	t <sub>PHL5</sub>	"	121	u	"	"	GND	u	u	"	"					OUT			"	CK TO Q <sub>B</sub>	u	"	"
	t <sub>PLH5</sub>	"	122	"	"	"	"	5.0 V	u	"	"				OUT				"	CK TO Q <sub>C</sub>	"	"	"
	t <sub>PHL5</sub>	"	123	"	"	"	"	GND	u	"	"				OUT				"	CK TO Q <sub>C</sub>	"	"	"
	t <sub>PLH5</sub>	"	124	"	"	"	"	"	5.0 V	"	"			OUT					"	CK TO Q <sub>D</sub>	"	"	"
	t <sub>PHL5</sub>	"	125	"	"	"	"	u	GND	"	"			OUT					"	CK TO Q <sub>D</sub>	"	"	"
	t <sub>PHL7</sub>	"	126	5.0 V	IN <u>7</u> /	5.0 V	"	"	5.0 V	"	"	IN	IN					OUT	"	ET to RC	u	24	"
	t <sub>PLH7</sub>	"	127	5.0 V	GND	"	"	u	u	"	"	5.0 V	IN					OUT	"	ET to RC	"	15	"
	t <sub>PHL11</sub>	**	128	IN	IN <u>7</u> /	"	"	"	"	**	"	IN	GND					OUT	"	U/ D to RC	"	28	**
	t <sub>PLH9</sub>	**	129	IN	GND	"	"	"	"	"	"	5.0 V	GND						"	U/D to RC	"	22	u
	t <sub>PHL7</sub>	"	130	GND	IN 7/	GND	"	"	GND	u	"	IN	IN						"	ET to RC	u	24	"
	t <sub>PLH7</sub>	"	131	GND	GND	"	u	u	u	u	"	5.0 V	IN	1	T T	İ 👘	İ 👘		"	ET to RC	"	15	"
	t <sub>PHL11</sub>	"	132	IN	IN <u>7</u> /	"	"	"	"	"	"	IN	GND						"	U/ D to RC	"	28	"
	t <sub>PLH9</sub>	66	133	IN	GND	"	"	"	"	"	"	5.0 V							"	U/ D to RC	"	22	"
	F <sub>MAX</sub> 10/	"	134	5.0 V	IN					"	"	5.0 V		OUT	OUT	OUT	OUT	1	"	CK to Q <sub>n</sub>	25	1	MH
	F <sub>MAX</sub> 10/	"	135	GND	IN					"	"	5.0 V		OUT	OUT	OUT	OUT		u	CK to Q <sub>n</sub>	25	1	MH

#### TABLE III. <u>Group A inspection for device type 05</u>– Continued. Terminal conditions (pins not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open).

See footnotes at end of device types 05 and 06.

			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured	Lim	nits	Un
ubgroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		method	Test no.	U/ D	СК	А	В	С	D	EP	GND	L	ET	QD	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>CC</sub>		Min	Max	1
10	t <sub>PLH5</sub>	See	136															carry		CK TO Q <sub>A</sub>	3	26	
= +125°C	PLH5	fig. 7	130	ł																CK TO Q <sub>A</sub>		"	+
= +125 C		" "	138	ł																CK TO Q <sub>B</sub>			+
		"	139	ł																CK TO QD		"	+
	t <sub>PHL5</sub>	"	140																	CK TO Q <sub>A</sub>	"	"	+
	11125	"	141	1																CK TO Q <sub>B</sub>	"	"	T
		"	142	1																CK TO Q <sub>C</sub>	u	"	T
		"	143																	CK TO Q <sub>D</sub>	"	"	Т
	t <sub>PHL15</sub>	"	144																	CK TO RC	u	37	Т
	t <sub>PLH12</sub>	"	145																	CK TO RC	"	35	T
	t <sub>PLH5</sub>	"	146																	CK TO Q <sub>A</sub>	"	26	+
	t <sub>PHL5</sub>	"	147																	CK TO Q <sub>A</sub>	"	"	t
	t <sub>PLH5</sub>	"	148																	CK TO Q <sub>B</sub>	"	"	t
	t <sub>PHL5</sub>	"	149		Sam	e conditions	s as for sub	group 9.												CK TO Q <sub>B</sub>	u	"	Т
	t <sub>PLH5</sub>	"	150					0 1												CK TO Q <sub>C</sub>	"	"	T
	t <sub>PHL5</sub>	"	151																	CK TO Q <sub>C</sub>	u	"	Т
	t <sub>PLH5</sub>	"	152																	CK TO Q <sub>D</sub>	u	"	
	t <sub>PHL5</sub>	"	153																	CK TO Q <sub>D</sub>	"	"	
	t <sub>PHL7</sub>	"	154																	ET to RC	"	28	
	t <sub>PLH7</sub>	"	155																	ET to RC	u	18	
	t <sub>PHL11</sub>	"	156																	U/ D to RC	"	33	
	t <sub>PLH9</sub>	"	157																	U/ D to RC	"	26	T
	t <sub>PHL7</sub>	"	158																	ET to RC	u	28	t
	t <sub>PLH7</sub>	"	159																	ET to RC	ű	18	
	t <sub>PHL11</sub>	"	160																	U/ D to RC	"	33	
	t <sub>PLH9</sub>	"	161																	U/ D to RC	"	26	t
	F <sub>MAX</sub>	"	162	1																CK to Q <sub>n</sub>	25		T
	FMAX	"	163	1																CK to Q <sub>n</sub>	25		

#### TABLE III. Group A inspection for device type 05– Continued. Terminal conditions (pins not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open).

See footnotes at end of device types 05 and 06.

		MIL-STD-	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured	Lim	its	Unit
Subgroup	Symbol	883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		method	Test no.	U/ D	СК	A	В	С	D	EP	GND	L	ET	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>cc</sub>		Min	Max	
9	t <sub>PLH5</sub>	See	129	5.0 V	IN <u>7</u> /	GND	GND	GND	GND	GND	GND	IN	GND				OUT		5.0 V	CK TO Q <sub>A</sub>	3	22	ns
Tc = +25°C		fig. 7	130	"	"	5.0 V	"	u	u	"	"	"	u			OUT			"	CK TO Q <sub>B</sub>	"	"	"
		"	131	"	**	"	5.0 V	u	u	"	"	"	"	1	OUT				"	CK TO Q <sub>C</sub>	"	"	"
		66	132	"	**	"	"	5.0 V	u	"	"	"	и	OUT					"	CK TO Q <sub>D</sub>	"	"	"
	t <sub>PHL5</sub>	"	133	"	" <u>7</u> /	5.0 V	GND	GND	GND	"	GND	IN	GND				OUT		"	CK TO Q <sub>A</sub>	"	32	"
		"	134	"	"	"	5.0 V	u	"	"	"	"	"			OUT			"	CK TO Q <sub>B</sub>	"	"	"
		"	135	"	"	"	"	5.0 V	u	"	"	"	"		OUT				"	CK TO Q <sub>C</sub>	"	"	"
		66	136	"	"	ű	"	ű	5.0 V	"	"	"	"	OUT					"	CK TO Q <sub>D</sub>	"	"	"
	t <sub>PHL15</sub>	66	137	"	"	GND	"	ű	u	"	"	"	"					OUT	"	CK TO RC	"	35	"
	t <sub>PLH12</sub>	**	138	"	"	GND	"	ű	u	"	u	5.0 V	u					OUT	"	CK TO RC	"	33	"
	t <sub>PLH5</sub>	66	139	GND	"	5.0 V	GND	GND	GND	"	"	5.0 V	"				OUT		"	CK TO Q <sub>A</sub>	"	22	"
	t <sub>PHL5</sub>	"	140	"	"	GND	GND	u	u	"	"	"	ű				OUT		"	CK TO Q <sub>A</sub>	"	32	"
	t <sub>PLH5</sub>	"	141	"	"	"	5.0 V	u	u	"	"	"	u			OUT			"	CK TO Q <sub>B</sub>	66	22	"
	t <sub>PHL5</sub>	"	142	"	"	"	GND	u	u	"	"	"	u			OUT			"	CK TO Q <sub>B</sub>	66	32	"
	t <sub>PLH5</sub>	"	143	"	"	"	"	5.0 V	u	"	"	"	u		OUT				"	CK TO Q <sub>C</sub>	66	22	"
	t <sub>PHL5</sub>	"	144	"	"	"	"	GND	ű	"	"	"	"		OUT				"	CK TO Q <sub>C</sub>	"	32	"
	t <sub>PLH5</sub>	"	145	"	"	"	"	u	5.0 V	"	"	"	"	OUT					"	CK TO Q <sub>D</sub>	"	22	"
	t <sub>PHL5</sub>	"	146	"	"	"	"	"	GND	u	u	"	u	OUT					ű	CK TO Q <sub>D</sub>	"	32	"
	t <sub>PHL7</sub>	"	147	5.0 V	" <u>7</u> /	5.0 V	5.0 V	5.0 V	5.0 V	"	u	5.0 V	IN					OUT	"	ET to RC	"	28	"
	t <sub>PLH7</sub>	"	148	5.0 V	"		"	"	"	"	u	5.0 V	IN					OUT		ET to RC	"	24	
	t <sub>PHL11</sub>	"	149	IN	IN <u>7</u> /	**	"	"	"	"	"	5.0 V	GND					OUT		U/D to RC	"	32	"
	t <sub>PLH9</sub>	66	150	IN	IN	66	"	"	"	"	"	5.0 V	GND					"	"	U/ D to RC	"	28	"
	t <sub>PHL7</sub>	**	151	GND	IN 7/	GND	GND	GND	GND	**	"	5.0 V	IN		1			"	"	ET to RC	66	28	"
	t <sub>PLH7</sub>	"	152	GND	IN	"	"	ű	"	"	"	5.0 V	IN	1				"	"	ET to RC	"	24	"
	t <sub>PHL11</sub>	"	153	IN	IN <u>7</u> /	"	"	"	"	"	"	5.0 V	GND					"	"	U/D to RC	"	32	"
	t <sub>PLH9</sub>	66	154	IN	IN	"	"	"	"	"	"	5.0 V	"					"	"	U/ D to RC	"	22	"
	F <sub>MAX</sub>	66	155	5.0 V	IN	"	"	u	u	"	"	5.0 V	"	OUT	OUT	OUT	OUT		"	CK to Q <sub>n</sub>	25		MHz
	FMAX	66	156	GND	IN	5.0 V	5.0 V	5.0 V	5.0 V	и	"	5.0 V	"	OUT	OUT	OUT	OUT		"	CK to Q <sub>n</sub>	25	1	MHz

#### TABLE III. Group A inspection for device type 06. Terminal conditions (pins not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open).

See footnotes at end of device types 05 and 06.

#### TABLE III. Group A inspection for device type 06. Terminal conditions (pips not designated may be $H \ge 2.0$ V or $L \le 0.7$ V or open)

			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured	Lim	its	Uni
Subgroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	terminal			
		method	Test no.	U/ D	СК	A	В	С	D	EP	GND	L	ET	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>	Ripple carry	V <sub>CC</sub>		Min	Max	
10	t <sub>PLH5</sub>	See	157														1	carry		CK TO Q <sub>A</sub>	3	26	n
; = +125°C	-	fig. 7	158																	CK TO Q <sub>B</sub>	"	"	"
		"	159	ĺ																CK TO Q <sub>C</sub>		"	
		"	160	1																CK TO QD		"	1
	t <sub>PHL5</sub>	"	161																	CK TO Q <sub>A</sub>	ű	36	
		"	162	]																CK TO Q <sub>B</sub>	ű	"	
		"	163	Į																CK TO Q <sub>C</sub>	ű	**	
		"	164																	CK TO Q <sub>D</sub>	u	"	_
	t <sub>PHL15</sub>	"	165																	CK TO RC	"	40	
	t <sub>PLH12</sub>	"	166																	CK TO RC	u	38	
	t <sub>PI H5</sub>	"	167																	CK TO Q <sub>A</sub>	u	26	1
	t <sub>PHL5</sub>	"	168																	CK TO Q <sub>A</sub>	ű	36	
	t <sub>PLH5</sub>	"	169																	CK TO Q <sub>B</sub>	u	26	
	t <sub>PHL5</sub>	"	170		Sam	e condition	s as for sub	group 9.												CK TO Q <sub>B</sub>	ű	36	
	t <sub>PLH5</sub>	"	171																	CK TO Q <sub>C</sub>	"	26	
	t <sub>PHL5</sub>	"	172																	CK TO Q <sub>C</sub>	"	36	
	t <sub>PLH5</sub>	"	173																	CK TO Q <sub>D</sub>	u	26	
	t <sub>PHL5</sub>		174																	CK TO Q <sub>D</sub>	"	36	
	t <sub>PHL7</sub>	"	175																	ET to RC	u	32	_
	t <sub>PLH7</sub>	"	176																	ET to RC	"	28	
	t <sub>PHL11</sub>	"	177																	U/ D to RC	"	37	
	t <sub>PLH9</sub>	"	178																	U/ D to RC	u	32	
	t <sub>PHL7</sub>	"	179																	ET to RC	"	32	
	t <sub>PLH7</sub>	"	180																	ET to RC	"	28	1
	t <sub>PHL11</sub>	"	181																	U/ D to RC	"	37	
	t <sub>PLH9</sub>	"	182																	U/ D to RC	u	32	
	F <sub>MAX</sub>	"	183	1																CK to Q <sub>n</sub>	25		Μ
	FMAX	"	184	1																CK to Q <sub>n</sub>	25	1	M

1/ Case 2, pins not referenced are N/C.

<u>2</u>/ Apply one clock pulse prior to test as follows:

 $\underline{3}$ / I<sub>IL</sub> limits (µA) min/max values for circuits shown:

Parameter	Terminals				Circuits			
		А	В	С	D	Е	F	G
I <sub>IL12</sub>	A, B, C, D			-160/-400		-0.5/-400		
I <sub>IL13</sub>	U/ D , CK, L			-160/-400		-135/-370		
I <sub>IL14</sub>	EP			160/-400		-150/-385		
I <sub>IL15</sub>	ET			-140/-720		-280/-760		

- 4/ Only a summary of attributes data is required.
  - 5/ A = 3.0 V minimum; B = 0.0 V or GND.
  - <u>6</u>/ H > 1.5 V; L < 1.5 V; X = don't care.
  - <u>7</u>/ Apply one clock pulse with "L" low prior to test.
  - <u>8</u>/ Apply three clock pulses prior to test.
  - 9/ Apply one clock pulse with "A" low prior to test.
  - $\underline{10}\prime~$  On (QA, QB, QC, and QD) shall respond as specified in the truth table with the minimum  $F_{MAX}$  frequency input to "CK".

		MIL STD	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	I	Lir	mits	
ubgroup	Symbol	MIL-STD- 883 method	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15 Dianta	17	18	19	20	Measured			Un
			Test no.	В	Q <sub>B</sub>	Q <sub>A</sub>	Count down	Count Up	Q <sub>C</sub>	Q <sub>D</sub>	GND	D	С	Load	Ripple Carry	Borrow	Clear	A	V <sub>CC</sub>	terminal	Min	Max	
1	Vol	3007	1			4 mA					GND			0.7 V			0.7 V	0.7 V	4.5 V	Q <sub>A</sub>		0.4	V
= +25°C			2	0.7 V	4 mA						"			ű			u		"	Q <sub>B</sub>			
			3						4 mA				0.7 V	u			u			Q <sub>C</sub>	L'	<u> </u>	
			4							4 mA		0.7 V		u			"			QD	L'	<u> </u>	
		**	5	<u>2</u> /				0.7 V				2.0 V	<u>2</u> /	"	4 mA		"	2.0 V	4.5 V	Ripple carry	1	"	
		**	6				0.7 V									4 mA	2.0 V		4.5 V	Borrow	í i	"	
	V <sub>OH</sub>	3006	7			-0.4 mA								0.7 V			0.7 V	2.0 V		Q <sub>A</sub>	2.5		
			8	2.0 V	-0.4 mA									u			u			Q <sub>B</sub>	"		
		"	9						-0.4 mA		"		2.0 V	"			"			Qc	"		
		**	10							-0.4 mA		2.0 V		"			"			QD	"		
		"	11					2.0 V							-0.4 mA		u			Ripple	"		
																				Carry			
		"	12				2.0 V									-0.4 mA				Borrow	"		
	VIC		13															-18 mA		A		-1.5	
			14	-18 mA							"								=	В			
			15										-18 mA						-	С		"	
			16								"	-18 mA							"	D		"	
			17								"			-18 mA					u	Load		"	
			18								"						-18 mA		ű	Clear		"	
			19					-18 mA			"								4	Count up		"	
			20				-18 mA				"								66	Count down		"	
	I <sub>IL9</sub>	3009	21								"			GND			GND	0.4 V	5.5 V	A	3/	3/	μ
	-123	"	22	0.4 V							"			"			"		"	В	"	"	P
		"	23	0.1.1							"		0.4 V	u			"		"	C	u	"	1
		"	24								"	0.4 V		u			"		"	D	u	"	1
	I <sub>IL10</sub>	"	25								"			0.4 V					"	Load	"	"	1
	I <sub>IL11</sub>	"	26								"						0.4 V		"	Clear	"	"	+
	1611	"	27					0.4 V			"						0		"	Count up	"	"	<u> </u>
		"	28				0.4 V	0.1 1			"								"	Count	"	"	
		3010	29								"			5.5 V			5.5 V	2.7 V	"	down	'	20	+
	I <sub>IH17</sub>	3010	29	2.7 V	+	ł		<del> </del>	<del> </del>	<del> </del>	"	<del> </del>	<u> </u>	5.5 V "	+		5.5 V "	2.1 V	"	A B	'	20	
	1	u	30	2.1 V		t	-	<u> </u>	<u> </u>	<u> </u>	"	t	2.7 V	u			и		"	C	<u> </u>	"	├
		**	32		+	<u> </u>		<del> </del>	<del> </del>	<del> </del>	"	2.7 V	2.1 V	u	+		u		"	D	'	"	┼──
		"	33		-						"	2.1 V		2.7 V					"	Load	ļ'	"	1
		"	34		-						"			2.1 V			2.7 V		"	Clear	ļ'	"	+
		"	35					2.7 V			"						2.1 V		"	Count up	'	"	
		"	36				2.7 V	2.7 V			"								"	Count	'	"	-
							2.7 V													down			
	I <sub>IH18</sub>	"	37		L						"			5.5 V			5.5 V	5.5 V	"	A	Ļ'	100	<u> </u>
		"	38	5.5 V					ļ		"	ļ	L	"			"		"	В	<b> </b>	"	<u> </u>
		"	39								"		5.5 V	u			"		"	С	Ļ'	"	<u> </u>
		"	40								"	5.5 V		u			u		"	D	<b> </b> '	"	1
		"	41								"			"					"	Load	Ļ'	"	
		"	42		L						"						5.5 V		"	Clear	Ļ'	"	<u> </u>
		"	43		L			5.5 V			"								"	Count up	Ļ'	"	
		"	44				5.5 V				"								"	Count down	1	"	

TABLE III. <u>Group A inspection for device types 07 and 08.</u> Terminal conditions (pins not designated may be  $H \ge 2.0 \text{ V}$ ; or  $L \le 0.7 \text{ V}$ ; or open).

							16111			not doolg	nutou mu	y be n ≞ <b>z</b> .		≥ 0.7 V; OI	open).								
			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Lii	mits	
Subgroup	Symbol	883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit
		method	Test no.	В	Q <sub>B</sub>	Q <sub>A</sub>	Count down	Count Up	Q <sub>C</sub>	Q <sub>D</sub>	GND	D	С	Load	Ripple Carry	Borrow	Clear	A	V <sub>cc</sub>	terminal	Min	Max	
1	los	3011	45			GND					GND			GND			GND	5.5 V	5.5 V	Q <sub>A</sub>	4/	<u>4</u> /	mA
Γc = +25°C			46	5.5 V	GND															Q <sub>B</sub>	"		
			47						GND				5.5 V	"			"		"	Q <sub>C</sub>	"	"	"
			48							GND		5.5 V		"						QD	"		
		**	49					5.5 V							GND					Ripple carry	"	"	
		"	50				5.5 V									GND				Borrow	"	"	
	Icc	3005	51											GND			GND			V <sub>cc</sub>		34	
2	Same te	sts, termin	al conditions	, and limit	s as for s	ubgroup	1, excep	ot $T_c = +$	125°C a	nd V <sub>IC</sub> te	sts are o	omitted.											
3	Same te	sts, termin	al conditions	, and limit	s as for s	ubgroup	1, excep	ot T <sub>C</sub> = -	55°C and	d V <sub>IC</sub> test	s are on	nitted.											

#### TABLE III. <u>Group A inspection for device types 07 and 08</u> – Continued. Terminal conditions (pins not designated may be $H \ge 2.0$ V; or $L \le 0.7$ V; or open).

	1											ay be $H \ge 2$ .				10	<u> </u>						<b>—</b>
1 '		MIL-STD-	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Li	mits	_
Subgroup	Symbol	883 method	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit
			Test no.	В	Q <sub>B</sub>	Q <sub>A</sub>	Count down	Count Up	Q <sub>C</sub>	Q <sub>D</sub>	GND	D	С	Load	Ripple Carry	Borrow	Clear	A	V <sub>CC</sub>	terminal	Min	Max	
	Func-	3014	52	A <u>6</u> /	L	L	A	A	L	L	GND	A	A	A	Н	Н	A	A	4.5 V				
Fc = +25°C	tional		53			L	"	A	"	"		"	"		"	"	В <u>6</u> /		"				
	tests		54			L	"	В	"	"	"	"	-	-	"			-					
1 '	<u>5</u> /		55			Н	"	A	"	"					"		"		"				
1 '		**	56		=	Н	"	В	"	"		"	"		"	"	"						
1 '		**	57		H	L	"	А	"	"		"	"		"		"						
1 '		**	58		=	L	"	В	"	"		"	"		"	"	"						
			59		=	Н	"	А	"	"		"	"		"		"						
		"	60		=	Н	"	В	"	"		"	"	-	"	"	"	"	"				
1		"	61		L	L	"	Α	Н	"		"	-	-	"	"	"	-					
		"	62			L	"	В	"	"		"	"		"	"	"	"	"				
1		"	63			Н	"	А	"	"		"	"		"	"							
			64	u		Н	"	В	"	"		"		"	"		"	"		J			
			65	"	H	L	"	А	"	"		"		"	"		"	"		J			
1 1			66			L	"	В	"	"		"	"	"	"			"					
1 '			67			Н	"	Α	"	"	"	"	"	"	"	"	"	"	"	1			
1 '			68		-	Н	"	В	"	"		"	"	"	"	"	"	"	"	1			
1 1			69		L	L	"	Α	L	Н		"	"	"	"	"		"					
			70		-	L	"	В	"	"		"	"	"	"	"	"	"	"	1			
1			71		-	Н	"	А	"	"		"	"	"	"	"	"	"		1			
			72			Н	"	В	"	"		"	"	"	L				"	1			
1		66	73		-	L	"	Α	"	L		"	"	"	Н	"	"	"		1			
1 '		"	74			L	В		"	L		"	"	"	"	L		"	"	1			
1 1		"	75	"		Н	Α	"	"	Н		"	"	"	"	Н		"		1			
1 '		"	76			Н	В		"	"		"		"	"	Н		"		1			
1 '		"	77			L	Α		"	"		"	"	"	"			"	"	See <u>7</u> /			
1 1		"	78			L	В	"	"	"		"	"	"	"	"		"		1 - '			
1 '		"	79		Н	Н	Α		Н	L		"		"	"			"		1			
1 '		"	80			Н	В		"	"		"	"		"					1			
1 '		"	81		-	L	Ā	"	"	"		"	"	"	"	"	"	"	"	1			
1 '		"	82			L	B		"	"		"			"					1			
		"	83		L	H	A		"	"		"			"					1			
1 '		"	84			Н	В	"	"	"		"	"	"	"	"	"	"	"	1			
1 '		"	85			L	A		"	"		"			"					1			
		"	86			L	В		"	"		"			"			"		1			
		"	87		Н	H	A		L	"		"			"					1			
1 1		"	88			H	В		"	"		"	"	"	"	"							
1 '		"	89			L	A		"	"		"			"					1			
		"	90			Ē	В		"	"		"			"					1			
1		66	91		L	H	Ā	"	"	"		"	"	"	"	"		"					
1 1		66	92		-	H	B		"	"		"						"		1			
1 '		"	93	"		L	A		"	"		"		"	"		"	"		1			
1 1		"	94			L	В		"	"		"				L				1			
1	1		95			H	A		"	Н		"	"		"	H		"		1 '		1	1
1			96		н	Н			н	Н		"		В	"					1 '			
1 '			97		L	L			L	L		"	-	"	"		А			1 '			
1 '			98		H	H			H	H		"					B			1 '			
1 '	1		98		Н	Н			Н	Н				A			B			1 '		1	1
		1					<u> </u>	<del> </del>				<u>↓</u>	<u>↓</u>					<b></b>	<del> </del>	4 '	1	1	1
! .		"	100		L	L			L	L							A						

TABLE III. <u>Group A inspection for device types 07</u> – Continued. Terminal conditions (pins not designated may be  $H \ge 2.0$  V; or  $L \le 0.7$  V; or open).

See footnotes at end of device types 07 and 08.

		MIL-STD-	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Lir	nits	
Subgroup	Symbol	883 method	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit
			Test no.	В	Q <sub>B</sub>	Q <sub>A</sub>	Count down	Count Up	Q <sub>C</sub>	Q <sub>D</sub>	GND	D	С	Load	Ripple Carry	Borrow	Clear	A	V <sub>cc</sub>	terminal	Min	Max	
7	Func-	3014	102	A <u>6</u> /	Н	Н	Α	A	Н	Н	GND	A	A	B <u>6</u> /	Н	Н	В	Α	4.5 V				
c = +25°C	tional		103	А			"		"	"	-	A	А	A	"	"		Α					
	tests		104	В	"	"	"	"	"	"		В	В	A	"	"	"	В	"	1			
	5/		105		L	L	"	"	L	L		"	"	В	"	"	"		"	1			
		"	106				В		"	"		"			"	L			"				
		"	107				Α		"	"		"			"	Н			"				
		"	108				"	В	"	"	-	"	"		"	"				See <u>7</u> /			
		-	109		-		"	Α	=	"	-	-		=	-	"	-	-	-				
		"	110			-	"	-	=	"		=	=	А	=	"		=	-				
		"	111				"		-	"		=	-	-	=		Α	=					
		"	112				В		-	"		=	-	-	=	L		=					
		"	113		-		Α	-	=	"	-	-		=	-	Н	-	-	-				
		-	114	"			A	В	-	"	-	-	-	-	-			-	-	]			
			115				A	A	"	"		"			"								

# TABLE III. Group A inspection for device types 07 - Continued.

Te

							Termina	il conditior	ns (pins n	ot designa	ated may I	be high $\geq 2$ .	0 V; or lov	$v \le 0.7 V;$	or open).								
			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Li	mits	
Subgroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit
		method	Test no.	В	Q <sub>B</sub>	Q <sub>A</sub>	Count down	Count Up	Q <sub>C</sub>	QD	GND	D	С	Load	Ripple Carry	Borrow	Clear	A	V <sub>CC</sub>	terminal	Min	Max	
7	Func-	3014	52	В <u>6</u> /	L	L	A <u>6</u> /	Å	L	L	GND	В	В	В	Н	Н	В	В	4.5 V				
Fc = +25°C			53			L	"	"	-		"	"	"	Α	"		"	В					
	tests		54	"		Н	"		-	"	"	"		В	"		"	А					
	5/		55			H	"		"	"	"	"		Ā				A		-			
		"	56	А	Н	L	"		"	"		"	"	В			"	В					
		"	57	"		Ĺ	"		"	"	"		"	Ā	"		"	В					
		"	58			H	"		"	"				B	"			A					
			59			Н	"		"	"				A	"			A					
		"	60	В	L	L	"		Н	"		"	А	В	"	"	"	В		-			
		"	61	"		Ē	"		"	"		"	"	A	"	"	"	B		-			
		"	62			H	"		"	"		"		B	"			A					
		"	63			Н	"		"	"		"		Ā	"			A					
			64	А	Н	L	"		"	"		"		B	"			В					
			65	"		Ē	"		"	"	"	"		A	"		"	B		1			
	1	"	66	"		H	"		"	"	"	"		B	"		"	A		1	1		
			67	"		Н	"		"	"	"	"		A	"		"	A		1			
	1	"	68	В	L	L	"		L	Н	"	Α	В	В	"		"	В		1	1		
			69		-	L	"		"	"	"	"	"	A	"		"	B		1			
			70			Ĥ	"		"	"		"		B	"	"	"	Ā					
			71			Н	"		"	"		"		Α	"	"	"	A					
		"	72	A	Н	L	"		"	"		"		В	"			В					
		"	73	"		L	"		"	"		"		Α	"			В					
		"	74	"		Н	"		"	"		"		В	"			Α					
		"	75	"		Н	"		"	"		"	"	Α	"	"	"	А					
		"	76	В	L	L	"		Н	"		"	А	В	"			В		1			
		"	77			L	"	"		"	"	"	"	Α	"	"	"	В		See <u>7</u> /			
		"	78			Н	"		-	"		"		В	"	"	"	Α		1 –			
		"	79			Н	"	"	"	"	"	"	"	Α	"	"	"	А		1			
		"	80	A	Н	L	"	"	"	"	"	"	"	В	"	"	"	В		1			
		"	81	"		L	"		"	"		"	"	A	"			В					
		"	82	"		Н	"		"	"		"	"	В	"			A					
		"	83		L	L	"		L	L		"		В	"		Α		-				
		"	84				"	-	"				-	Α	"	-	Α		-				
		"	85				"			"		"			"		В						
		"	86			"	В		"	"	"	"			"	L	"	"					
		"	87		Н	Н	A		Н	Н	"	"			"	Н	"	"					
		"	88			Н	В		"	"	"	"			"		"	"					
1		"	89	"		L	A			"	"	"			"		"	"					
1	1	"	90	"		L	В			"							"	"		4	1		
1	1	"	91	"	L	н	A			"		"	"		"		"	"		4	1		
1		"	92	"		н	B													-			
1		"	93	"		L	A													-			
1	1		94			L	B			<u> </u>										-	1		
1			95		H	н	A		L "											-			
1			96			Н	B													-			
			97			L	A													-			
			98			L	B													-			
1		"	99 100			Н	A													-			
1			100			H	B	"				"			"					-			
	1		101			L	A													-	1		
	1		102			L	B													-	1		
					H	H	A		H	L "										-			
1			104 105			H	B A					"								-			
1			105			L	B		"			"								-			
	1		106		1	L H	A		"						"					-	1		
L	1	I	107	1	L		~			I	1	I		L	I					1	1	I	

See footnotes at end of device types 07 and 08.

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			Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Lin	nits	
ogroup	Symbol	MIL-STD- 883	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			L
		method	Test no.	В	Q <sub>B</sub>	Q <sub>A</sub>	Count down	Count Up	Q <sub>C</sub>	QD	GND	D	С	Load	Ripple Carry	Borrow	Clear	А	V <sub>CC</sub>	terminal	Min	Max	
7	Func-	3014	108	A <u>6</u> /	L	Н	B <u>6</u> /	A	Н	L	GND	А	А	А	H	Н	В <u>8</u> /	А	4.5 V				+
, +25°C		"	109	"		L	A .	"	"	"	"	"	"	"	"		"	"	4.0 V				
	tests		110	"		L	B		"	"							"						
	<u>5</u> /		111		Н	Ĥ	A		L	"		"			"								
		"	112		"	H	В		"	"		"			"								
		"	113			L	Ā		"	"		"			"								
		"	114		-	L	В				-		-						"				
			115	"	L	Ĥ	Ā			"			-		"		"		"				
		"	116	"		Н	В			"			-		"		"		"				
		"	117	"		L	Α		"	"		"			"		"		"	1			
		"	118		-	L	"	В			-		-						"				
		"	119			Н	"	Α	"	"		"			"		"		"	1			
			120			Н	"	В	"	"		"			"		"		"	1			
			121	"	Н	L	"	Α	"	"		"			"		"		"	1			
			122	"		L	"	В	"	"		"			"		"		"	1			
			123			Н	"	Α	"	"		"			"		"		"	1			
			124			Н	"	В	"	"		"			"		"		"	1			
			125		L	L	"	Α	Н	-	-		-	"			"		"				
			126		-	L	"	В	-	-	-	-	-	"	-		"		"				
			127		-	Н	"	Α	-	-	-	-	-	"	-		"		"				
			128	"		Н	"	В	"	"		"	"		"		"			1			
		"	129	-	Н	L	"	Α	-	-	-	-	-	"	-								
		**	130		-	L	"	В	-	-	-	-	-	"	-		"		"				
		**	131	"	-	Н	"	Α	-	-	-	-	-	"	-		"		"				
		**	132			Н	"	В	"	"		"			"		"		"				
		"	133	"	L	L	"	Α	L	Н					"		"		"	See <u>7</u> /			
		"	134	"		L	"	В	-	"	-		-	"	"	"	"	"	"	1 –			
		"	135	"		Н	"	Α	-	"	-		-	"	"	"	"	"	"	1			
		**	136			Н	"	В	"	"		"			"		"						
		"	137		Н	L	"	A	"	"		"			"								
		"	138			L	"	В	"	"		"			"								
		"	139		=	Н	"	Α	=	=	=	-	=	-	-			"	-				
		"	140	-	=	Н	"	В	=	=	=	=	=		=		"		-				
		"	141		L	L	"	A	Т	=	=	=	=		-		"		"				
		"	142		-	L	"	В	-	-	-	-	-		-		"						
		"	143		-	Н	"	A		-				-	-								
		"	144			Н	"	В	"	-													
		"	145		Н	L	"	Α	"	"									"				1
		"	146	"		L	"	В	"	"		"			"								
		"	147		-	Н	"	Α		-							"		"				1
		"	148		-	Н	"	В		-	=	=			L		"		"				
		"	149	"	L	L	"	A	L	L			-		Н		"		"				
		u	150				"	A	"	-		"			"		A		"				1
			151	"			"	В	"	"		"					"						
			152		-		"	A	"	-		-	-		-	"	"	"	"				
			153		-		В			"			-			L	"		"				1
			154				A		"	-		"			"	Н			"				
			155	"			"		"	"		"					В						
		ű	156	-	Н	Н	"	-	Н	Н		"	-	В	=								
			157		-		-	В		"			-		L		"		-				1
			158	"	-	"	"	A		"			-		H	"	"		"				
		"	159		-		В	Α		-					-		"						
			160				Α	A		"					"					1			

TABLE III. Group A inspection for device types 08 – Continued. Terminal conditions (pins not designated may be  $H \ge 2.0$  V; or  $L \le 0.7$  V; or open).

								Termi	nal condi	tions (pin:	s not des	ignated m	nay be hig	h ≥ 2.0 V	; or low ≤	0.7 V; or	open).							
		MIL-STD-	Cas E,		1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Lir	nits	
Subgroup	Symbol	883 method	Case	e <u>1</u> /	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit
		method	(Dev typ	/ice	В	Q <sub>B</sub>	Q <sub>A</sub>	Count	Count	Q <sub>c</sub>	Q <sub>D</sub>	GND	D	С	Load	Ripple	Borrow	Clear	А	V <sub>cc</sub>	terminal	Min	Max	
			07					down	up							carry								
9 Tc = +25°C	F <sub>MAX</sub> <u>8</u> /	3003 <u>9</u> /	116	161			OUT	5.0 V	IN			GND			5.0 V			GND		5.0 V	Count up to $Q_A$	22		MHz
	F <sub>MAX</sub> <u>8</u> /		117	162			OUT	IN	5.0 V						5.0 V			GND			Count down to $Q_A$	22		MHz
	t <sub>PLH8</sub>		118	163			OUT					"			IN			GND	5.0 V	"	Load to Q <sub>A</sub>	3	45	ns
			119	164	5.0 V	OUT						"			u			"		"	Load to Q <sub>B</sub>		"	
		**	120	165						OUT		"		5.0 V	"			"		"	Load to Q <sub>C</sub>	"	"	
		**	121	166							OUT	"	5.0 V	"	u			"		"	Load to Q <sub>D</sub>			
	t <sub>PHL10</sub>		122	167			OUT					"			u			GND	GND	"	Load to Q <sub>A</sub>		"	
	111210	"	123	168	GND	OUT						"			u			"		"	Load to Q <sub>B</sub>	"	"	
		**	124	169						OUT		"		GND	u			"		"	Load to Q <sub>C</sub>	"	"	
		**	125	170							OUT	"	GND		u			"		"	Load to Q <sub>D</sub>	"	"	**
	t <sub>PLH9</sub>	**	126	171			OUT	5.0 V	IN			"			5.0 V			"		"	Count up to Q <sub>A</sub>	"	43	"
		**	127	172		OUT		"	"			"			"			"		"	Count up to Q <sub>B</sub>	"	"	"
		**	128	173				"	"	OUT		"			"			"		"	Count up to Q <sub>C</sub>	"	"	**
		**	129	174				"	"		OUT	"			"			"		"	Count up to Q <sub>D</sub>	"	"	
		**	130	175				IN	5.0 V		OUT	"			"			"		"	Count down to Q <sub>D</sub>	"	"	
		**	131	176				"	"	OUT		"			"			"		"	Count down to Q <sub>C</sub>	"	"	"
		**	132	177		OUT		"	"			"			"			"		"	Count down to Q <sub>B</sub>	"	"	"
		**	133	178			OUT	"	"			"			"			"		"	Count down to Q <sub>A</sub>	"	"	"
	t <sub>PHL11</sub>	**	134	179			OUT	5.0 V	IN			"			"			"		"	Count up to Q <sub>A</sub>	"	52	"
			135	180		OUT		"	"			"			u			"		"	Count up to Q <sub>B</sub>	"	u	
			136	181				"	"	OUT		"			"			"		"	Count up to Q <sub>C</sub>	"	"	"
			137	182				"	"		OUT	"			"			"		"	Count up to Q <sub>D</sub>	"	"	"
			138	183				IN	5.0 V		OUT	"			"			"		"	Count down to Q <sub>D</sub>	"	u	"
		"	139	184				"	"	OUT		"			"			"		"	Count down to Q <sub>C</sub>	"	"	**
		"	140	185		OUT		"	"			"			"			"		"	Count down to Q <sub>B</sub>	"	"	"
		"	141	186			OUT	"	"			"			"			"		"	Count down to Q <sub>A</sub>	"	"	"
	t <sub>PHL12</sub>	"	142	187			OUT					"			<u>10</u> /			IN	5.0 V	"	Clear to Q <sub>A</sub>	"	40	"
		"	143	188	5.0 V	OUT						"			"			"		"	Clear to Q <sub>B</sub>	"	"	"
		"	144	189						OUT		"		5.0 V	"			"		"	Clear to Q <sub>C</sub>	"	"	**
		**	145	190							OUT	"	5.0 V		u			"		"	Clear to Q <sub>D</sub>	"	"	"

### TABLE III. Group A inspection for device types 07 and 08 - Continued.

See footnotes at end of device types 07 and 08.

Subgroup	Symbol		Ε,	F			3	4	5	6	7	8	9	10	11	12	13	14	15	16		L11	nits	
	Symbol	MIL-STD- 883 method	Case 2		2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit
		metriod	(Dev type	rice	В	Q <sub>B</sub>	Q <sub>A</sub>	Count down	Count up	Qc	QD	GND	D	С	Load	Ripple carry	Borrow	Clear	A	V <sub>cc</sub>	terminal	Min	Max	
9 Tc = +25°C	F <sub>MAX</sub> <u>8</u> /	3003 <u>9</u> /		191																	Count up to $Q_A$	22		MHz
	F <sub>MAX</sub> <u>8</u> /	"	147	192																	Count down to $Q_A$	22		MHz
	t <sub>PLH8</sub>		148	193																	Load to Q <sub>A</sub>	3	63	ns
			149	194																	Load to Q <sub>B</sub>	-	"	
		"		195																	Load to Q <sub>C</sub>	"	"	
		"	151	196																	Load to Q <sub>D</sub>		"	
	t <sub>PHL10</sub>			197																	Load to Q <sub>A</sub>		"	
		"		198																	Load to Q <sub>B</sub>	"	u	
		"		199																	Load to Q <sub>C</sub>	"	ű	
		"	155	200																	Load to Q <sub>D</sub>	"	u	"
	t <sub>PLH9</sub>	"		201																	Count up to Q <sub>A</sub>		60	
		66		202	_																Count up to Q <sub>B</sub>		"	
		66	158	203	Sa	ame termii	nal conditi	ons as fo	r subgrou	ıp 9.											Count up to Q <sub>C</sub>		"	"
		66	159	204																	Count up to Q <sub>D</sub>		"	
		66	160	205 206																	Count down to Q <sub>D</sub>		"	
		"	161	206																	Count down to Q <sub>C</sub>		"	
		44	162	207																	Count down to Q <sub>B</sub>		"	
		"		208																	Count down to Q <sub>A</sub>		"	
	t <sub>PHL11</sub>	"		209																	Count up to Q <sub>A</sub>	"	73	
			165	210																	Count up to Q <sub>B</sub>	"	u	
			166	211																	Count up to Q <sub>C</sub>	"	"	"
				212																	Count up to Q <sub>D</sub>	"	"	"
			168	213																	Count down to Q <sub>D</sub>	"	u	"
		66	169	214																	Count down to Q <sub>C</sub>	"	"	"
		66	170	215																	Count down to Q <sub>B</sub>	"	"	"
		66	171	216																	Count down to Q <sub>A</sub>	"	"	"
ļ	t <sub>PHL12</sub>	66	172	217																	Clear to Q <sub>A</sub>	"	56	"
		**	173	218																	Clear to Q <sub>B</sub>	"	"	"
		"		219																	Clear to Q <sub>C</sub>	"	u	"
		**		220																	Clear to Q <sub>D</sub>	"	"	"

# TABLE III. <u>Group A inspection for device types 07 and 08</u> – Continued. Terminal conditions (pins not designated may be high $\geq$ 2.0 V; or low $\leq$ 0.7 V; or open).

See footnotes at end of device types 07 and 08.

- 1/ Case 2, pins not referenced are N/C.
- 2/ Apply 0.7 V for device type 07; apply 2.0 V for device type 08.
- <u>3</u>/  $I_{IL}$  limits (µA) min/max values for circuits shown:

Parameter	Terminals				Circuits			
- arameter	1 offinitato	А	В	С	D	E	F	G
		-160/-400	-160/-400	-160/-400	-100/-340	-100/-340	-120/-360	-135/-370
I <sub>IL9</sub>	А	**	"	"	"	"	"	"
	В	66	66	"	"	66	"	**
	С	66	66	"	"	66	"	"
	D	66	**	"	"	66	"	"
I <sub>IL10</sub>	Load	-100/-340	"	-150/-380	-120/-360	-120/-360	"	-100/-340
	Clear	-160/-400	"	-150/-380	"	**	"	-135/-370
I <sub>IL11</sub>	Count up	**	"	"	"	**	"	"
	Count down	"	"	"	"	"	"	"

4/ Ios limits (mA) min/max values for circuits shown: -15/-100 for circuits A, C, D, E, F, and G and -15/-110 for circuit B.

- 5/ Only a summary of attributes data is required.
- $\underline{6}$ / A = 3.0 V minimum; B = 0.0 V or GND.
- $\underline{7}/\quad$  H > 1.5 V; L < 1.5 V; X = don't care.
- 8/ F<sub>MAX</sub> minimum limit specified is the frequency of the input pulse. The output frequency shall be one-half of the input frequency.
- $\underline{9}/$  See figure 8 for device type 07 and figure 9 for device type 08.
- 10/ Apply momentary GND, then 4.5 V minimum prior to input pulses. Maintain 4.5 V minimum for measurement.

	1	r	Cases E, F	1	2	3	4	5	6		gnated m 8	aybeH≥2 9	2.0 V; OF L 10	. <u>≤0.7 v;o</u> 11	12 12	13	14	15	16	1	Lir	nits	
Subgroup	Symbol	MIL-STD-	Cases E, F Cases1/	2	2	4	4 5	5 7	8	9	10	9 12	10	14	12	13	14	15	20	Measured	LII	niits	Unit
0		883 method	2 Test no.	В	Q <sub>B</sub>	Q₄	Enable	Down/	Q <sub>c</sub>	Q <sub>D</sub>	GND	D	с	Load	Max/	Ripple	Clock	A	V <sub>cc</sub>	terminal	Min	Max	
4	V	0007	10011101			∽A	G	up	<b>∽</b> ∪	ςD	-	-	, ,		Min	carry	Clock			-		0.4	
1	V <sub>OL</sub>	3007	1	0.7 V	4 mA	4 mA					GND "			0.7 V "				0.7 V	4.5 V	Q <sub>B</sub>		0.4	V
c = +25°C						4 MA			4				0.7 V	"				0.7 V		Q <sub>A</sub> Q <sub>C</sub>			
			3						4 mA	4 mA		0.7 V	0.7 V	"						Q <sub>C</sub>			
		"	4 5	2.0 V				2.0 V		4 MA		0.7 V		"	4 mA				"	Max/Min		"	
		"	6	2.0 V			0.7 V	2.0 V 0.7 V				2.0 V	2/	"	4 MA	4 mA	0.7 V	2.0 V	"	Ripple carry		"	
	V <sub>OH</sub>	3006	6	2.0 V	-0.4 mA		0.7 V	0.7 V				2.0 V	<u></u>	u		4 MA	0.7 V	2.0 V			2.5 V		
	YOH	"	8	2.0 V	-0.4 11/4	-0.4 mA								и				2.0 V		Q <sub>A</sub>	2.5 V "		
		"	9			0.4 110 (			-0.4 mA				2.0 V	u				2.0 V		Q <sub>C</sub>	"		
		"	10						0.4 110 (	-0.4 mA		2.0 V	2.0 V	u							"		
		"	11	0.7 V				2.0 V		0		0.7 V	0.7 V	u	-0.4 mA			0.7 V	"	Max/Min	"		
		"	12	0.1 1			2.0 V	2.0 1				0.1 1	0	u	0	-0.4 mA		0	"	Ripple carry	"		
	VIC		13	-18 mA							-								-	В		-1.5 V	"
	10		14				-18 mA												"	Enable G		"	
			15					-18 mA												Down/up		"	"
			16								**	-18 mA			1				"	D		"	"
			17								"		-18 mA						"	С		"	"
			18								"			-18 mA					"	Load		"	"
			19								"						-18 mA		"	Clock		"	"
			20								"							-18 mA	"	A		"	
	I <sub>IL7</sub>	3009	21				0.4 V	5.5 V			"								5.5 V	Enable G	<u>3</u> /	<u>3</u> /	μA
	I <sub>IL8</sub>	"	22	0.4 V							"			GND					"	В	"	"	"
		"	23					0.4 V			"								"	Down/up	"	"	"
		"	24								"	0.4 V		u					"	D	"	"	"
		"	25								"		0.4 V	"					"	С	"	"	"
		"	26								"			0.4 V					"	Load	"	"	"
		"	27								"						0.4 V		u	Clock	"	"	"
		"	28								"			GND				0.4 V	"	A	"	"	"
	I <sub>IH15</sub>	3010	29				2.7 V													Enable G		60	"
	I <sub>IH16</sub>	"	30				5.5 V				"								"	Enable G		300	"
	I <sub>IH17</sub>	"	31	2.7 V							"			5.5 V					"	В		20	"
		"	32					2.7 V			"								"	Down/up		"	"
		"	33								"	2.7 V	L	5.5 V					"	D		"	"
		"	34								"		2.7 V	5.5 V					"	С		"	"
		"	35				ļ				"	ļ		2.7 V	ļ				"	Load		"	"
		"	36								"	L					2.7 V		"	Clock		"	"
	I	"	37								"	I		5.5 V	I			2.7 V	"	A		"	"

#### TABLE III. Group A inspection for device types 09 and 13 – Continued. Terminal conditions (pins not designated may be H > 2.0 V; or L < 0.7 V; or open).

See footnotes at end of device types 09 and 13.

							16111	inai conu	nions (pin	5 1101 0631	ynaleu m	ay be li ≤ z		$\leq 0.7 \text{ V}; 0$	r open).								
		MIL-STD-	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Lir	nits	1
Subgroup	Symbol	883 method	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit
			Test no.	В	Q <sub>B</sub>	Q <sub>A</sub>	Enable G	Down/ Up	Q <sub>c</sub>	Q <sub>D</sub>	GND	D	С	Load	Max/ Min	Ripple Carry	Clock	А	V <sub>CC</sub>	terminal	Min	Max	
1	I <sub>IH18</sub>	3010	38	5.5 V							GND			5.5 V					5.5 V	В		100	μΑ
Гс = +25°С		"	39					5.5 V												Down/up			"
			40									5.5 V		5.5 V						D		-	"
		"	41										5.5 V							С			-
		"	42											u					-	Load		u	
		"	43														5.5 V			Clock		ű	
		"	44								u			5.5 V				5.5 V	"	A		ű	"
	los	3011	45	5.5 V	GND						u			GND					"	Q <sub>B</sub>	4/	<u>4</u> /	mA
		"	46			GND					u			"				5.5 V	"	Q <sub>A</sub>	"	"	"
		"	47						GND		u		5.5 V	"					"	Q <sub>C</sub>	"	u	ű
		"	48							GND	u	5.5 V		"					"	Q <sub>D</sub>	"	ű	ű
		"	49	GND				5.5 V			u	GND	GND	u	GND			GND	"	Max/Min	u	u	"
		"	50				5.5 V				u					GND			"	Ripple carry	"	ű	ű
	Icc	3005	51	GND			GND	GND				GND	GND	GND			GND	GND		V <sub>CC</sub>		35	"
2	Same te	sts, termin	al conditions	, and limit	s as for s	ubgroup	1, excep	ot $T_C = +$	125°C a	nd V <sub>IC</sub> te	sts are o	mitted.											
3	Same te	sts, termin	al conditions	, and limit	s as for s	ubgroup	1, excep	ot $T_C = -$	55°C and	l V <sub>IC</sub> test	s are on	nitted.											

## TABLE III. <u>Group A inspection for device types 09 and 13</u> – Continued. Terminal conditions (pins not designated may be $H \ge 2.0$ V; or $L \le 0.7$ V; or open).

TABLE III. Group A inspection for device types 09 – Continued. Terminal conditions (pins not designated may be  $H \ge 2.0$  V; or  $L \le 0.7$  V; or open).

r         line         line <th li<="" th=""><th></th><th></th><th></th><th></th><th></th><th></th><th></th><th>Termi</th><th>nal condit</th><th>ions (pins</th><th>not desig</th><th>gnated ma</th><th>y be <math>H \ge 2</math>.</th><th>0 V; or L ≤</th><th>≦0.7 V; or</th><th>open).</th><th></th><th></th><th></th><th></th><th></th><th></th><th></th><th></th></th>	<th></th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th> <th>Termi</th> <th>nal condit</th> <th>ions (pins</th> <th>not desig</th> <th>gnated ma</th> <th>y be <math>H \ge 2</math>.</th> <th>0 V; or L ≤</th> <th>≦0.7 V; or</th> <th>open).</th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th>								Termi	nal condit	ions (pins	not desig	gnated ma	y be $H \ge 2$ .	0 V; or L ≤	≦0.7 V; or	open).								
Nerve         Parton         B         Parton				Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Li	mits		
nethod         nethod<	Subgroup	Symbol	MIL-STD- 883		2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit	
T     Func.     Solid     52     A     K     T     T     A     A     A     A     B     H     H     A     A     A     L     S     T <tht< th=""> <tht< th="">     T     T     &lt;</tht<></tht<>					В	Q <sub>B</sub>	Q <sub>A</sub>			Q <sub>C</sub>	Q <sub>D</sub>	GND	D	с	Load	Max/Min	Ripple Carry	Clock	A	V <sub>cc</sub>	terminal	Min	Max		
Tc + 25°C       i       i       53       i	7	Func-	3014	52	A 6/	н	н			Н	Н	GND	Α	А	В	Н		А	Α	4.5 V				· · · · · ·	
Noise         2         3         8         1 <th1< th="">         1         <th1< th=""> <th1< th=""></th1<></th1<></th1<>	Tc = +25°C	tional		53			"	A	"	"	"		"		В	"		u	"	"				i i	
\$i     55     8     6     1<		tests		54		"	u	"		"	"	"	"		Α	"		"	"	"				i i	
1       56       8       -					В	"	u	"		"	"	"	В	В	"	"		В	В	"				i i	
1       0		-	"	56	В	"		"		"	"	"	"		-	"		А	-	"				i i	
*       69       ·       L       L       ·			**	57	В	"	"	В		"	"	"	"	"	-	"		A		"				i i	
1       100       1 <th1< th=""></th1<>			**	58	A	"	"	"		"	"	"	A	Α	-	"	L	В	Α	"				i i	
*       0.67       ·				59		L	L	"	-	L	L	"	"	-		L	Н	А		"				i i	
·         ·			**	60			L	"	-	"	"	"	"	-		"		В		"				i i	
-       63       B       H       L       -       -       -       -       -       -       -       A       A       -       -       -       A       A       -       -       -       B       A       -       -       -       B       A       -       -       -       B       A       -       -       -       B       A       -       -       -       B       A       -       -       -       B       A       -       -       -       B       A       -       A       A       -       -       -       A       A       -       -       -       A       A       -       -       -       A       A       -       -       -       -       -       -       -       A       A			"	61	"		Н	"	-	"	"		"	-		"		А	В	"				i i	
·         ·			"	62			Н	"	-	"	"		"	-	=	"	-	В	-	"				i i	
·         ·						Н	L	"		"			В	В		"								i i	
-       660       -       -       H       -					A			"		"	"		Α							"				i	
1       000       1								"		"	"		"							"				i	
*       668       *       *       1       *							Н	"	-			"	"	В	-	"				"				l I	
*       69       *       *       H       *       *       *       A       A       *       *       *       A       B       *       *       A       B       *       *       A       B       *       *       A       B       *       *       A       B       *       *       A       B       *       *       A       B       *       *       A       A       *       *       A						L	L	"		Н	"		"			"	"			"				l I	
*       70       *       *       H       *						"		"		"	"					"	"			"				l I	
*       71       *       H       L       *       *       *       *       A       *       *       A       A       *								"		"			A		-	"	-			"				l I	
1       1 <th1< th=""> <th1< th=""> <th1< th=""></th1<></th1<></th1<>							Н	"		"			"							"				i i	
*       73       *       *       H       *							_			"										"				i i	
1       73       1								"		"						"				"				i i	
1       1					"			"		"					-	"				"				i i	
1       76       A       "       L       "																								l I	
77 <td< td=""><td></td><td></td><td></td><td></td><td></td><td>L</td><td></td><td>"</td><td></td><td>L</td><td></td><td>"</td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td>"</td><td></td><td></td><td></td><td>i i</td></td<>						L		"		L		"								"				i i	
1       1						"				"										"				i i	
-       79       B       H       L       *       *       *       A       B       *       *       A																				"	See <u>7</u> /			i i	
1       10       1			ű																	"				i i	
-       -			"			н	_						A											l l	
-       -       -       -       -       -       -       A       -       -       A       -       -       A       -       -       A       -       -       A       -       -       A       -       -       A       -       -       A       -       -       A       -       -       A       -       -       A       -       -       A       -       -       -       A       -       -       A       -       -       -       A       -       -       -       A       -       -       -       A       -																								i i	
"       83       "       L       L       "       "       "       "       B       "       "       A       "       "         "       84       "       "       L       "       "       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       A <td></td> <td></td> <td>"</td> <td></td> <td>-</td> <td></td> <td></td> <td></td> <td></td> <td>i i</td>			"																-					i i	
"       84       "       "       L       "       "       "       B       B       "       "       "       B       "			"																					i i	
-       -						L				H														i i	
"       86       B       "       H       "       "       "       B       B       "       "       "       B       B       "       "       "       B       B       "					~														^					i i	
"       87       A       H       L       "       "       "       A       A       "       "       "       A       A       "       "       A       B       B       B       B       A       A       A       B       B       A       A       B       B       A       A       B       B       A       A       B       B       A       A       B       B       A       A       B       B       B       B       A       B       A       B       B       B       B       A       A       B       B       A       A       B       B       A       A       B       B										"														i -	
""       88       B       "       L       "       "       "       B       B       "       "       "       B       B       "										"														i -	
"       89       A       "       H       "       "       "       A       A       "       H       "       "         "       90       B       "       H       "       "       "       B       B       "       H       "       "         "       90       B       "       H       "       "       "       "       B       B       "       H       L       B       B       "       "       H       L<			"							"	"													i -	
"       90       B       "       H       "       "       "       "       B       B       "       H       L								"								ц								i	
"       91       A       L       L       "       L       L       "       A       A       "       L       H       A       A       "         "       92       B       "       "       A       "       "       B       B       "       H       A       A       "         "       92       B       "       "       A       "       "       B       B       "       H       A       A       "         "       93       A       "       "       A       "       B       B       "       H       A       A       "         "       93       A       "       "       A       "       B       B       "       "       B       B       "       T       B       B       "       T       A       A       T       T       A       T       T       A       T       T       A       T       T       A       T       T       A       T       T       T       A       A       T       T       A       T       T       A       T       T       A       T       T       A								"		"														i i	
"""       92       B       """"       """"       """"       B       B       """"       H       """""       B       """"         ""       93       A       """"       A       """"""       """""       A       """""""""       A       """"""""""""""""""""""""""""""""""""			u					"									_							i i	
""""       93       A       """"       A       """""       A       A       """"""""""""""""""""""""""""""""""""			u					"	Δ	"														i i	
"       94       B       "       "       "       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       B       B       "       "       "       B       "       "       B       "       "       "       B       "       "       A       B       "       "       A       "       "       "       A       "       "       A       "       "       "       "       "       "       A       "       "       "       "       A       "       "       "       A       "       "       "       A       "       "       "       A       A       "       "			"					Δ	"	"	"													i i	
"       95       A       "       "       "       "       "       B       A       "       "       "       A       "       "       "       A       "       "       "       A       "       "       "       A       "       "       "       A       "       "       "       A       "       "       "       A       "       "       "       A       "       "       "       "       A       "       "       "       "       "       "       A       "			"					"		"	"							В						i i	
"         96         B         "         "         "         "         A         B         "         "         A         B         "         "         A         "         "         A         "         "         A         B         "         "         A         "         "         "         A         B         "         "         A         "         "         "         A         B         "         "         A         "         "         "         "         A         B         "         "         A         "         "         "         "         "         A         "								"		"	"													i i	
"97         A         "         "         "         "         "         B         "         L         B         "         "           "98         A         H         H         "         H         H         "         A         "         L         B         "         "								В		"	"													i i	
<u>"98 A H H " " H H " " A " L H A A "</u>			"			"			"	"	"	"	"			"	L		"					i i	
			"			н	н	"	"	н	н	"	"			L	-		Α					i -	
I I I " I 99 I B I " I H I " I " I " I " I B I B I " I " I " I B I B			"	99	В	"	Н	"		"	"		В	В				B	В	"	1	1		1	
			u			"	L	"	"	"	"					"				"	1			i i	
						"	Ē	"	"	"	"	"				"	"			"	1	1		i	

# TABLE III. Group A inspection for device types 09 - Continued.

Terminal conditions (pins not designated may be $H \ge 2.0$ V; or $L \le 0.7$ V; or open).
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<b>.</b>		MIL-STD-	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Li	mits	
Subgroup	Symbol	883 method	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17 Diagla	18	19	20	Measured		Maria	Uni
	_		Test no.	B	Q <sub>B</sub>	Q <sub>A</sub>	Enable G	Down/ up	Q <sub>c</sub>	Q <sub>D</sub>	GND	D	С	Load	Max/Min	Ripple Carry	Clock	A	V <sub>cc</sub>	terminal	Min	Max	
7	Func-	3014	102	A <u>6</u> /	L	н	B <u>6</u> /	A "	H	Н	GND	B	A	A "	L	H	A	В	4.5 V	-			
c = +25°C	tional		103	B		н						A	A				B	В		_			
	tests		104	A								B	B				A	A		-			
	<u>5</u> /	"	105	A	Н							B	B	"			B	A B		-			
		"	106 107	A B	"	H			L		"	A	A B	"			A B		"	_			
		"	107	B							"	B	A	"			A	A	"	-			
		"	108	A	"						"	A	B	"			B	A	"	-			
		**	110	A	L	H					"	B	A	"	"		A	B	"				
		**	110	A	"	Н					"	B	A	"	"		B	B	"				
		"	112	B		L					"	A	В	"			A	A	"	-			
		"	112	B		L					"	B	B	"			B	A	"	-			
		"	114	B	Н	H			Н	L	"	B	B	"			A	B	"	-			
		"	115	A		Н					"	A	A	"			B	A	"	-			
		"	116	В							"	В	В	"			A	B	"	-			
		"	117	A	"	L			"	"	"	A	A	"	"		B	B	"				
		"	118	В	L	Ĥ			"	"	"	В	B	"	"		A	A	"				
		"	119	Ā		H					"	Ā	A	"			В	В	"				
		"	120	A		L		"			"	В	В	"	"		A	A	"				
		"	121	A		Ē					"	B	B	"	"		B	"	"				
		"	122	В	Н	н			L	"	"	В	А	"			А	"	"	-			
		"	123	B	"	H				"	"	A	A	"	"		В	"	"	-			
		"	124	В	"	L					"	В	В	"			А	"	"				
		"	125	Α	"	L				"	"	В	В	"			В	В	"				
		"	126	А	L	н				"	"	Α	В	"	"		А	А	"	-			
		"	127	Α		Н		"			"	Α	А	"	"		В	А	"	See <u>7</u> /			
		"	128	В		L		"			"	В	В	"	Н		А	В	"	_			
		**	129	A	"	L				"	"	Α	A	"	Н	L	В	Α	"				
		"	130	В	Н	Н	"	"	Н	Н	"	В	В	"	L	Н	A	В	"				
		"	131	A	"	-	"	"		"	"	Α	A	В	L	Н	A	Α	"				
		"	132	"		"		В			"		"	"	Н	L	В	"	"				
		"	133								"		"	"		Н	A	"	"				
		**	134			=	Α		-	-	"	-	"	"		-	В	"	"				
		"	135	В	L				L	L	"	В	В	"	L	-	"	В	"				
		"	136	В	L	н	-	-	Η	L	"	В	А	"	"		"	А	"				
		"	137	A	Н	L			L	Н	"	A	В	"			"	В	"				
		"	138	В	L	Н		A	Н	L	"	В	A	"			"	A	"				
		"	139	A	Н	L	В		L	Н	"	A	В	"	"		"	В	"				
		**	140	В	L	Н			Н	L	"	В	A	"		"	"	A	"				
		и	141	A	Н	L			L	Н	"	A	В	"			A	В	"				
		"	142	A							"	A	В	A	"		"	В	"				
		"	143	В	"						"	В	A	"			"	A	"				
		a	144		"			В			"		"				"		"				
			145				A					-	"						"	4			1
			146				B "						"	"					"	4			1
			147					A												4			1
		"	148										"	"			"	B	"	4			1
		"	149	A														A		4			
			150						Н					B			B	B		4			
	1		151			-		-	Н	L				A			В	В					1

See footnotes at end of device types 09 and 13.

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			Cases E, F	1	2	3	4	5	6	7	8	/beH≥2. 9	10	11	12	13	14	15	16		Li	nits	[
Subgroup	Symbol	MIL-STD-	Cases1/	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			Unit
		883 method	2 Test no.	В	Q <sub>B</sub>	Q <sub>A</sub>	Enable G	Down/ up	Qc	QD	GND	D	С	Load	Max/Min	Ripple carry	Clock	A	V <sub>cc</sub>	terminal	Min	Max	
7	Func-	3014	52	В <u>6</u> /	L	Н	A <u>6</u> /	B	L	н	GND	Α	В	В <u>6</u> /	Н	H	В	А	4.5 V				
Tc = +25°C		"	53		"	"	"	"	"	"		"	"	A	"		В	u	"				1
	tests	"	54		"	"	"		-	"		"	"	"	"		А	u	"				l
	5/	"	55	"	"	"	В	"	"	"	"	"	"	"			A	u	"				i i
	_	"	56	"	"	"	"	"	"	"	"	"	"		"	L	В		"				l
		"	57	u		L	ű			L	-	"	"		L	Н	A						l
		**	58	A	"	L		"	-	"		"	A		"	"	В	u	"				1
			59	A	"	Н	"	"	"	"	"	"	"		"	"	A		"				l
		"	60	В	"	Н						"	"				В	В					l
		"	61	В	Н	L						В	В				A	В					l
		"	62	A	"	L						A "	A				В	A					l
			63	B "	"	Н						"	B				A	"		-			l
			64			Н							B				B			-			l
			65		L "	L			H				A				A B	B "		-			l
			66 67	A B	"	L H			"			В	B				A	u	"	-			l
		"	68	A	"	Н			"			"	A				B	u	"	-			l
			69		Н	L			"			"	В				A	u					l
		"	70		"	L		"	"	"		"	B		"		B	"	"				l
		"	71		"	Ĥ		"	"	"		Α	A		"		A	А	"				l
		"	72	В	"	H			"			В	В		"		В	В	"				l
		"	73	A	L	L		"	L	Н		Α	Α		"		А	А	"	1			l
		**	74	A	"	L		"	-	"		A	А		"		В	A	"				l
		**	75	В	"	Н		"	"	"		В	В		Н		A	В	"				l
		"	76	В		Н	"	"	=	"	-	"	"	-	Н	L	В	u		]			l
		"	77	В		L			-	L	-	"	"	-	L	Н	A	u		See <u>7</u> /			l
		"	78	A	"	L			-	"		A	A		"		В	A	"				l
		u	79	В	"	Н	"	"		"		A	В				A	A	"				l
		"	80	A		"	A	A				В	A				В	В					l
		"	81	A		"						B	A				A	B		-			l
		"	82 83	B "	"	"			"			A "	B				B	A		-			l
		"	84			"	В					"	B A				A B	A B		-			l
		**	85	"	"	L	D "		"			"	A		н		A	"	"	-			l
		"	86	"	"	L			"			В	В		Н	L	B	и	"				l
		"	87	А	"	H			"	н		"	"		L	H	A	А					l
		"	88	u		H			"			"	u		L	H	B	"	"				l
		"	89	"	"	L		"	"	"	"	"	"		u	"	Ā		"				l
		"	90	"	"	L	"		"	"		Α	Α		u	"	В	u	"	1			l
		"	91	"	Н	Н	"		Н	L		"	u		"	"	А	u	"				l
		"	92	"	"	Н		"	"	"		"	"				В	В	"				i i
		u	93		"	L	"		"			"	"			"	А		"	]			i
		"	94		"	L			"			В	В				В		"	]			i i
		"	95		L	Н		"	-	"		"	В		"		A	-	"	1			i i
		"	96	В	"	Н	"		"	"		"	A		"		В	A	"	1			i
			97	В	"	L	"	"					"				A	В		1			i
			98	A	"	L		-				A	"				В	В	"	4			i
		"	99		H	Н			L								A	A		4			i
			100			Н		"									B			-			i
			101	-		L											A			1	1		1

TABLE III. Group A inspection for device types 13 – Continued. Terminal conditions (pins not designated may be  $H \ge 2.0 \text{ V}$ ; or  $L \le 0.7 \text{ V}$ ; or open).

	O week of	MIL-STD-	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Management	LI	nits	
ubgroup	Symbol	883 method	Cases <u>1</u> / 2	2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured			U
	_		Test no.	В	Q <sub>B</sub>	Q <sub>A</sub>	Enable G	Down/ up	Q <sub>C</sub>	Q <sub>D</sub>	GND	D	С	Load	Max/Min	Ripple Carry	Clock	A	V <sub>CC</sub>	terminal	Min	Max	
7	Func-	3014	102	В <u>6</u> /	Н	L	B <u>6</u> /	A <u>6</u> /	L	L	GND	В	B <u>6</u> /	A	L	H	В	В	4.5 V				
+25°C	tional		103		L	Н		"	-		"	"		"			A	В					
	tests		104	"	"	Н					"	"	"	"			В	A					
	<u>5</u> /		105	"	"	L			-		"	"		"	Н	-	A	A					
		u	106	A	"	L	A	"	-		"	A	A	"		-	A	В					
		"	107	A	"	"					"	A	A	"			В	"					
		"	108	В	"				-		"	В	В	"		-	A	-					
			109	"	"		В		-		"	"		"		-	A	-					
		"	110	"	"	"					"	"		"		L	В	"					
		"	111	A	"	Н				Н	"	A	A	"	L	Н	A	A					
		"	112	"	"	Н								"			В	В					
		"	113	"	"	L								"			A	Α					
			114	В	"	Н			-				В	В		-	"	=					
			115		"	"			=	-	"			A		=	"	=					
			116	"	"	"		-	-		"	В	"	"		=	"	В	-				
			117	"	"	"	Α				"	"		"			"	"					
		"	118	"	"	"					"		"	"			В		-				
			119	"	"	"	"		-	"	"	"	"	"		-	A		"				
			120	"	"			В	-		"	"		"	Н	-	Α	-					
			121	"	"				-		"	"		"		-	В	-					
			122	"	"	"			-		"			"		-	А	-					
		"	123	Α	"	"	В			"	"	Α	Α	"		"	Α	Α					
		"	124	"	"	"			"					"		L	В	"					
		"	125	"	"	L	"		L	L	"		"	"	L	Н	Α	"					
		"	126	В	"	Н			Н		"	В		В		-	А						
		u	127	"	"	"	"			"				"		-	В	-		See <u>7</u> /			
		u	128	"	"	"					"		"	"		-	A						
		"	129	"	"				"					Α			"	"					
		"	130	А	"				"			А	В	"		"	"	В					
		u	131	A	"							"	"	"			В	"					
		"	132	В	"	L			1	н				В			B	"					
		"	133	"	"	"			-					B			A	"					
		u	134	"	"		А	А						A			A	"					
		u	135	"	"		"	"				В	А	"			B	А					
		"	136	"	"							B	A	"			A	"					
		u	137	"	"	н						A	В	В			"	"					
		u	138	А	Н				н	L		B	A	"			"	В					
		"	139	A	Н	H			Н			"	A	"			"	A					
		u	140	B	L	L		В	L				B	"			"	B					
		и	140	B	"	"	В	"	-				B	A			"	B					
		"	141	A	"		"					A	A	-			"	A					
		"	142		"			۸				- A 		"	Н		"	н "					
		"	143					A "							H		В						
			144	"		Н				Н		В				L							
					"	"		Б						"	L	Н	A	B					
			146					B				B			н	Н	A	B					
			147									A			н	L	B	A "					
			148			L				L					L	Н	A						
	1		149		Н	н			Н	н				В	н	н	A				1	1	1

TABLE III. <u>Group A inspection for device types 13</u> – Continued. Terminal conditions (pins not designated may be  $H \ge 2.0 \text{ V}$ ; or  $L \le 0.7 \text{ V}$ ; or open).

								10	inninai oc		pino not v					0.7 V; 01 0								
		MIL-STD-	Case E,		1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Lir	nits	
Subgroup	Symbol	883 method	Case 2		2	3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured terminal			Unit
			(Devi type	e)	В	Q <sub>B</sub>	Q <sub>A</sub>	Enable G	Down/ up	Q <sub>c</sub>	Q <sub>D</sub>	GND	D	С	Load	Max/Min	Ripple carry	Clock	А	V <sub>CC</sub>		Min	Max	
			09	13				-																
9 Tc = +25°C	F <sub>MAX</sub> <u>8</u> /	3003 <u>9</u> /	152	150			OUT	GND	GND			GND			5.0 V			IN		5.0 V	Ck to Q <sub>A</sub>	18		MHz
	t <sub>PLH10</sub>	"	153	151			OUT					-			IN			GND	5.0 V	"	Load to Q <sub>A</sub>	3	38	ns
		"	154	152	5.0 V	OUT						-			"			"		"	Load to Q <sub>B</sub>	"	"	"
		"	155	153						OUT		-		5.0 V	"			"		"	Load to Q <sub>C</sub>	u	"	"
		"	156	154							OUT	-	5.0 V		"			"		"	Load to Q <sub>D</sub>	"	-	"
	t <sub>PHL13</sub>	"	157	155			OUT								"			"	GND	"	Load to Q <sub>A</sub>	"	55	"
		"	158	156	GND	OUT									"			"		"	Load to Q <sub>B</sub>	и	"	"
		"	159	157						OUT				GND	"			"		"	Load to Q <sub>C</sub>	u	"	"
		"	160	158							OUT		GND		"			"		"	Load to Q <sub>D</sub>	u	"	"
	t <sub>PLH11</sub>	"	161	159			OUT	GND	GND						5.0 V			IN			Ck to Q <sub>A</sub>	"	29	"
		"	162	160		OUT		"	"						"			"			Ck to Q <sub>B</sub>	"	"	"
		"	163	161				"	"	OUT		=			"			"			Ck to Q <sub>C</sub>	-	"	"
		"	164	162				"	"		OUT				"			"			Ck to Q <sub>D</sub>		"	"
	t <sub>PHL14</sub>	"	165	163			OUT	"	"						"			"			Ck to Q <sub>A</sub>		41	"
		"	166	164		OUT		"	u			=			"			"			Ck to Q <sub>B</sub>		"	"
		"	167	165				"	"	OUT		=			"			"		"	Ck to Q <sub>C</sub>		"	"
		u	168	166				"	"		OUT	=			"			u			Ck to Q <sub>D</sub>	"	"	"
[	t <sub>PLH12</sub>	"	169	167				"	"			u			"	OUT		"		"	Ck to Max/Min	"	47	"
	t <sub>PHL15</sub>		170	168				"	"			"			"	OUT		"		"	Ck to Max/Min	"	57	"

## TABLE III. <u>Group A inspection for device types 09 and 13</u>– Continued. Terminal conditions (pins not designated may be $H \ge 2.0 V$ ; or $L \le 0.7 V$ ; or open).

		MIL-STD-	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16		Lir	mits	
Subgroup	Symbol	883 method	Case <u>1</u> / 2		3	4	5	7	8	9	10	12	13	14	15	17	18	19	20	Measured terminal			Unit
			(Device type) 09 13	D	Q <sub>B</sub>	Q <sub>A</sub>	Enable G	Down/ up	Qc	Q <sub>D</sub>	GND	D	С	Load	Max/Min	Ripple carry	Clock	A	V <sub>cc</sub>		Min	Max	
10 Tc = +125°C	F <sub>MAX</sub> <u>8</u> /	3003 <u>9</u> /	171 16	9																Ck to Q <sub>A</sub>	18		MHz
	t <sub>PLH10</sub>	"	172 17																	Load to Q <sub>A</sub>	3	53	ns
			173 17																	Load to Q <sub>B</sub>	"	"	"
			174 17																	Load to Q <sub>C</sub>		"	"
		"	175 17																	Load to Q <sub>D</sub>	"	"	
	t <sub>PHL13</sub>	"	176 17																	Load to Q <sub>A</sub>	"	77	
		"	177 17 178 17																	Load to Q <sub>B</sub>	"	"	
		и	178 17																	Load to Q <sub>C</sub> Load to Q <sub>D</sub>	"	"	"
	t <sub>PLH11</sub>	"	180 17		Same termir	nal conditi	ons as fo	r subgrou	ıp 9.											Ck to Q <sub>A</sub>		41	
	PLH11	"	181 17					0												Ck to Q <sub>B</sub>	"	"	
		"	182 18																	Ck to Q <sub>C</sub>		"	"
		"	183 18																	Ck to Qp	"	"	"
	t <sub>PHL14</sub>	"	184 18	2																Ck to Q <sub>A</sub>		57	
		"	185 18																	Ck to Q <sub>B</sub>	-	"	"
		"	186 18																	Ck to Q <sub>C</sub>	"	"	"
		"	187 18	5																Ck to Q <sub>D</sub>	"	**	"
	t <sub>PLH12</sub>	"	188 18	6																Ck to Max/Min	"	66	
	t <sub>PHL15</sub>		189 18	7																Count up to $Q_B$	"	80	
11	Same te	ests, termii	nal conditi	ons, and li	imits as fo	r subgro	up 10, e	except T	c = -55°	C.													

## TABLE III. <u>Group A inspection for device types 09 and 13</u> – Continued. Terminal conditions (pins not designated may be $H \ge 2.0 V$ ; or $L \le 0.7 V$ ; or open).

- 1/ Case 2, pins not referenced are N/C.
- 2/ Apply 2.0 for device type 09; apply 0.7 V for device type 13.
- <u>3</u>/  $I_{IL}$  limits (µA) min/max values for circuits shown:

Parameter	Terminals	Circuits										
1 arameter	i ominaio	А	В	С	D	E	F	G				
I <sub>IL7</sub>	Enable G	-360/-1080	-160/-400	-360/-1080	-360/-1080	-360/-1080	-360/-1080	-360/-1080				
I <sub>IL8</sub>	A, B, C, D	-130/-400	-160/-400	-160/-400	-160/-400	-120/-360	-120/-360	-120/-360				
	Down/up	"	"	-150/-380	"	"	"	"				
	Clock	"	"	"	"	"	"	"				
	Load	-100/-340	66	"	-100/-340	"	"	"				

- 4/ Ios limits (mA) min/max values for circuits shown: -15/-100 for circuits A, C, D, E, F, and G and -15/-110 for circuit B.
- 5/ Only a summary of attributes data is required.

- $\underline{6}$ / A = 3.0 V minimum; B = 0.0 V or GND.
- $\underline{7}$ / H > 1.5 V; L < 1.5 V; X = don't care.
- 8/ F<sub>MAX</sub> minimum limit specified is the frequency of the input pulse. The output frequency shall be one-half of the input frequency.
- 9/ See figure 10 for device type 09 and figure 12 for device type 13.

		MIL-STD-	Cases A, B, C, D	1	2	3	4	5	6	nated may 7	8	9	10	11	12	13	14		Lir	nits	
Subgroup	Symbol	883 method	Cases <u>1</u> / 2	2	3	4	6	8	9	10	12	13	14	16	18	19	20	Measured terminal			Unit
			Test no.	В	NC	NC	NC	V <sub>cc</sub>	R <sub>0</sub> (1)	R <sub>0</sub> (2)	QD	Q <sub>c</sub>	GND	Q <sub>B</sub>	Q <sub>A</sub>	NC	А		Min	Max	
1	V <sub>OL</sub>	3007	1	GND				4.5 V	2.0 V	2.0 V			GND		4 mA		2.0 V	Q <sub>A</sub>		0.4	V
c = +25°C			2	2.0 V				"	"	"			**	4 mA	+l <sub>IL3</sub> (max)		GND	Q <sub>B</sub>			"
			3	"				и	"	"			"				"	Q <sub>c</sub>			
			4	"				u	"	"	4 mA		"				"	Q <sub>D</sub>		=	
	V <sub>OH</sub>	3006	5	GND				u	<u>2</u> /	<u>2</u> /			u		-0.4 mA		<u>2/3/</u>	Q <sub>A</sub>	2.5		
			6	<u>2/3/</u>				u	"	"			"	-0.4 mA			GND	Q <sub>B</sub>	"		"
		ű	7	<u>2/ 4/</u>				ű	"	"		-0.4 mA	"				"	Q <sub>C</sub>	"		
		"	8	<u>2/5/</u>				"	"	"	-0.4 mA		"				"	QD	"		"
	VIC		9	40.4				"					"				-18 mA	A		-1.5	
			10 11	-18 mA					-18 mA				"					B		"	
			11 12						-18 MA	-18 mA			"					R <sub>0</sub> (1) R <sub>0</sub> (2)		"	"
	I <sub>IL1</sub>	3009	12					5.5 V	0.4 V	5.5 V			"					$R_0(2)$ R <sub>0</sub> (1)	6/	6/	mA
	'IL1	"	13					" "	5.5 V	0.4 V			"					R <sub>0</sub> (2)		5	"
	I <sub>IL2</sub>	"	15					"	<u>2</u> /	<u>2</u> /			"				0.4 V	А	"	"	"
	I <sub>IL3</sub>	"	16	0.4 V				"	"	"			"					В	"	"	
	I <sub>IH1</sub>	3010	17					и	2.7 V	GND			"					R <sub>0</sub> (1)		20	μA
	I <sub>IH1</sub>	"	18			1		"	GND	2.7 V			"					R <sub>0</sub> (2)		20	"
	I <sub>IH2</sub>	"	19					и	5.5 V	GND			"					R <sub>0</sub> (1)		100	"
	I <sub>IH2</sub>	"	20					"	GND	5.5 V			"					R <sub>0</sub> (2)		100	"
	I <sub>IH3</sub>	"	21					"	5.5 V	5.5 V			"				2.7 V	А		80	"
	I <sub>IH4</sub>	"	22					"	"	"			"				5.5 V	А		400	"
	I <sub>IH5</sub>	"	23	2.7 V				"	"	"			"					В	<u>13</u> /	80	"
	I <sub>IH6</sub>	"	24	5.5 V				"	"	"			"					В		400	"
	I <sub>os</sub>	3011	25	GND				u	2/	2/			"		GND		2/3/	Q <sub>A</sub>	7/	7/	mA
	00	"	26	2/3/				и	"	"			"	GND			GND	Q <sub>B</sub>	"	"	"
		"	27	<u>2/4/</u>				u	"	"		GND	"				"	Q <sub>C</sub>	"	"	"
		"	28	<u>2/5/</u>				u	"	"	GND		"				"	QD	"	"	"
	I <sub>CC</sub>	3005	29	GND				"					"					V <sub>cc</sub>		15	"
2	Same te	sts, termina	al conditions	, and limit	s as for s	subgroup	1, exce	pt T <sub>C</sub> = +	125°C a	nd V <sub>IC</sub> te	ests are o	omitted.									
3	-		al conditions																		

#### TABLE III. Group A inspection for device types 10. Torminal

See footnotes at end of device type 10.

		MIL-STD-	Cases E A, B, C, D	1	2	3	4	5	6	7	8	9	10	11	12	13	14		Li	mits	
Subgroup	Symbol	883	Cases1/	2	3	4	6	8	9	10	12	13	14	16	18	19	20	Measured			Unit
		method	2																		
			Test no.	В	NC	NC	NC	V <sub>cc</sub>	R <sub>0</sub> (1)	R <sub>0</sub> (2)	Q <sub>D</sub>	Q <sub>c</sub>	GND	Q <sub>B</sub>	Q <sub>A</sub>	NC	А	terminal	Min	Max	
7	Func-	3014	30	B <u>9</u> /				4.5 V	A <u>9</u> /	A <u>9</u> /	L	L	GND	L	L		В <u>9</u> /				
Tc = +25°C	Tional		31	A				"			"	"		"	"						
	tests		32	В							"	"	"	"	"		"				
	<u>8</u> /		33	В					В		"	"	"	"	"						
	-	"	34	А					-		"	ű	"	"	"		"				
		"	35	В							"	u	"	Н	"						
		"	36	В					Α		"	u	"	L	"						
			37	В					-	Х		"	"	"	"		"				
		"	38	А					-	В		"	"	"	"		"				
		66	39	В					-	"		u	"	н	u		"				
		66	40	A					-			"	"	н	"		"				
	1	"	41	В					=	"	"	Н	"	L	"			]			1
			42	А							"	Н	u	"			"	]			i
			43	В						"	Н	L	"	и	"			]			i
			44	А							"	"	"	"	"		"	]			i
	1		45	В								"	"	Н				]			1
			46	A					=	-		"	"	Н			-				
			47	В					=			Н	"	L			"				
			48	В				"	-	А	L	L		"	u						
			49	В				-	В		-	"		"							
			50	A								"		"							
		"	51	В							"	u	"	Н	"						
		"	52	A								"		Н							
		"	53	В					"	"	"	Н	"	L "	u						
		"	54	A								Н		"							
		"	55	B							Н	L						See <u>10</u> /			
		"	56	A														-			
		"	57 58	B								"	"	H H				-			
		"	58	AB								Н						-			
		"	59 60	A					"	u		Н		L "				-			
		"	61	B										"				-			
		66	62	D "				"			L "	L "		"			A	-			
		"	63	"							"	u	и	"	н		B	1			
	1	"	64	"							"	u	и	"	Н	<u> </u>	A	1			1
		"	65	"							"	u	"	"	L	1	B	1			
	1				·	·							1	1							
8	Same te	sts, termina	al conditions	, and limit	s as for s	ubgroup	7, excep	ot $T_C = +$	125°C a	nd -55°0	Э.										
9	F <sub>MAX</sub>	3003	66					5.0 V	GND				GND		OUT		IN <u>12</u> /	A to Q <sub>A</sub>	29		MHz
Tc = +25°C	1																				i
	t <sub>PLH1</sub>	(Fig 11)	67					"	<u>11</u> /	A <u>9</u> /		OUT	"				IN	A to Q <sub>C</sub>	3	53	ns
	t <sub>PHL1</sub>	"	68						GND			OUT	и				IN	A to Q <sub>C</sub>	u	58	"
	t <sub>PLH2</sub>	"	69	IN					<u>11/</u>	A <u>9</u> /	OUT		u					B to Q <sub>D</sub>	ű	37	"
	t <sub>PHL2</sub>	"	70	IN				"	GND		OUT		"					B to Q <sub>D</sub>	ű	50	"
10 Tc = +125°C	F <sub>MAX</sub>	"	71						GND						OUT		IN <u>12</u> /	A to Q <sub>A</sub>	29		MHz
	t <sub>PLH1</sub>	"	72						<u>11</u> /	A <u>9</u> /		OUT	"				IN	A to Q <sub>C</sub>	3	74	ns
	t <sub>PHL1</sub>	"	73					"	GND			OUT	"				IN	A to Q <sub>C</sub>	"	81	"
	t <sub>PLH2</sub>	"	74	IN					<u>11/</u>	A <u>9</u> /	OUT							B to Q <sub>D</sub>	u	52	u
	t <sub>PHL2</sub>	"	75	IN					GND		OUT		"					B to Q <sub>D</sub>	ű	56	"
11	Same te	sts, termina	al conditions	, and limit	s as for s	ubgroup	10, exce	ept T <sub>C</sub> =	-55°C.												

# TABLE III. <u>Group A inspection for device type 10</u>– Continued. Terminal conditions (pins not designated may be high $\ge 2.0$ V; or low $\le 0.7$ V; or open).

See footnotes at end of device type 10.

- 1/ Case 2, pins not referenced are N/C.
- <u>2</u>/ Apply 4.5 volts pulse, then ground prior to taking measurements to set device in the desired state. Maintain ground for measurement.
- $\underline{3}$  Input pulse must be applied one time after R<sub>0</sub> pulse.
- $\underline{4}$  Input pulse must be applied twice after R<sub>o</sub> pulse.
- $\underline{5}$ / Input pulse must be applied four times after R<sub>0</sub> pulse.
- 6/ IIL limits (mA) min/max values for circuits shown:

Parameter	Terminals	Circuits									
		А	В	С	D	E	F	G			
I <sub>IL1</sub>	R <sub>o</sub> (1) R <sub>o</sub> (2)	12/36 "	03/40	03/40	03/40		12/36 "				
I <sub>IL2</sub>	А	-0.5/-2.0	-1.0/-2.4	-1.0/-2.4	-1.0/-2.4		-0.5/-2.0				
I <sub>IL3</sub>	В	-0.7/-3.2	-0.7/-3.2	-0.7/-3.2	-0.4/-1.6		-0.7/-3.2				

# <u>Z</u>/ I<sub>os</sub> limits (mA) min/max values for circuits shown:

	Measured	Circuits									
Parameter	terminals	А	В	С	D	E	F	G			
l <sub>os</sub>	$egin{array}{c} Q_A, \ Q_B, \ Q_C, \ Q_D \end{array}$	-15/-100	-15/-100	-30/-130	-15/-100		-15/-100				

## 8/ Only a summary of attributes data is required.

<u>9</u>/ A = 3.0 V minimum; B = 0.0 V or GND.

<u>10</u>/ H > 1.5 V; L < 1.5 V; X = don't care.

11/ Momentary 3.0 V (min), then ground. Maintain ground for measurement.

12/ F<sub>MAX</sub> min limit specified is the frequency of the input pulse. The output frequency shall be one-half of the input frequency.

<u>13</u>/ The minimum limit for circuit F shall be  $-150 \ \mu$ A.

# MIL-M-38510/315D

# 5. PACKAGING

5.1 <u>Packaging requirements</u>. For acquisition purposes, the packaging requirements shall be as specified in the contract or order (see 6.2). When actual packaging of materiel is to be performed by DoD or in-house contractor personnel, these personnel need to contact the responsible packaging activity to ascertain packaging requirements. Packaging requirements are maintained by the Inventory Control Point's packaging activity within the Military Service or Defense Agency, or within the military service's system command. Packaging data retrieval is available from the managing Military Department's or Defense Agency's automated packaging files, CD-ROM products, or by contacting the responsible packaging activity.

# 6. NOTES

(This section contains information of a general or explanatory nature which may be helpful, but is not mandatory.)

6.1 <u>Intended use.</u> Microcircuits conforming to this specification are intended for original equipment design applications and logistic support of existing equipment.

- 6.2 <u>Acquisition requirements.</u> Acquisition documents should specify the following:
  - a. Title, number, and date of the specification.
  - b. PIN and compliance identifier, if applicable (see 1.2).
  - c. Requirements for delivery of one copy of the conformance inspection data pertinent to the device inspection lot to be supplied with each shipment by the device manufacturer, if applicable.
  - d. Requirements for certificate of compliance, if applicable.
  - e. Requirements for notification of change of product or process to contracting activity in addition to notification to the qualifying activity, if applicable.
  - f. Requirements for failure analysis (including required test condition of method 5003 of MIL-STD-883), corrective action, and reporting of results, if applicable.
  - g. Requirements for product assurance options.
  - Requirements for special carriers, lead lengths, or lead forming, if applicable. These requirements shall not affect the part number. Unless otherwise specified, these requirements will not apply to direct purchase by or direct shipment to the Government.
  - I Requirements for "JAN" marking.
  - j. Packaging Requirements (see 5.1)

6.3 <u>Superseding information</u>. The requirements of MIL-M-38510 have been superseded to take advantage of the available Qualified Manufacturer Listing (QML) system provided by MIL-PRF-38535. Previous references to MIL-M-38510 in this document have been replaced by appropriate references to MIL-PRF-38535. All technical requirements now consist of this specification and MIL-PRF-38535. The MIL-M-38510 specification sheet number and PIN have been retained to avoid adversely impacting existing government logistics systems and contractor's parts lists.

6.4 <u>Qualification</u>. With respect to products requiring qualification, awards will be made only for products which are, at the time of award of contract, qualified for inclusion in Qualified Manufacturers List QML-38535 whether or not such products have actually been so listed by that date. The attention of the contractors is called to these requirements, and manufacturers are urged to arrange to have the products that they propose to offer to the Federal Government tested for qualification in order that they may be eligible to be awarded contracts or purchase orders for the products covered by this specification. Information pertaining to qualification of products may be obtained from DSCC-VQ, 3990 E. Broad Street, Columbus, Ohio 43123-1199.

# MIL-M-38510/315D

6.5 <u>Abbreviations, symbols, and definitions.</u> The abbreviations, symbols, and definitions used herein are defined in MIL-PRF-38535, MIL-HDBK-1331, and as follows:

GND	Ground zero voltage potential
I <sub>IN</sub>	Current flowing into an input terminal
V <sub>IC</sub>	Input clamp voltage
V <sub>IN</sub>	Voltage level at an input terminal

6.6 <u>Logistic support</u>. Lead materials and finishes (see 3.4) are interchangeable. Unless otherwise specified, microcircuits acquired for Government logistic support will be acquired to device class B (see 1.2.2), lead material and finish A (see 3.4). Longer length leads and lead forming should not affect the part number.

6.7 <u>Substitutability.</u> The cross-reference information below is presented for the convenience of users. Microcircuits covered by this specification will functionally replace the listed generic-industry type. Generic-industry microcircuit types may not have equivalent operational performance characteristics across military temperature ranges or reliability factors equivalent to MIL-M-38510 device types and may have slight physical variations in relation to case size. The presence of this information should not be deemed as permitting substitution of generic-industry types for MIL-M-38510 types or as a waiver of any of the provisions of MIL-PRF-38535.

Military device	Generic-industry
type	type
01	54LS90
02	54LS93
03	54LS160
04	54LS161
05	54LS168
06	54LS169
07	54LS192
08	54LS193
09	54LS191
10	54LS92
11	54LS162
12	54LS163
13	54LS190

# MIL-M-38510/315D

6.8 <u>Manufacturers' designation</u>. Manufacturers' circuits which form a part of this specification are designated with an "X" as shown in table IV herein.

Device	Circuit	A	В	G	С	E	F	D
type	Manufacturer	Texas Instruments,	Signetics Corp.	National Semi-	Raytheon Company	Fairchild Semi-	Motorola, Inc.	Advanced Micro
	Commercial Type	Incorporated		Conductor Corp.		conductor		Devices Inc.
01	54LS90	Х	х		Х	Х	Х	
02	54LS93	Х	Х	Х	Х	Х	Х	
03	54LS160A	Х	Х	Х	Х	Х	Х	Х
04	54LS161A	Х	Х	Х	Х	Х	Х	Х
05	54LS168			Х		Х		
06	54LS169A			Х		Х		
07	54LS192	Х	Х	Х	Х	Х	Х	Х
08	54LS193	Х	Х	Х	Х	Х	Х	Х
09	54LS191	Х	Х	Х	Х	Х	Х	Х
10	54LS92	Х		Х	Х		Х	
11	54LS162A	Х	Х	Х	Х	Х	Х	Х
12	54LS163A	Х	Х	Х	Х	Х	Х	Х
13	54LS190	Х	Х	Х	Х	Х	Х	Х

# TABLE IV. Manufacturers' designation.

6.9 <u>Change from previous issue.</u> Asterisks are not used in this revision to identify changes with respect to the previous issue, due to the extensiveness of the changes.

Custodians: Army - CR Navy - EC Air Force - 11 DLA - CC

Review activities: Army – SM, MI Navy - AS, CG, MC, SH TD Air Force – 03, 19, 99 Preparing activity: DLA - CC

(Project 5962-1996)